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X-ray excited optical luminescence of polynuclear aromatic hydrocarbons

by

Gregory Joseph Oestreich

A Dissertation Submitted to the
Graduate Faculty in Partial Fulfillment of
The Requirements for the Degree of
DOCTOR OF PHILOSOPHY

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CHAPTER 1: INTRODUCTION

The search for cancer-causing agents began in 1775 when physicians observed an abnormally high occurrence of cancer of the scrotum in chimney sweeps. Today, the carcinogenic and mutagenic properties of polynuclear aromatic hydrocarbons (PAHs), a major component of soot, are well known (1,2). All humans are exposed to many natural and man made sources of PAHs. These compounds are produced in hydrocarbon-fueled combustion processes, both natural (e.g. forest fires (3)) and controlled (e.g. internal combustion engines, (4) fuel-rich flames (5)). In addition to the many existing sources of PAHs, the dwindling supply of petroleum threatens to add another source of PAHs, as coal becomes an energy substitute. PAHs occur in coal tar pitch (6,7), in the environment surrounding coke production (8), in coal conversion processes (9), in coal liquification products (10-12), and even in coal (13).

Once formed, the PAHs can enter the atmosphere and the food chain. The modern coal-burning power plant is one example of a particularly dangerous source of atmospheric PAHs. The PAHs formed in the combustion process enter the atmosphere as gases and subsequently condense on the particulate matter formed in the boiler (14) and finally escape into the environment by being immobilized on the very fine particulate matter not removed by precipitators. In this

form the PAHs are inhaled deeply into the lungs and become imbedded in tissue. The localized concentrations of PAHs in the lung tissues represents a serious health hazard. PAHs also enter the body during the consumption of nourishment and water. Fresh water supplies contain PAHs in the range from 1 part per trillion in ground water to 100 parts per trillion and higher in industrially-polluted surface water (15,16). Certain foods contain large quantities of PAHs. Smoked and charcoal broiled foods have been shown to be dietary sources of PAHs. In one study the content of PAHs ranged from 0 to 141 part per billion in smoked foods and from 0 to 164 part per billion in charcoal broiled foods (17). In a more general study PAHs were found at trace levels in meat, fish, poultry, root vegetables, beverages, dairy products, oils, fats and shortenings (18). The occurrence of PAHs in the diet is an important source of human exposure to carcinogenic substances.

The many different sources and the varied composition of PAH-contaminated materials presents the analytical chemist with a serious problem. Sensitive and selective analytical methods for the characterization of PAHs are required. For these reasons and because of the potentially hazardous exposure of humans to PAHs in industrial (19) and natural environments, there is increasing interest in new analytical concepts for the qualitative and quantitative determination

of these compounds at trace and ultratrace levels (20).

PAHs occur in natural and man-made substances at trace and ultratrace levels in complex matrices (21-24,18). Therefore, sensitive and selective analytical techniques are required to characterize PAH mixtures. Because PAHs are highly luminescent materials (25,26), fluorimetric and phosphorimetric methods are favored for PAH characterization. Unfortunately, broad-band emission of most PAH systems prevents the simultaneous determination of several PAHs and limits the selectivity of luminescent methods.

To improve the selectivity of the luminescent methods for PAH systems, solid state techniques are often used. Two approaches for sharpening the luminescent emission are line-narrowing fluorescence spectroscopy (27,28) and mixed-crystal spectroscopy (29,30,31). Line-narrowing fluorescence spectroscopy employs a laser to excite only those PAH molecules in a particular environment within a low temperature matrix (e.g. glass, crystal or Shpol'skii). Molecules with vibrational levels in the first singlet electronic state which coincide with the laser frequency are excited. After vibrational deactivation these molecules are in equal energy excited states and fluoresce in a narrow frequency range. This technique has been demonstrated with an argon ion laser for anthracene and pyrene (32). Greatly improved selectivity should be possible with a tunable dye

laser in place of the argon ion laser. The second approach requires choice of a solvent or matrix in which the PAHs can reside in a few particular orientations. If PAHs are dissolved in n-alkanes (pentane to nonane) and the resulting solutions are cooled to a temperature in the range of 4 K to 77 K, narrow-lined emission is observed under UV excitation. The impurity PAH molecules in the n-alkane host are held in substitutional sites and lattice broadening of their emission is not observed. These quasilinear spectra are a manifestation of the Shpol'skii effect (33-35). A review of the Shpol'skii effect (36) summarizes the systems which display this behavior. The variety of systems listed suggests the phenomena is quite common. The application of the Shpol'skii effect, excited by UV radiation, to the determination of 3,4-benzopyrene, a potent carcinogen, is well-documented (37-40).

The major drawbacks to luminescence analysis using the Shpol'skii effect are instrumental limitations (41). Scattered radiation from the excitation source is a particularly serious limitation since internal reflection occurs within the n-alkane snows formed upon freezing. The technique known as X-ray Excited Optical Luminescence (XEOL), which employs x-ray excitation, eliminates the problem of crosstalk between emission from the excitation source and luminescenct emission from the sample. The conventional

sources (e.g. lasers, mercury lamps, xenon arcs etc.) (42) are replaced by an x-ray tube. XEOL is a sensitive analytical technique capable of detecting impurities at the fractional part per billion level in appropriate solid or gaseous environments (43,44). In an earlier publication (45) we reported the first observation of the Shpol'skii effect from PAHs in n-alkanes under x-ray excitation. The observation of quasilinear fluorescence and phosphorescence of PAHs under x-ray excitation suggested the combination of XEOL and the Shpol'skii effect might be a viable approach to the simultaneous multicomponent determination of complex PAH mixtures.

Another advantage gained by combining the Shpol'skii effect and XEOL is nonspecific excitation of the sample. The coincidence of the absorption band of the PAH molecule and the emission frequency of the excitation source is not a requirement because resonance processes are not responsible for direct excitation of the PAH molecules. Instead, highly selective energy transfer processes are responsible for the sensitized luminescence which is observed from trace PAHs contained in n-alkane microcrystals (45). The observation of sensitized luminescence indicates XEOL should be a sensitive method for the determination of PAHs in Shpol'skii matrices.

To visualize the processes which occur in the proposed excitation mechanism, an energy level diagram of the

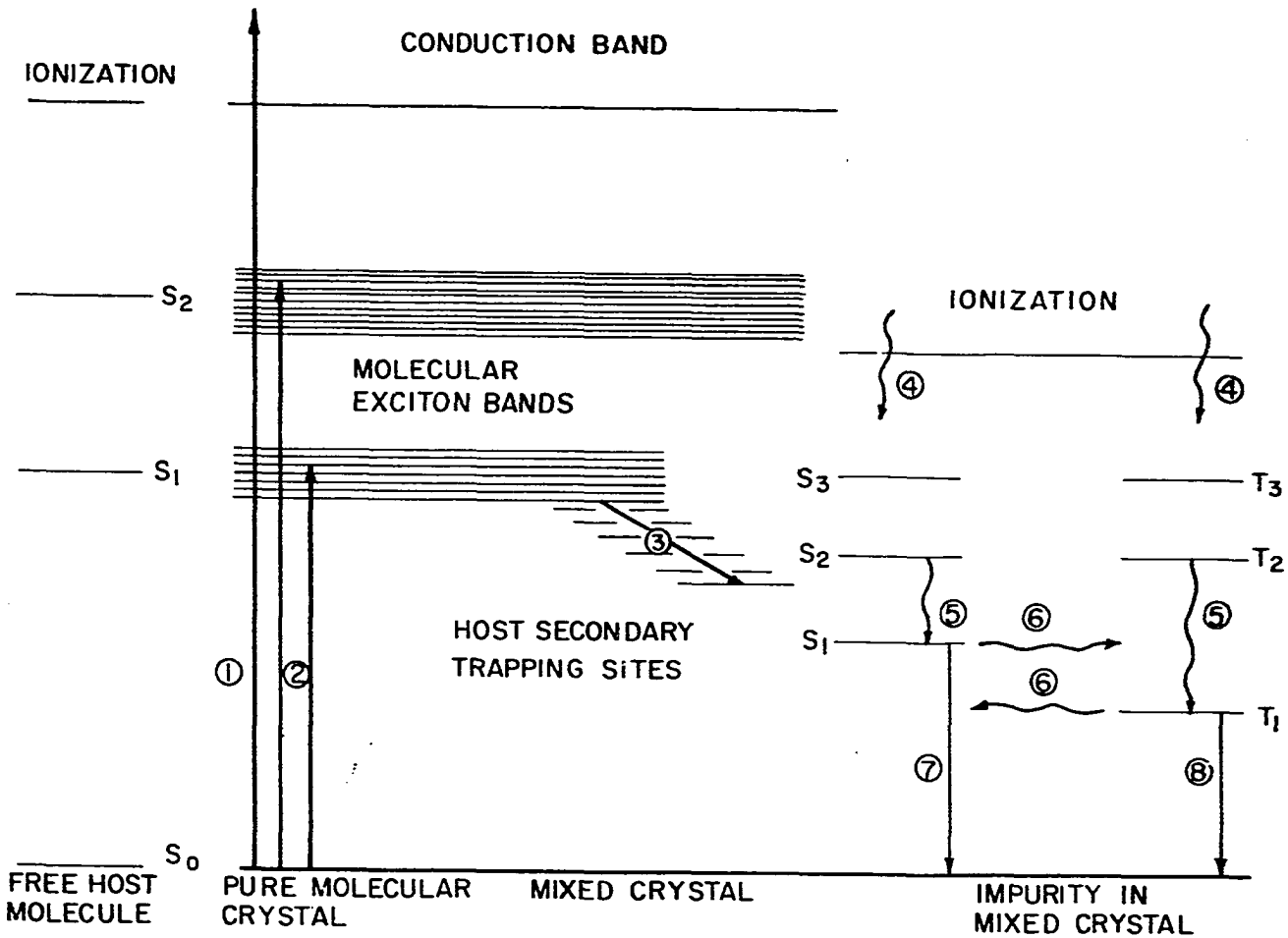

Figure 1. Energy level diagram for a n-alkane-PAH system at 10 K. The numbered transitions are; 1. Formation of the primary photoelectron, 2. Collisional population of molecular exciton bands, 3. Exciton trapped by perturbed host molecule, 4. Recombination, 5. Internal conversion followed by vibrational deactivation, 6. Intersystem crossing, 7. Fluorescence and 8. Phosphorescence.

n-alkane-PAH system at 10 K is presented in Figure 1. An explanation of the excitation mechanism begins with the energy levels of the free host molecule on the left side of Figure 1. The ground state, first two excited singlet electronic states, and the ionization limit are shown. To simplify the diagram, the vibrational levels were not drawn. In the solid state, the ground state and the ionization limit of the free host molecule are analogous to the valence and conduction bands of an ionic crystal. The singlet electronic states of the free host molecule broaden into molecular exciton bands which are characteristic of a molecular assembly of many host molecules. These molecular exciton bands are the transmission lines of the excitation energy. The perturbation exerted by an impurity molecule on neighboring host molecules results in the formation of host secondary trapping sites, shown in the mixed crystal region of the diagram. These perturbed host molecules are important in the selective capture of excitons by the impurity molecules. Finally, on the right side of Figure 1 the energy levels of a typical PAH are depicted as discrete states. The use of a Shpol'skii solvent traps the PAHs in identical environments in the crystal lattice and prevents broadening of the singlet and triplet excited electronic states. The observed optical signal is a composite of fluorescence and phosphorescence transitions of PAH molecules trapped in the

lattice.

The first step in the excitation mechanism is the interaction of x-ray photons with the sample or the sample holder. X-ray photons interact with matter in three ways; 1. Photoelectric effect, 2. Compton effect and 3. Pair production (46,47). At the energies used in XEOL experiments (typically 60 kV.) only the photoelectric effect occurs. Atoms of the solvent or sample holder may absorb an x-ray photon and eject a primary photoelectron with energy in excess of several keV. (process No. 1 in Figure 1). The excited atoms relax by the emission of characteristic fluorescence x-rays or the ejection of Auger electrons. The primary photoelectron, fluorescent x-rays and the Auger electrons collisionally excite neighboring atoms in a cascade process.

The collisional excitation of electrons and atoms of host molecules populates the molecular exciton bands (process No. 2 in Figure 1). The exciton wave migrates through the molecular assembly and the excitation is delocalized (31). As the exciton propagates through the microcrystal it may enter a region in which an impurity molecule is trapped in the lattice. If the exciton migrates to a perturbed host molecule a phonon is produced and the exciton no longer possesses enough energy to migrate freely in the microcrystal. The exciton continues toward the impurity with the production of

additional phonons (process No. 3 in Figure 1) until the impurity traps the exciton and is excited electronically or ionized. The inability of the exciton to return to the bulk of the crystal after the production of phonons near the impurity sites results in the funneling of excitation energy to the impurity. Recombination, internal conversion and intersystem crossing with vibrational deactivation (processes No. 4, 5 and 6 in Figure 1) occur in the impurity. Fluorescence (process No. 7 in Figure 1) and phosphorescence (process No. 8 in Figure 1) return the PAH molecule to the ground state. Thus, the highly selective energy transfer processes produce the optical signal.

The sharp line spectra resulting from the Shpol'skii effect make spectral resolution of several PAHs possible and endow the XEOL technique with some selectivity. However, no monochromator is capable of resolving all lines. Even with the Shpol'skii effect, overlap occurs in the fluorescent and phosphorescent emission of PAHs. Time resolved spectroscopy (TRS) coupled with XEOL would further improve the selectivity of the method. The technique of time resolved spectroscopy (48-50) allows separation of overlapping luminescence of PAHs on the basis of their luminescent decay constants. Since PAHs possess a large range of fluorescent and phosphorescent decay constants (26), it should be possible to time resolve fluorescent components and phosphorescent components. A

pulsed excitation source is required to perform the time resolution experiment. Before coupling XEOL and TRS a pulsed x-ray source has to be constructed.

This dissertation describes the development of XEOL-TRS as a method for the analysis of PAHs. The modification of a medical x-ray unit for use as a pulsed x-ray source under computer control is discussed. The ability to time resolve phosphorescent mixtures but not fluorescent mixtures because of x-ray pulse characteristics is reported. Finally, analytical data is presented on the analysis of synthetic PAH mixtures and other systems that might be amenable to study by the XEOL-TRS technique are suggested.

CHAPTER 2: FACILITIES

Experimental Facilities

The experimental facilities, used as basic components in a simple XEOL system, are described in an early publication (51). The basic components plus the additional components of the pulsed XEOL system used in the present study are summarized in Table 1.

In Figures 2 and 3 the essential hardware portions of the pulsed XEOL system are numbered for easy identification. The brass sample chamber, used to shield the operator from scattered x-rays, was redesigned for this system. All seams in the brass structure were fitted with right angle slots to eliminate streaming of scattered x-rays through conventional seams. A reproducible mount for the cryogenic vacuum shield was fitted on top of the chamber. A table, to which the chamber was securely fastened, was added to support a ball bushing and bearing assembly for easy insertion and extraction of the cryogenic system into and out of the vacuum shield. Figure 2 shows the cryogenic system removed from the vacuum shield. The table has three-dimensional adjustments to simplify optical alignment of the system. Optical alignment was performed using a continuous wave He-Ne laser with emission at 632.8 nm. (C. W. Radiation Inc. Mountain View, CA). The sides of the brass box are easily removed and

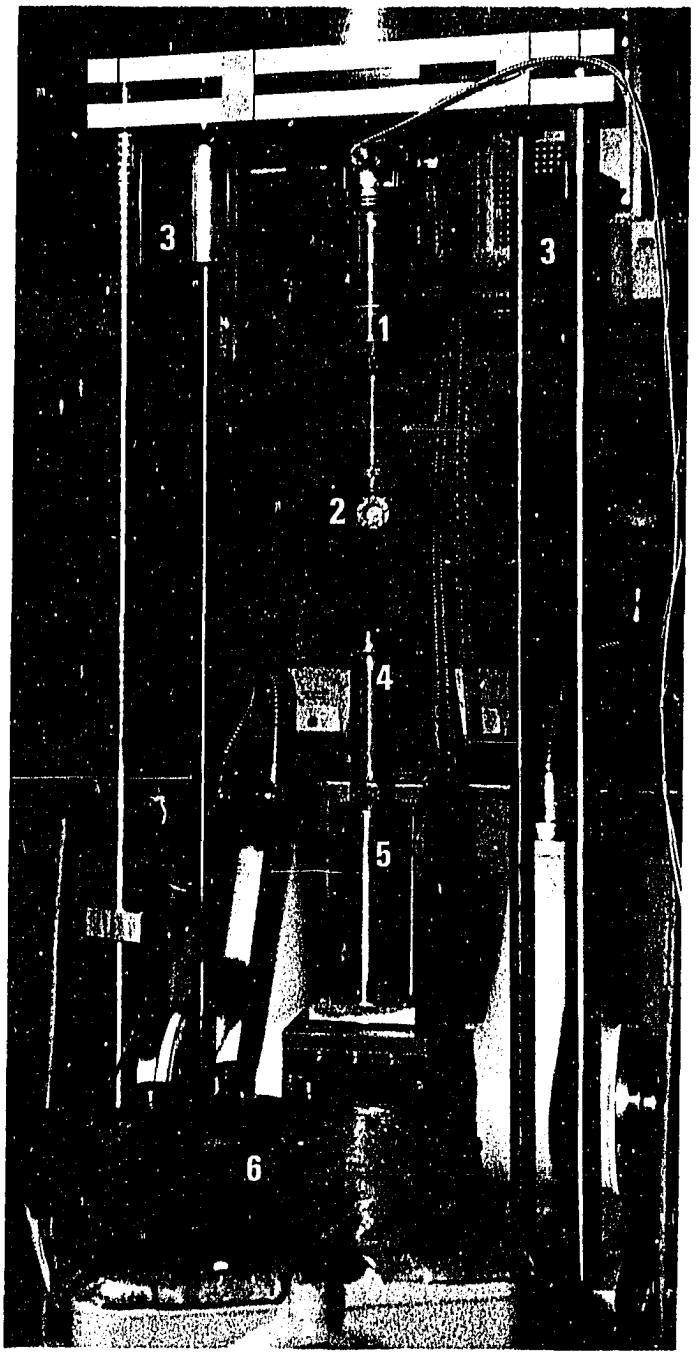

Figure 2. Photograph of the pulsed XEOL system with the cryostat removed from the vacuum shield. The numbered components are: 1. cryostat (cold end), 2. sample holder, 3. ball bushing and bearing assembly, 4. radiation shield, 5. vacuum shield and 6. monochromator.

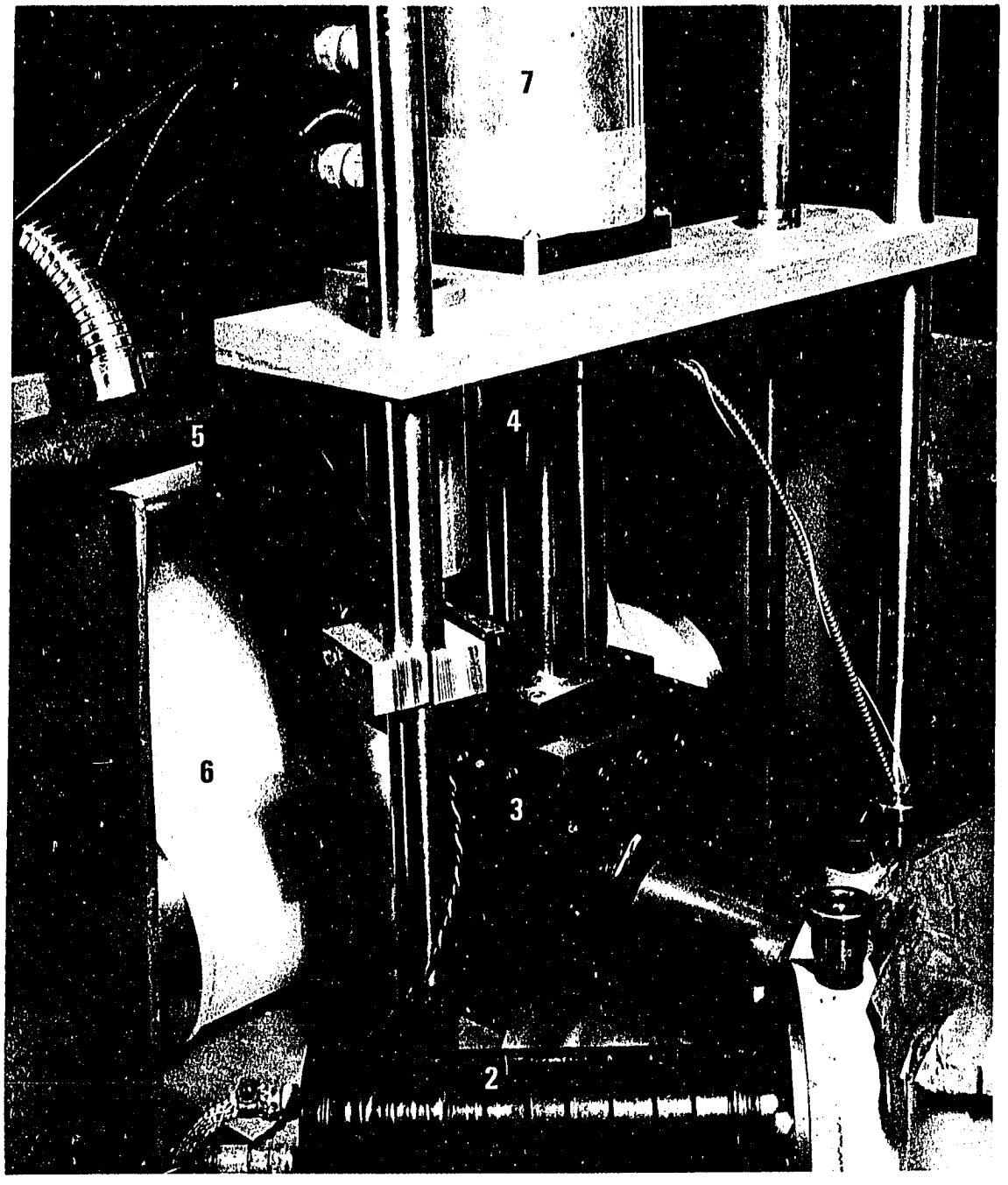

Figure 3. Photograph of the pulsed XEOI system with the cryostat inserted into the vacuum shield. The numbered components are: 1. monochromator, 2. photomultiplier tube in housing, 3. brass sample chamber, 4. vacuum shield, 5. vacuum line, 6. x-ray tube and 7. cryostat (mechanical end).

Table 1. Principal Components of Pulsed XEOL System

X-ray Sources	
DC x-ray power supply	Operated at 50 kV. and 40 mA. Water cooled Maximum 60 kV. 60 mA. (General Electric Corp., Milwaukee, WI Model XRD-6)
DC x-ray tube	Tungsten target Water cooled anode Emission of x-rays from 0.1 nm. to 0.02 nm. (General Electric Corp., Milwaukee, WI Model EA-75X)
Pulsed x-ray power supply	Medical x-ray unit Thyratron pulse circuits modified for computer control (Westinghouse Electric Corp., Greenville, PA)
Pulsed x-ray tube	Medical x-ray tube Operated at 60 kV. 100 mA. using large filament Rotating anode Conduction cooled (The Machlett Laboratories Inc., Stamford, CT)
Spectroscopic Equipment	
Monochromator	Scanning 0.3 meter Crossed Czerny Turner mount (McPherson Instrument Corp., Acton, MA, Model No. 218)
Detector	EMI 6256B photomultiplier S-13 response (EMI Gencom Inc., Plainview, NY)
High voltage power supply	Operated at 1200 VDC (NJE Corp., Kenilworth, NJ, Model S-325)

Table 1. (Continued)

External optics	Precision grade quartz lens 1 inch diameter 2 inch focal length (Corion Instrument Corp., Waltham, MA)
Amplifier	Fast current amplifier with adjustable rise time and zero suppression (Keithley Instruments, Cleveland, OH, Model 427)
Recorder	Two pen voltage recorder (Houston Instruments, Austin, TX, Model 5210-5)
Refrigeration and Vacuum Equipment	
Helium refrigerator	Helium refrigerant Temperature selectable from 10 K to 360 K with 1 degree resolution (Air Products and Chemicals Inc., Allentown, PA, Model CSA-202)
Diffusion pump	2 inch air cooled (NRC Equipment Co., Newton, MA)
Floor pump	(The Welch Scientific Co., Skokie, IL, Model 1397)
Vacuum gauge	(National Research Corp., Cambridge, MA)
Computer and Interfaces	
Computer	PDP8/E minicomputer (Digital Equipment Corp., Maynard, MA)
Control interface	See text
Data interface	(Heath Co., Benton Harbor, MI)

Table 1. (Continued)

Buffer	(Heath Co., Benton Harbor, MI)
Analog to Digital Converter	(Redcor Corp., Woodland Hills CA)
Teletype	(Teletype Corp., Skokie, IL, Model-33)

replaced to accommodate either a DC or pulsed x-ray tube. The x-ray tubes are positioned to minimize the distance from the anode to the vacuum, because air can severely attenuate the x-ray beam. Figure 3 shows the brass chamber with the pulsed x-ray tube attached and the refrigerator inserted.

The control interface was designed by G. Holland of Ames Laboratory Instrumentation Group and built by technicians in the same group. A simplified circuit diagram of the interface is presented in Figure 4. The interface instructions which control the operation of the x-ray source are indicated on the diagram. The flip flops are equivalent to toggle switches. The AND gates test two computer conditions before allowing pulses to reach the x-ray supply. A second circuit in the control interface generates timing pulses from the line voltage. The simplified circuit is drawn in Figure 5. The two operational amplifiers act as comparators. The voltage dividers, connected to the noninverting inputs, are used to fine tune the phase relationship between the x-ray

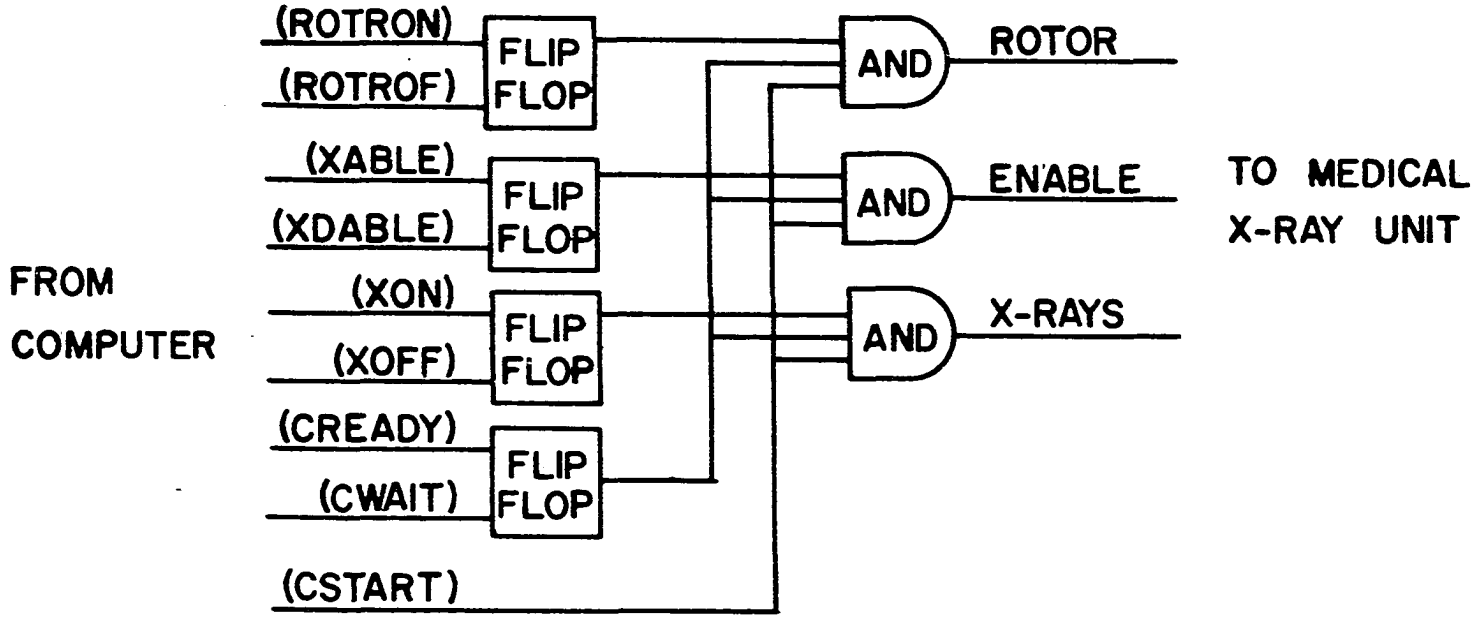

Figure 4. Simplified circuit diagram of the control interface. Interface commands are indicated in parentheses.

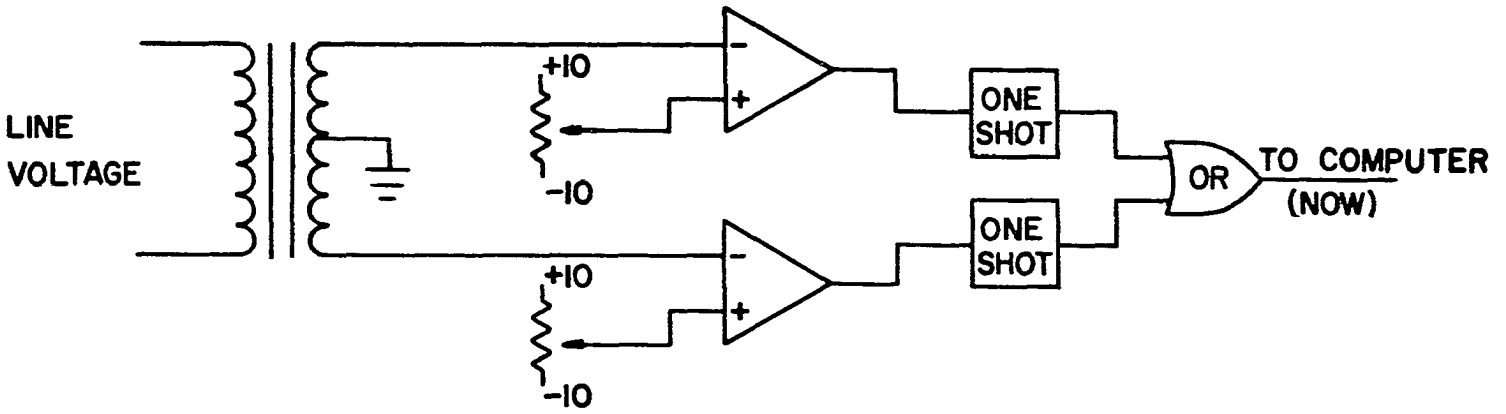

Figure 5. Simplified circuit diagram of the circuit used to generate timing reference pulses.

supply and the timing pulses. The gated integrator, also designed by G. Holland, is an operational amplifier with a feedback capacitor and several input resistors. The circuit board is contained in the control interface chassis. The simplified circuit is drawn in Figure 6. Three input resistances were included to attenuate the input voltage. The integrator is operated with two interface instructions shown on the diagram. All interface instructions, their octal values and functions are summarized in Table 2.

Table 2. Interface Instructions

Instruction	Octal Value	Function
CREADY	6337	Enable control interface
CREADY	6331	Open communication lines
CWAIT	6336	Close communication lines
NOW	6332	Timing pulse
ROTRON	6341	Turn rotor on
ROTROF	6342	Turn rotor off
XABLE	6343	Enable x-ray supply
XDABLE	6344	Disable x-ray supply
XON	6333	Turn x-rays on
XOFF	6334	Turn x-rays off
INBOX	6346	Initialize integrator
STBOX	6345	Start integrator
GETDAT	6354	Transfer data
STATOD	6455	Start A to D conversion
INATOD	6455	Initialize A to D converter

Computational Facilities

The data, produced by the pulsed XEOL system, is processed by PL/1 and FORTRAN IV programs. These programs are

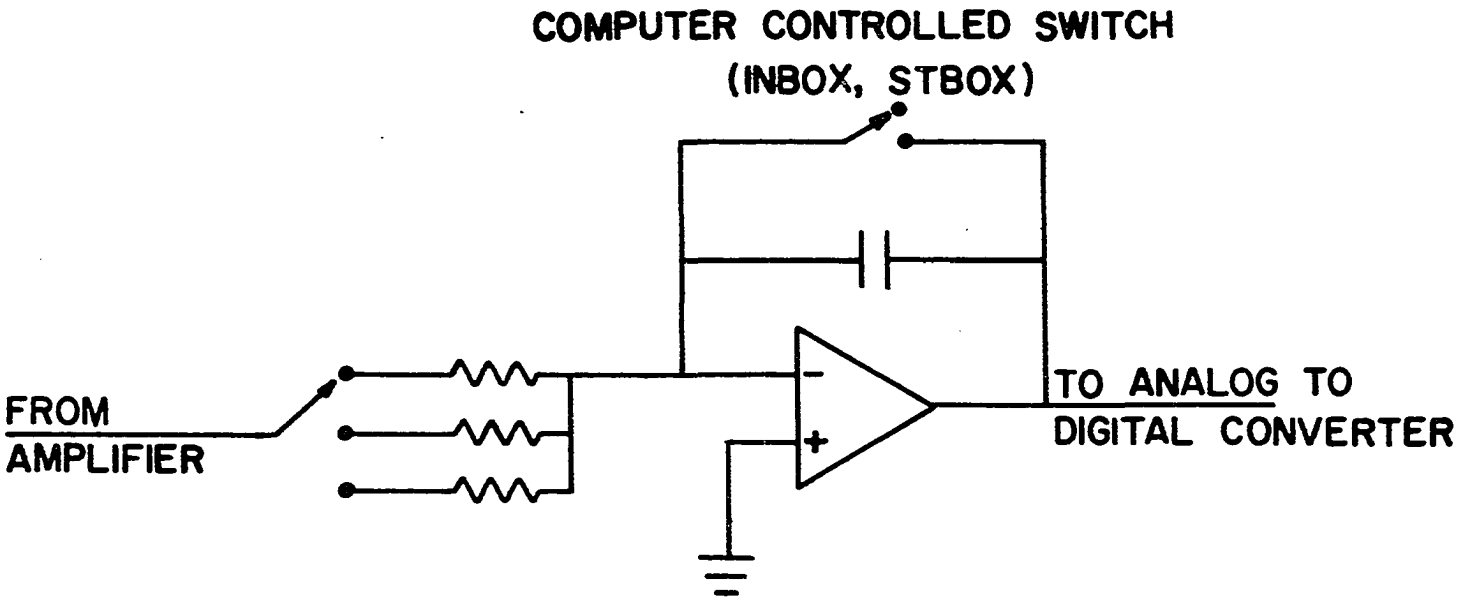

Figure 6. Simplified circuit diagram of the gated integrator. Control instructions are indicated in parentheses.

executed on the IBM 360/65 and ITEL AS/5 computers in the Iowa State University Computation Center. The PL/1 program was written to plot decay curve data using Simplotter (52) and to produce an input data set in the proper format for the FORTRAN IV program, called SMASH (53). SMASH was developed by the neutron activation analysis group at Ames Laboratory to separate complex decay curves and was modified for the present study to handle spectroscopic data. Listings of the PL/1 and SMASH programs appear in Appendix 1 and Appendix 2 respectively.

A conversational system, known as WYLBUR, makes operator interaction with the data processing system possible. WYLBUR was accessed over telephone lines located in our research area. A Decwriter II (Digital Equipment Corp. Maynard, MA) and Teletype (Teletype Corp., Skokie, IL, Model 35) were the devices used to communicate instructions to WYLBUR. WYLBUR is a text editing program with remote job entry and execute file capabilities supported by the Iowa State University Computation Center. The text editing features facilitate program writing and the remote job entry feature simplifies the debugging process. After the paper tape data set is transferred to the computer system, a WYLBUR execute file is used to generate a control data set for the PL/1 program and to create a system job composed of job control language, program listings and data. WYLBUR submits the job to the

system and the results are printed in the computation center.

Another facility available at the Iowa State University Computation Center for displaying graphical data is Simplotter. Simplotter is a FORTRAN program, developed at Ames Laboratory, for general plotting requirements. Simplotter was used to display decay curves, calibration curves and other general data. A PL/1 program was written to access Simplotter directly to plot simple data sets while WYLBUR was used to generate the data set with the proper format. A listing of the WYLBUR execute file and PL/1 program is given in Appendix 3.

The computational facilities, available through the Iowa State University Computation Center, made the time resolution experiment possible. The separation of complex decay curves by a least squares method using a digital computer is a routine exercise. Without the least squares method we would have limited our resolution to simple two-component systems because graphical methods would have been employed. Our ability to use mathematical techniques, such as the SMASH routine, made it possible to extend time-resolved spectroscopy to mixtures with more than three components.

CHAPTER 3: PULSED XEOL SYSTEM

The pulsed x-ray excited optical luminescence system is shown as a block diagram in Figure 7. At the heart of the system is a dedicated minicomputer. The stringent timing requirements for x-ray pulse generation and the careful measurement of integration periods during data acquisition required the use of a dedicated computer. Human interaction with the system occurs at the teletype where input is typed at the keyboard and output is generated at the punch as paper tape. The assembly language program which generates the x-ray pulse, controls the data acquisition system and handles input and output information is listed in Appendix 4.

The computer interacts with the system through two interfaces. The data interface is used to transfer digital data from the analog-to-digital converter to the computer memory where it is stored until output is punched. The control interface connects the computer, the x-ray supply and the integrator. Timing reference pulses are produced in the control interface.

The excitation source in the luminescence system is a modified medical x-ray unit. The x-ray supply can produce a maximum voltage of 150 kV. across the x-ray tube and a maximum current of 300 mA. through the x-ray tube. The x-ray tube is a rotating anode, medical x-ray tube which is cooled by conduction.

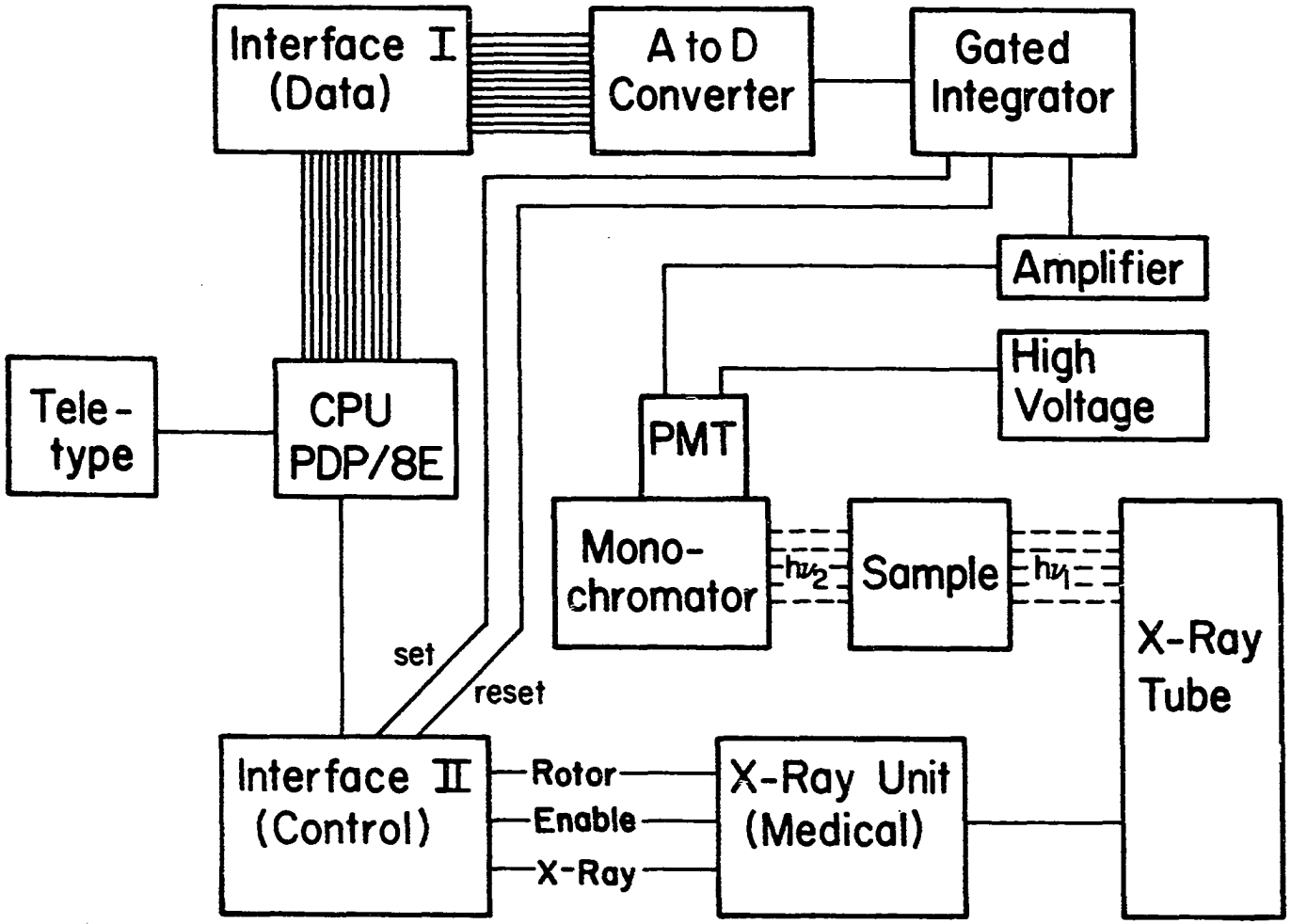

Figure 7. Block diagram of the pulsed x-ray excited optical luminescence system.

Three control signals are required to pulse the x-ray source. First, the rotating anode must be started. The rapid rate of rotation prevents excessive heating of localized areas of the anode surface and subsequent sputtering and pitting. Next the x-ray supply must be enabled. Under normal operation the enable function would produce x-rays. Finally, a gate pulse signals the power supply to release the thyratron switches and activate the x-ray tube for the duration of the pulse.

During the on period of the x-ray pulse, the sample, typically PAHs dissolved in n-heptane at 10 K, is excited. At termination of the x-ray pulse some initial activity exists and decays exponentially. The emission is collected by a lens, dispersed with a monochromator and detected by a photomultiplier tube. The photomultiplier tube current is amplified by a fast response (typically 1-10 msec.) current amplifier and a voltage signal results.

The gated integrator sums the voltage signal for a predetermined period and is reset. Prior to the reset command, the integrator output is sampled and an analog-to-digital conversion is performed. After the integrator is reset the process is repeated until the number of data points, specified by the operator, is obtained. The luminescent decay is characterized by the sequential data points. The timing relationship between the x-ray pulse and

the integration of the voltage signal is precisely controlled by the minicomputer. The digital data are transferred to computer memory where luminescent decay from subsequent x-ray pulses can be added. The signal averaged data are punched on paper tape and analyzed on the Iowa State University Computation Center facilities.

In the following sections detailed explanations of the operation of different phases of the pulsed, x-ray excited, optical luminescence system are presented. The principles of x-ray pulse generation are outlined. The control of the sample temperature and the containment of the sample are described. The data acquisition options are presented and the section on data analysis follows the data after they are punched on paper tape to the final results. Finally, some consequences of the pulsing technique are discussed in the section on x-ray pulse characteristics.

X-ray Pulse Generation

The first attempt to produce an x-ray pulse involved a high voltage grid in the x-ray tube which could deflect the electron beam away from the anode. Before implementing the grid approach, the x-ray emission of the DC supply was characterized. A liquid scintillator was irradiated and the response was observed with an oscilloscope. A typical oscilloscope tracing is depicted in Figure 8. A full-wave

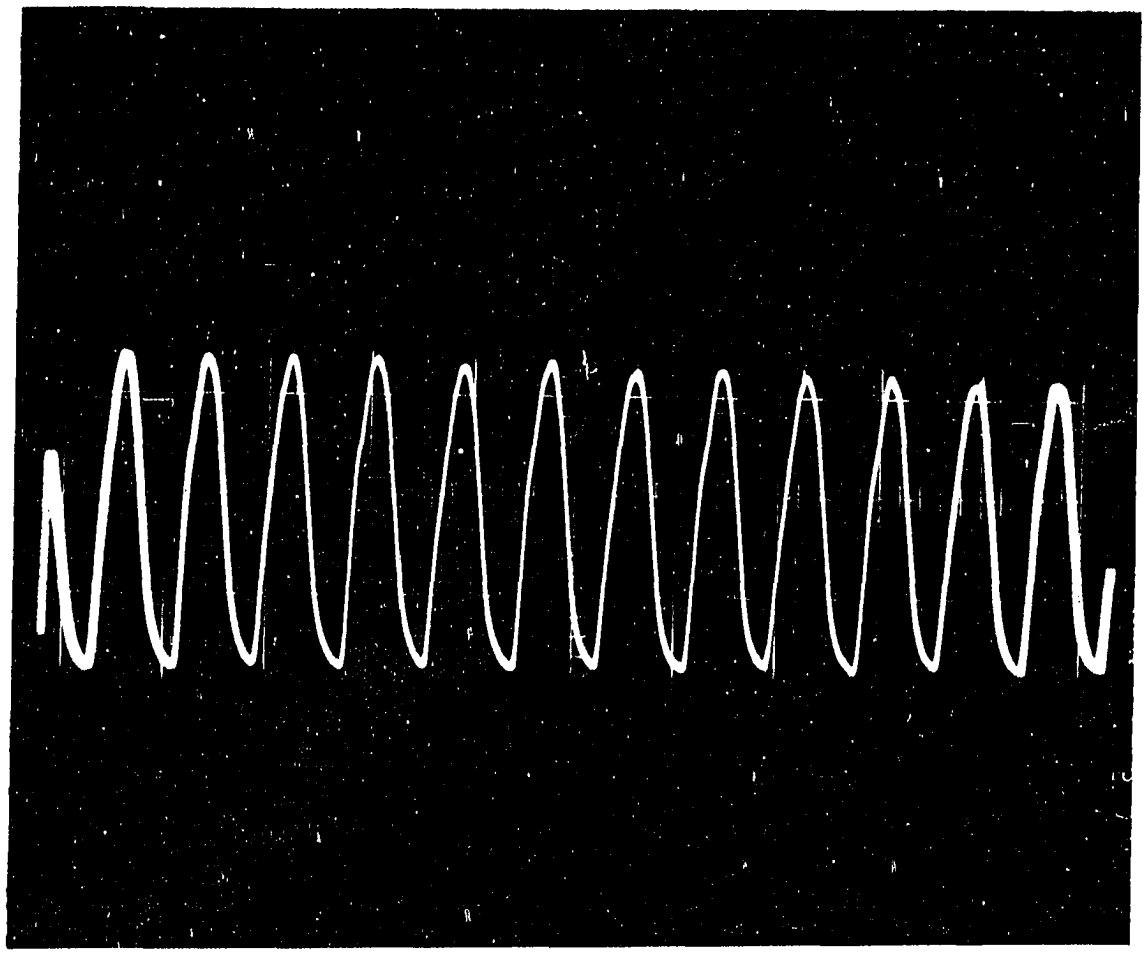

Figure 8. Oscilloscope tracing of the amplifier signal produced by a photomultiplier tube in response to a fast scintillator (perylene in n-heptane) excited by a DC x-ray source. Horizontal scale is 10 msec./cm. and vertical scale is 2 volts/cm.

rectified sine-wave with a frequency of 120 cycles per second was observed. The sine waveform and not a DC level was observed because manufacturers of x-ray equipment do not filter the voltage supply which powers the x-ray tube. The size of the capacitors and resistors that are required to filter kilovolt voltage levels are prohibitive. The switch-selectable voltages and currents on x-ray sources are root-mean-square values and represent the DC average of the waveform. The grid approach was abandoned and advantage was taken of the inherent pulsed nature of a DC x-ray supply. If the medical x-ray supply could be turned on at a zero point in the waveform and off at a later zero point, an x-ray pulse which is a multiple of 1/120th of a second in length could be produced.

To generate such an x-ray pulse required precise determination of zero points in voltage waveforms, such as the one shown in Figure 8. A computer was used to control the pulse generation. Because the computer could not monitor the voltage waveform of the medical x-ray unit directly, a virtual link between the computer and the x-ray unit was established with the control interface. The line voltage which powered the control interface was used to produce timing reference pulses every time the line voltage went to zero. Because the entire United States is on the same power grid the timing reference pulses differed from the zero

points of the voltage waveform in the medical x-ray supply by a simple phase relationship. An oscilloscope was used to synchronize the timing reference pulses and the zero points in the voltage waveform with the phase adjustments in the control interface.

Normal operation of the medical unit required two steps to produce x-rays. After the thyratron switches were modified to function under computer control, three steps were required. The rotor had to be started, the x-ray unit had to be enabled, which produced x-rays in normal operation, and the thyratron switches had to be gated. The sequence of events in production of a typical x-ray pulse is shown in Figure 9. After the rotor was started and the x-ray unit was enabled, the computer start command enables the control interface. The computer ready command released the timing reference pulses. At the first zero point the x-rays were turned on and at the next zero point the x-rays were turned off. If a longer excitation period was required, the process was repeated until the number of waves, as specified by the operator, occurred. Variable length excitation periods from 1/120th of a second to several seconds could be produced. The maximum length of x-ray excitation period was limited by the voltage, current and time product which determined the electrical power the x-ray tube had to dissipate as heat.

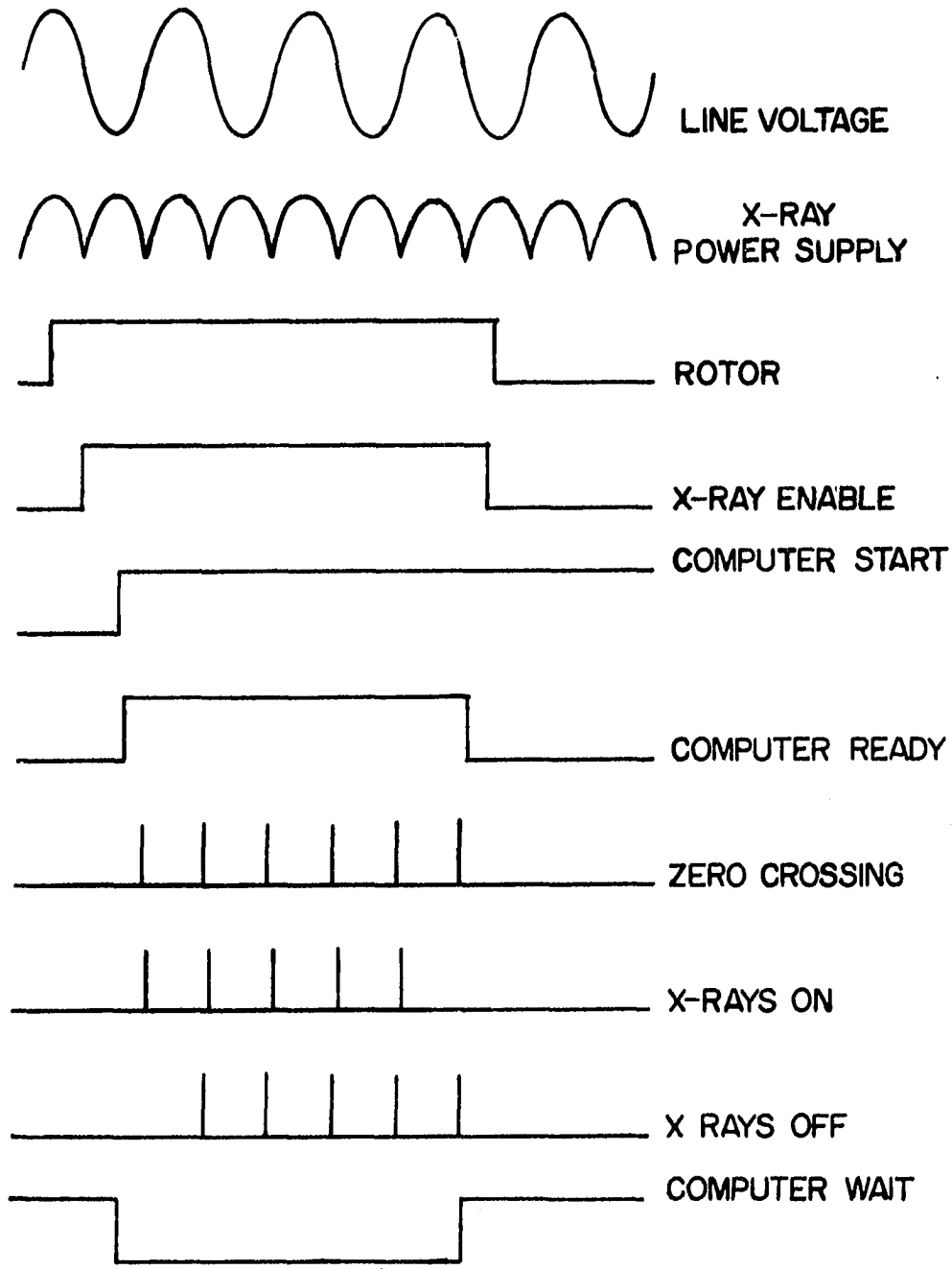

Figure 9. Timing diagram which illustrates the time relationship and sequence of events in the production of a typical x-ray pulse.

Refrigeration and Optical Systems

The pulsed XEOL system was developed to study a variety of samples over a large temperature range. A refrigeration system with the flexibility to study solids, liquids and gases at temperatures in the range from liquid helium to boiling water was desired. A helium refrigerator (see Table 1 for details) was purchased and incorporated in the pulsed XEOL system. The helium refrigerator was a two stage cryostat which worked on the Solvay process and provided the capability of examining the spectra of solids, liquids and gases at thumb-switch-selectable temperatures ranging from 10 to 360 K with 1 K resolution.

Unfortunately, the helium refrigerator presented its own problems. Because the vacuum used to insulate the cryostat from the surroundings prohibited the use of conventional XEOL sample handling techniques, a sample holder which could contain the sample in a vacuum, allow x-rays to irradiate the sample and transmit the optical radiation was designed. The materials problems encountered in designing the sample holder with the specifications mentioned above required a change from the conventional geometry used in an XEOL experiment.

The sample holder used in this study is sketched in Figure 10. The body of the sample holder was made of oxygen-free high conductivity (OFHC) copper. The quarter-twenty thread attaches the holder to the cryostat.

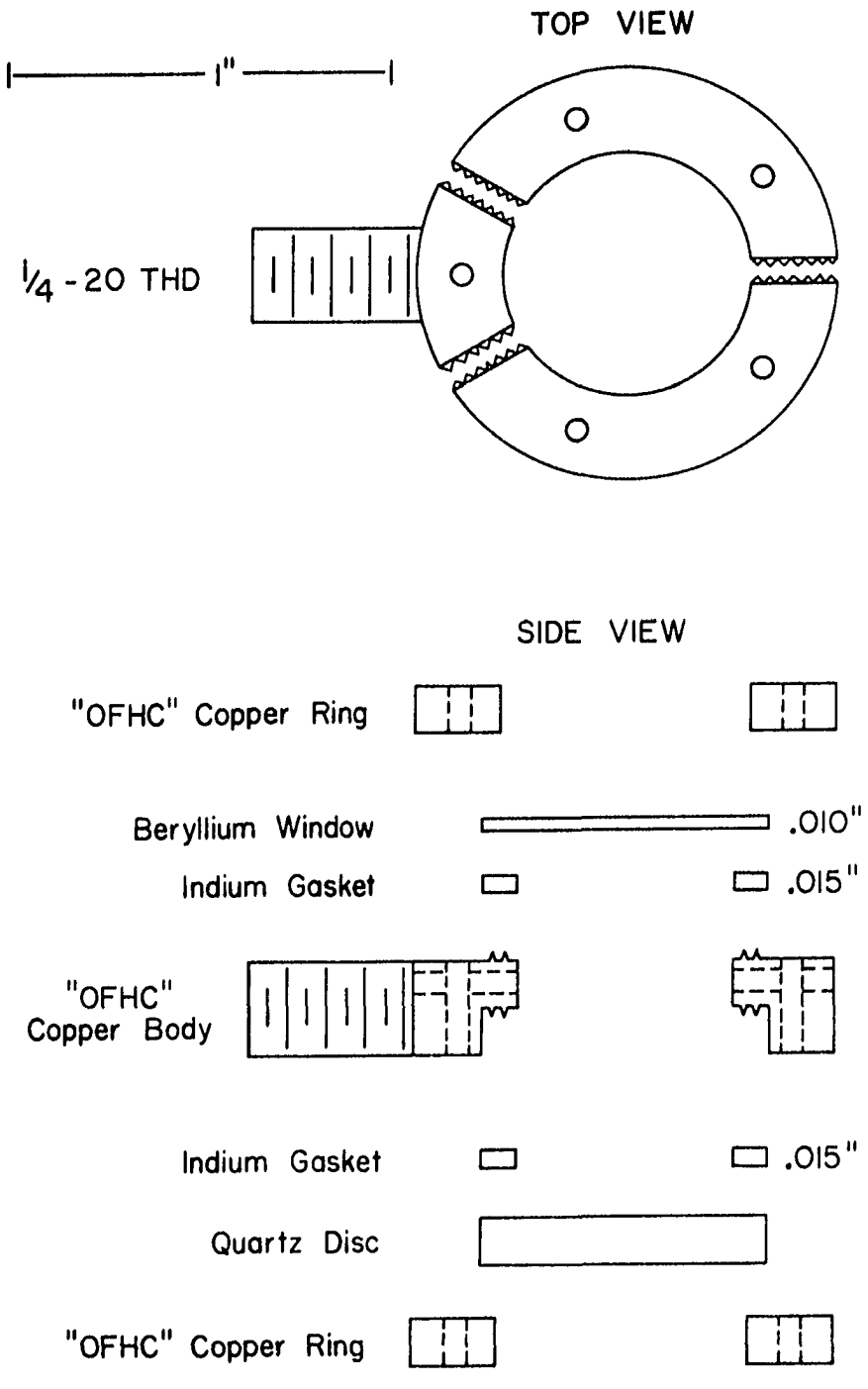

Figure 10. Sample holder used with the pulsed XEOL system. Main body and retaining rings were fabricated from oxygen free high conductivity copper.

An indium washer was placed between the cryostat and the holder to compensate for expansion and contraction effects and to insure that thermal contact was made between the cryostat and the sample holder. The sample was held between a beryllium window and a fused quartz disc. Both the window and the disc were sealed to the holder with OFHC copper retaining rings and indium gaskets. Indium gaskets were used because of the ductility of indium at 10 K. Also, 0.2 mm. (0.008 in.) indium gaskets replaced the thicker gaskets shown in Figure 10 because less indium was smeared into the sample holder. The sample was injected into the holder with a syringe through the filling ports. The ports were threaded and sealed with number two screws and indium gaskets. The holder was emptied by removing two of the three number two screws.

A "straight-through" geometry was used with the sample holder described above. The optical diagram is shown in Figure 11. Advantage was taken of the penetrating ability of x-ray radiation and the crossed Czerny-Turner mount of the monochromator. The x-ray cross section of capture for carbon and hydrogen is small so the x-ray beam is not significantly attenuated by a hydrocarbon sample, therefore, the x-ray beam and the luminescence proceed into the monochromator. At the collimating mirror the optical signal is reflected to the grating but the x-ray radiation passes through the mirror and is absorbed by the lead shielding which surrounds the

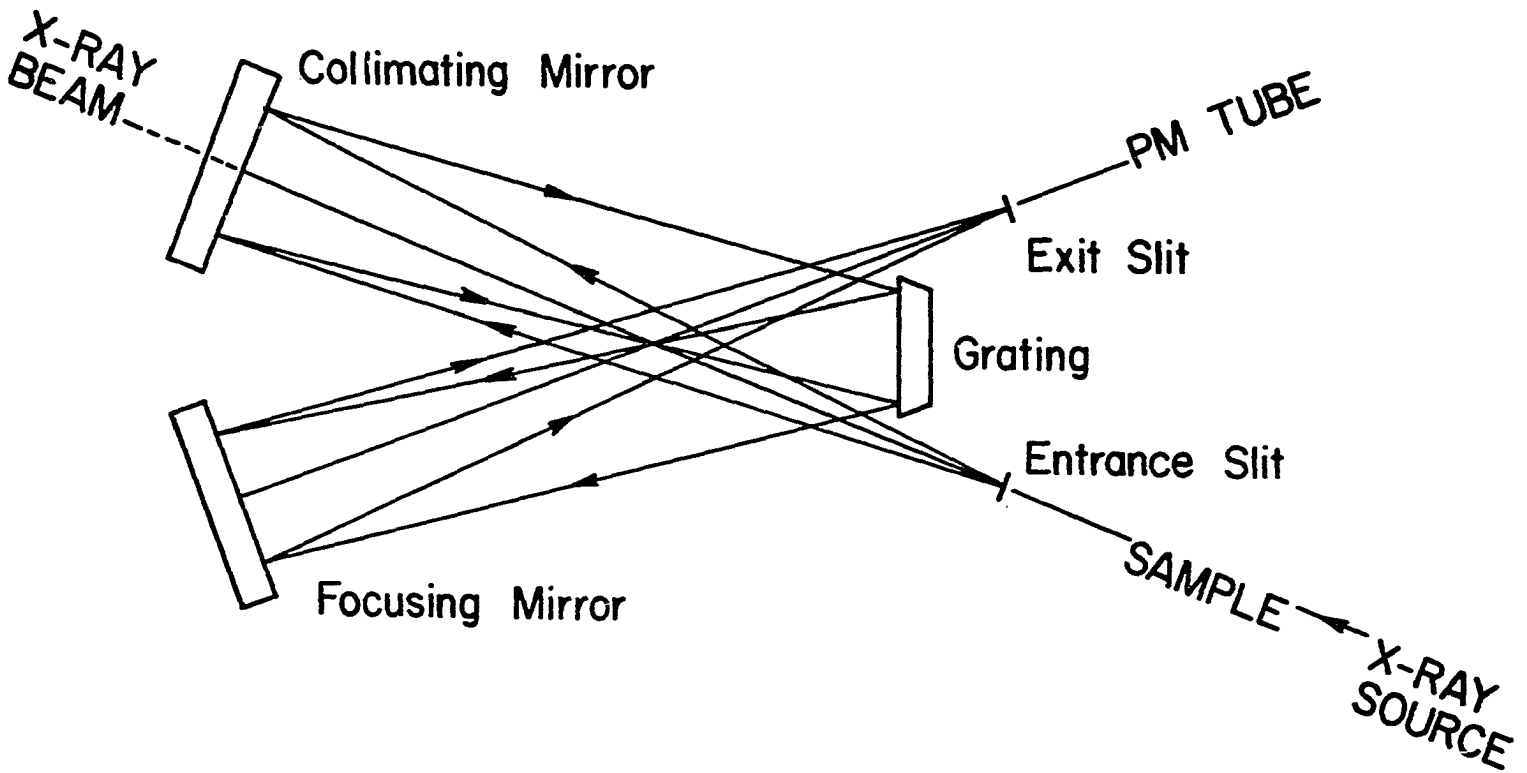

Figure 11. A schematic diagram of the optical system designed around the crossed Czerny-Turner mount of the McPherson monochromator used in the pulsed XEOL system.

monochromator. The optical signal is dispersed at the grating and proceeds to the photomultiplier tube where it is detected. Scattered x-ray radiation does not enter the photomultiplier tube to produce noise because the photomultiplier tube is positioned off the primary optical axis.

Data Acquisition System

The major objective for construction of the pulsed XEOL system was to obtain decay curve data. The large x-ray flux available with a pulsed source represents an advantage over the DC sources, hence a secondary objective was to obtain pseudo-DC data. The major instrumental components of the data acquisition system were the gated integrator, the analog-to-digital converter and the data interface. The heart of the system, however, was the software which controlled the gated integrator. The software was written to make the data acquisition system operate in one of two modes, a fast mode or a slow mode.

In the fast mode, pseudo-DC data was obtained. The fast mode was used to study fluorescent single component emission. The integrator was started at the zero point of the x-ray wave and reset at the next zero point. The luminescence produced by a single x-ray wave was integrated and the voltage output of the integrator was considered the average

DC level of the luminescence. To improve the signal-to-noise ratio and the statistical values of the data several successive waves could be integrated during an extended pulse and the data of several pulses could be summed to signal average the noise. A mean and standard deviation were calculated and used as an average DC value for subsequent analytical calculations.

In the slow mode, decay curve data were obtained. There were two algorithms for sampling an exponential decay. The first algorithm involved integration of the entire decay curve and periodic sampling of the integrator output. A numerical differentiation generated the original decay curve. The second algorithm divided the decay curve into equal time segments. Each time segment was integrated and the voltage output was plotted as a function of time to obtain the decay curve. The second approach was used because the individual integrations "signal averaged" the noise to a constant value which could be subtracted from each data point and enhanced signal-to-noise ratios as compared to the discrete sampling algorithm resulted.

Three integration periods (1000, 100 and 10 msec.) were programmed for the gated integrator, so that a large range of decay constants could be studied. The reset time of the integrator was 1 millisecond, hence a small percentage of the signal is lost. To illustrate, use of the 10 millisecond

integration period means 10 percent of the signal was lost during the reset time whereas with the 1000 millisecond integration period, only 0.1 percent of the signal was lost. The same "real-time" must be integrated to obtain equivalent signal-to-noise ratios if different integration periods are used. For example, if 10 decay curves are summed using the 1000 millisecond integration period then 100 decay curves have to be summed using the 100 millisecond integration period and 1000 decay curves have to be summed using the 10 millisecond integration period to obtain equivalent signal-to-noise ratios.

In both modes the data acquisition system proceeded in several steps. The analog signal from the fast response current amplifier was integrated according to the algorithm of the mode. The integrator output was digitized by the analog-to -digital converter in 20 microseconds. The digitized signal was passed to the computer through the data interface in a parallel transmission. The data was temporarily stored in the computer until output was punched and then the paper tape was processed by the large computer system as described in the next section.

Data Analysis

The pulsed XEOL system generated large quantities of numerical data in either mode of operation. To process these

data, sophisticated computational facilities were needed. Furthermore, the time resolution experiment was dependent on a numerical characterization of simple or complex decay curves. The statistical techniques needed to characterize the decay curves were ideally suited for computer analysis. For these reasons it was necessary to accumulate data with the minicomputer but process the data on a more sophisticated computer system.

The Iowa State University Computation Center operates an IBM 360/65 and an AS/5 computer system. PL/1 and FORTRAN IV are among the many languages supported by the system. An interactive system, known as WYLBUR, is also available. WYLBUR, PL/1 and FORTRAN IV were used extensively for the analysis of the numerical data.

The paper tape data set generated by the assembly language program contained control information used in the assembly language program and the numerical data collected from the experiment. The data set was transferred to the large computer and stored on disc. WYLBUR was used to construct a job which calculated the experimental results. If the fast mode was run the job contained only a PL/1 program which read the data from disc and calculated a mean and standard deviation. The results were printed with a data dump of the important control variables. If the slow mode was run, the job contained a PL/1 program and a modified FORTRAN IV

program. The PL/1 program read the data from disc and plotted the decay curve using Simplotter. The data dump was generated and an output data set was created which was the input for the FORTRAN IV program, called SMASH. SMASH either calculated a decay curve by a direct-search method or used a linear least squares procedure to calculate initial activities of the luminescence. The results of the SMASH program were printed by the output routines contained within the program.

After the data analysis job was completed, the output was retrieved from the Iowa State University Computation Center. The results were extracted from the printed material. If wavelength or concentration plots were desired, another jcb could be created with a WYLBUR execute file and PL/1 program, which generated a computer plot with Simplotter. Analytical data were calculated with a hand calculator.

All the programs mentioned in this section are listed in Appendices 1-4. The PL/1 programs were written specifically for this study but the SMASH program was borrowed from the neutron activation analysis group and the input routine was modified to facilitate operation of the program. The job ccntrol language which regulates execution of the job is listed in Appendix 5. The WYLBUR execute file which created the job is listed in Appendix 6.

X-ray Pulse Characteristics

The method used to generate the x-ray pulse limited the range of the time resolution experiment. The limitation is manifest by a differential equation which relates the number of excited molecules as a function of time to a supply term and a depletion term. The relation is expressed in equation 1;

$$N' = S*F - k*N \qquad (1)$$

where N represents the number of excited molecules as a function of time, S is the cross section for capture of an x-ray photon, F is the driving function or functional form of the excitation source ($F=\sin(\omega t)$) and k is the decay constant of the excited molecule. The equation holds only while the x-ray pulse is active. The solution is given in equation 2;

$$N = S[k*\sin(\omega t) - \omega*\cos(\omega t)] \,/\, [k^2 + \omega^2] \qquad (2)$$

Three cases are considered to simplify the form of the solution. If $k>>\omega$, which corresponds to phosphorescent emission, then equation 3 results;

$$N = (S/\omega)\cos(\omega t) \qquad (3)$$

As the x-ray pulse ($\sin(\omega t)$) goes to zero, the number of excited molecules goes to a maximum and an initial activity

exists after the x-ray pulse. If $k<<\omega$, which corresponds to fluorescent emission, then equation 4 results;

$$N = (S/k)\sin(\omega t) \qquad (4)$$

Now, as the x-ray pulse goes to zero so does the number of excited molecules and no initial activity exists after the x-ray pulse. Finally, if $k \approx \omega$ then no simplification of the equation is possible. Some initial activity does exist after the x-ray pulse but the decay is severely distorted by the shape of the excitation pulse. Fourier techniques are used to deconvolute the data and extract the decay curve.

To summarize the three cases, with the x-ray pulse used in the present study the time resolution experiment was limited to phosphorescent emission. Fluorescent emission could not be time resolved but was studied by observation of single component emission with the pseudo-DC mode. No intermediate decay curves were observed from the PAHs studied, but as the scope expands to include other types of organic compounds it will be necessary to develop the Fourier techniques to deconvolute the data.

CHAPTER 4: EXPERIMENTAL PROCEDURES

Preparation of Chemicals, Solvents and Solutions

All of the PAHs used in the XEOL study are listed in Table 3. The PAHs were purified by zone refining or vacuum sublimation as indicated in the table. The crude PAHs were sealed in a glass tube under a partial pressure of helium and melted before being zone refined. A minimum of five passes on a ten-stage zone refiner were used to purify the PAHs. The zone refined tubes were scratched with a file and broken in thirds. The top and bottom thirds of the tube were discarded and the middle third was retained. The PAHs were chipped and scraped from the glass tube when needed for solutions. To vacuum sublime coronene and benzo-ghi-perylene, the two compounds were sealed individually in a vacuum under a water-cooled glass probe. A mineral oil bath was used to sublime the PAHs which subsequently condensed on the glass probe. The glass probe was removed from the vacuum and the PAH was scraped from the surface and stored for later use. Vacuum sublimation was used because too little starting material was available for zone refining. Only naphthalene and fluorene were used as received.

On the basis of their XEOL spectra, seven of the PAHs were used as model compounds for the time resolution experiments. Triphenylene, coronene, chrysene, phenanthrene,

fluoranthene, naphthalene and fluorene exhibited phosphorescent emission. Perylene and 3,4-benzopyrene were used as model compounds for the single component fluorescent experiments.

Table 3. Polynuclear Aromatic Hydrocarbons

Compound	Purity
Naphthalene	As received
Anthracene	Zone refined
Phenanthrene	Zone refined
1,2-Benzanthracene	Zone refined
Pyrene	Zone refined
Chrysene	Zone refined
Triphenylene	Zone refined
1,2,5,6-Dibenzanthracene	Zone refined
3,4-Benzopyrene	Zone refined
Perylene	Zone refined
Benzo-ghi-perylene	Vacuum sublimed
Coronene	Vacuum sublimed
Fluorene	As received
Fluoranthene	Zone refined

Three n-alkane solvents were used, n-hexane, n-heptane and n-octane. The solvents were distilled and passed through a cation exchange resin in the silver form to remove the last traces of aromatic impurities. A weak bond is formed between the silver cation and the pi bond of the aromatic system. If the price of the solvents should become prohibitive the purification procedure can be used to recycle the n-alkane solvents. Gas chromatographic analysis of the purified solvents revealed the only contaminants were trace amounts of

isomeric aliphatic hydrocarbons.

Stock solutions of the PAHs were prepared in volumetric flasks from weighed quantities of purified PAHs. Concentrations ranged from 0.01 M to 0.0001 M. Solubility limited the maximum concentration for several PAHs. PAHs which dissolved slowly were equilibrated overnight or vigorously stirred by an ultrasonic cleaner. Concentrated stock solutions were prepared to minimize adsorption and decomposition effects commonly observed with very dilute solutions. All stock solutions were stored in the dark to avoid photodecomposition. Dilute solutions were prepared as needed on a day-to-day basis from the stock solutions. No successive dilutions were performed to minimize pipetting errors.

Time Resolved Spectroscopy

The principles of time resolved spectroscopy are based on the radiative lifetimes of excited molecules. The functional form of the time dependence of single component luminescence is given in equation 5:

$$I(t) = I(0)\exp(-kt) \qquad (5)$$

I(t) is the emitted intensity as a function of time, I(0) is the initial intensity at the termination of the excitation pulse, k is the decay constant of the excited species and t

is the time. If many species are emitting simultaneously the time dependent intensity is expressed by equation 6:

$$I(t) = \sum_i I(0)_i \exp(-k_i t) \qquad (6)$$

The total intensity is the sum of the intensities of all the emitting species.

The time resolution experiment is divided into two phases. First, decay curves are obtained from the individual luminescent species and decay constants are determined by substitution of the data into equation 5. Second, decay curves from mixtures of luminescent species are collected. The decay constants, determined from single component decay curves, are substituted into equation 6 and the initial intensity of each component is calculated. Finally, the initial intensities are related to the concentration of the luminescent species in the sample.

To prepare either phase of the time resolution experiment the steps listed in Table 4 are performed. After the preparations are completed, the experiment is initiated by operator interaction with the minicomputer. The step by step operation of the minicomputer is described in Table 5.

After the experiment is completed and the paper tape data set is transferred to disc, WYLBUR is used to prepare a job which processes the data. If a decay constant is sought certain conventions are followed. A preliminary job is

Table 4. Stepwise Preparation of Pulsed XEOL System

1. Inject the sample into the holder and seal the holder with indium gaskets and number two screws (Approximately 1.0 ml. of sample is needed to fill the holder).
2. Attach the holder and radiation shield to the cryostat and insert the cyrostat into the vacuum shield.
3. Connect the vacuum line and pull a vacuum on the contents of the vacuum shield.
4. Start the refrigerator and wait for the sample to cool.
5. Turn on the medical x-ray unit and select the current and voltage for the x-ray pulse (typically 60 kV., 100 mA.).
6. Make certain the slits are opened (typically 1000 micrometers), the monochromator is tuned to zero order and the photomultiplier tube is on (typically 1200 volts).
7. Turn on the computer power key and the teletype.

created which generates a plot of the decay curve. An estimate of the half life is made from the decay curve by measuring the time the intensity drops to one half the initial value. The decay constant is equal to 0.693 divided by the half life. A second job is generated which contains SMASH. The estimate of the decay constant is input into SMASH as a negative number. The negative estimate signals SMASH to perform a direct search for the decay constant. The initial estimate is used to calculate a maximum value for the quality of fit. A search vector is followed and the value for the quality of fit is minimized as the search vector proceeds to

the final value of the decay constant. At the completion of the calculation output is generated which lists the initial data and the calculated fit with the estimated decay constant and with the final decay constant.

Table 5. Minicomputer Operation

1. Load the assembly language program into memory if the program is not already present in memory (Consult the operations manual).
2. Depress all address switches and press the extended address load switch.
3. Load 200 octal into the address switches and press the address load switch.
4. Place the halt switch in the up position, press the clear switch and the continue switch (The telepype should print a message).
5. Enter the date and time as requested and answer subsequent questions. Typical answers are; Number of waves = 480, Number of passes = 10, Transient decay = 800, Number of data points = 100, Range code = 3. After the last question is answered the experiment will start automatically.
6. Turn the punch on and wait for the next question to be printed by the teletype.
7. After the experiment is completed depress the halt switch and tear the paper tape data set off the punch.
8. Roll the paper tape and submit it at the Iowa State University Computation Center for transfer to disc.

A complex decay curve can be time resolved with SMASH if different conventions are used. The same WYLBUR execute file

is used to prepare the job. A decay constant, which has been determined from single component data, is entered for each species which contributed to the decay curve. All decay constants are entered as positive numbers. The positive decay constants signal SMASH to perform a linear least squares procedure to calculate the initial intensities of the various components. The quality of fit is calculated and if the value does not fall between specific limits, error messages are generated. The error messages indicate whether too many or too few decay constants were entered. The output contains the initial data and the calculated data. The initial intensities are listed with the corresponding decay constants.

The output produced by the job is retrieved from the computation center and the calculated results are extracted from the printed matter and tabulated. If analytical results are sought the calculated results are normalized for amplifier gain and integrator input resistance. The normalization factors are listed in Table 6. After the results are normalized, calibration curves are plotted or unknown concentrations of PAH's are calculated.

Fluorescence Measurements

If fluorescent emission is measured the capacitor in the gated integrator is reduced by a factor of 60. Greater integrator sensitivity is needed because the integration

Table 6. Normalization Factors

Amplifier Gain	Input Resistor	Normalization Factor
1 X 10^8	50K ohms	1
	100K ohms	2
1 X 10^7	25K ohms	5
	50K ohms	10
	100K ohms	20
1 X 10^6	25K ohms	50
	50K ohms	100
	100K ohms	200

period is shortened to 1/120th of a second when single waves are integrated. After the integrator is modified the pulsed XEOL system is prepared as described in Table 4. The x-ray supply is adjusted to 90 kV. and 300 mA. because a shorter pulse is used for the fluorescence experiment and the x-ray tube can dissipate the heat. The experiment is initiated as described in Table 5 but different input is used. The fast mode is specified for the assembly language program and only the number of waves in the pulse and the number of passes are entered. Typically 40 waves and 20 passes are selected. The experiment begins after the last question is answered.

Even though computerized data analysis techniques exist for the fast mode, the techniques were not used. The data collected from fluorescent emission were analyzed with a programable calculator. If analytical results are desired the calculated results are normalized with the factors given in

Table 6. A mean and standard deviation were calculated from the signal averaged data obtained for each wave in the pulse. However, the data obtained from the first twenty waves were discarded because the x-ray flux produced by the x-ray tube is not stable immediately after the x-ray tube is turned on. The mean is used to profile emission bands, generate calibration curves and calculate unknown PAH concentrations.

CHAPTER 5: RESULTS AND DISCUSSION

Decay Constant Values

The first step in the time resolution experiment was the determination of decay constants of the phosphorescent PAHs. These constants were determined from the stock solutions prepared from purified PAH materials. Because the pulsed XEOL system was untested, a reproducibility study of the determination of several decay constants was performed. The five day stability of the system was measured for triphenylene, coronene, chrysene, phenanthrene and fluoranthene, and a mean was calculated from five values obtained on different days. The decay constants obtained on five different days for seven PAHs are listed in Table 7. Two of the values in the table were excluded from statistical calculations by the Dixon criterion. The excluded values resulted from an error in the search routine used by SMASH, because noise in the measurement system can cause a large spread in the data points which describe a decay curve, with the greatest spread late in the decay scheme, and a false minimum in the quality of fit can be sought by the search vector. The frequency of occurrence of the error in the search routine was governed by the signal-to-noise ratio of the data. The mean and percent relative standard deviation of each decay constant are summarized in Table 8.

Table 7. Five Day Determination of Decay Constants[1]

Compound	Day 1	Day 2	Day 3	Day 4	Day 5
Triphenylene	0.0696	0.0687	0.0688	0.0699	0.0689
Coronene	0.1160	0.1157	0.1165	0.1155	0.1169
Fluorene	0.1704	0.1690	0.1707	0.1704	0.1703
Phenanthrene	0.2775	0.2781	0.2460[2]	0.2736	0.2746
Naphthalene	0.3388	0.3483	0.3550	0.3385	0.2878[2]
Chrysene	0.3831	0.3809	0.3817	0.3849	0.3806
Fluoranthene	1.1231	1.1425	1.2067	1.0931	1.0222

[1]All quantities reported in sec^{-1}
[2]Values excluded by Dixon Criterion

Table 8. Decay Constant Statistics[1]

Compound	Mean Decay Constant	% RSD
Triphenylene	0.0692	0.77
Coronene	0.1161	0.50
Fluorene	0.1702	0.39
Phenanthrene	0.2760	0.79
Naphthalene	0.3452	2.3
Chrysene	0.3822	0.46
Fluoranthene	1.1175	6.0

[1]All quantities reported in sec^{-1}

If the decay constants are not independent of concentration, analytical applications of time resolved spectroscopy would be impossible. The concentration independent behavior of the decay constants had to be verified. Triphenylene, coronene, phenanthrene, chrysene and fluoranthene were selected for these verifications. The results are presented in Table 9. With the exception of the lowest concentration values for phenanthrene, chrysene and

fluoranthene, the decay constants reported in Table 9 agreed with the values tabulated in Table 8. Therefore, the independent behavior of the decay constants with concentration was verified. The three values at the lowest concentration were severely distorted by a background luminescence. When the concentration dependence study was performed the background interference was not understood and no correction was made. The source and nature of the background luminescence will be discussed in the next section.

Table 9. Concentration Dependence of Decay Constants[1]

Compound	1×10^{-3} M	1×10^{-4} M	1×10^{-5} M	1×10^{-6} M
Triphenylene	0.0700	0.0705	0.0708	0.0715
Coronene	------	0.1171	0.1180	0.1182
Phenanthrene	0.2791	0.2770	0.2820	0.3037
Chrysene	0.3851	0.3879	0.3805	0.4950
Fluoranthene	1.2374	1.1924	0.9067	------

[1]All quantities reported in sec^{-1}

A comparison of the decay constants observed in this study with literature values is shown in Table 10. Examination of the tabulated values indicates XEOL-TRS and conventional methods give comparable results. The agreement

between decay constants obtained from optical excitation and x-ray excitation helps to unravel the XEOL excitation mechanism. Normally, the decay constants of phosphorescent species in a highly ionized environment are significantly different from the decay constants of phosphorescenct species in a neutral environment. Thus, x-ray excitation as compared to optical excitation does not affect the environment of the excited species appreciably even though ionized intermediates are produced by x-ray interaction with matter. Finally, the results obtained from decay curves of individual PAHs are summarized as decay constants, lifetimes and half lives in Table 11. The decay constant and the lifetime are reciprocally related and the half life is 0.693 divided by the decay constant.

Mixture Analysis by Time Resolution

One advantage of time resolved spectroscopy was demonstrated by some early results obtained from simple two component systems. As a first example of the usefulness of time resolved spectroscopy, a mixture of triphenylene and phenanthrene was studied. On the right hand side of Figure 12 the DC spectra of triphenylene and phenanthrene are presented with the background trace and the DC spectrum of a mixture of the two compounds. The double lines which extend from the top spectrum to the bottom spectrum indicate the region of the

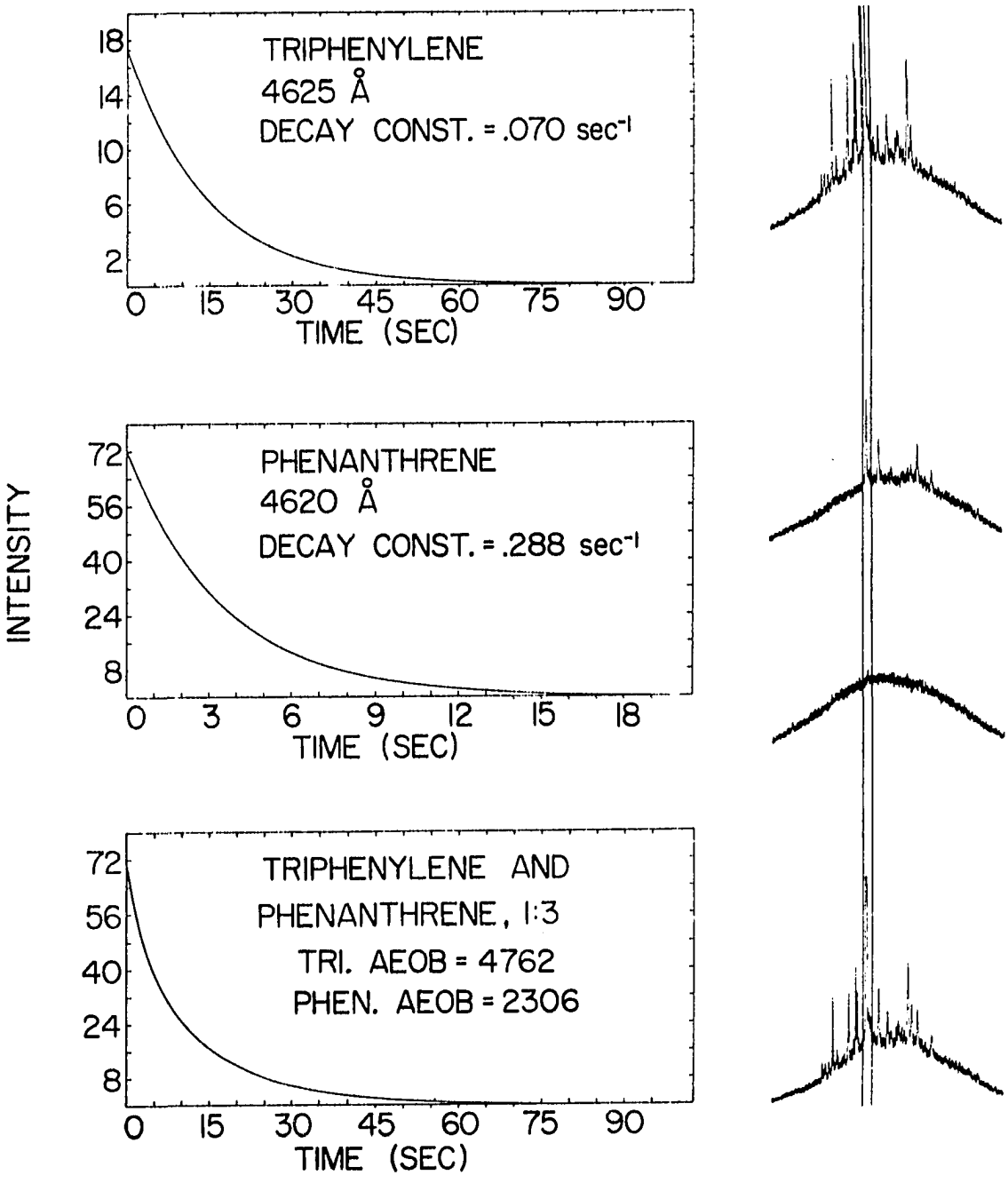

Figure 12. Time resolution of the phosphorescence emission from a mixture of triphenylene and phenanthrene in n-heptane by use of the pulsed XEOL technique.

Table 10. Comparison of XEOL and Published Decay Constants[1]

Compound	XEOL-TRS	Birks (26)	McClure (54)
Triphenylene	0.069	0.062	0.062
Coronene	0.12	0.11	0.11
Fluorene	0.17	0.20	0.20
Phenanthrene	0.28	0.29	0.30
Naphthalene	0.34	0.42	0.38
Chrysene	0.38	0.38	0.40
Fluoranthene	1.12	1.18	----

[1]All quantities reported in sec^{-1}

Table 11. Decay Constants, Lifetimes and Half Lives of PAHs

Compound	Decay Constant	Lifetime	Half Life
Triphenylene	0.069 sec^{-1}	14.5 sec	10.0 sec
Coronene	0.116 sec^{-1}	8.6 sec	6.0 sec
Fluorene	0.170 sec^{-1}	5.9 sec	4.1 sec
Phenanthrene	0.276 sec^{-1}	3.6 sec	2.5 sec
Naphthalene	0.345 sec^{-1}	2.9 sec	2.0 sec
Chrysene	0.382 sec^{-1}	2.6 sec	1.8 sec
Fluoranthene	1.118 sec^{-1}	0.89 sec	0.62 sec

spectra isolated by the monochromator. An obvious spectral interference is observed. On the left hand side of Figure 12 the decay curves for the individual compounds and the mixture are drawn. The decay constants used to time resolve the spectral interference are given on the top two plots and the initial intensities are summarized on the bottom plot. The nonzero initial intensities prove the spectral interference can be resolved temporally. A second example is presented in Figure 13 for the mixture of triphenylene and chrysene.

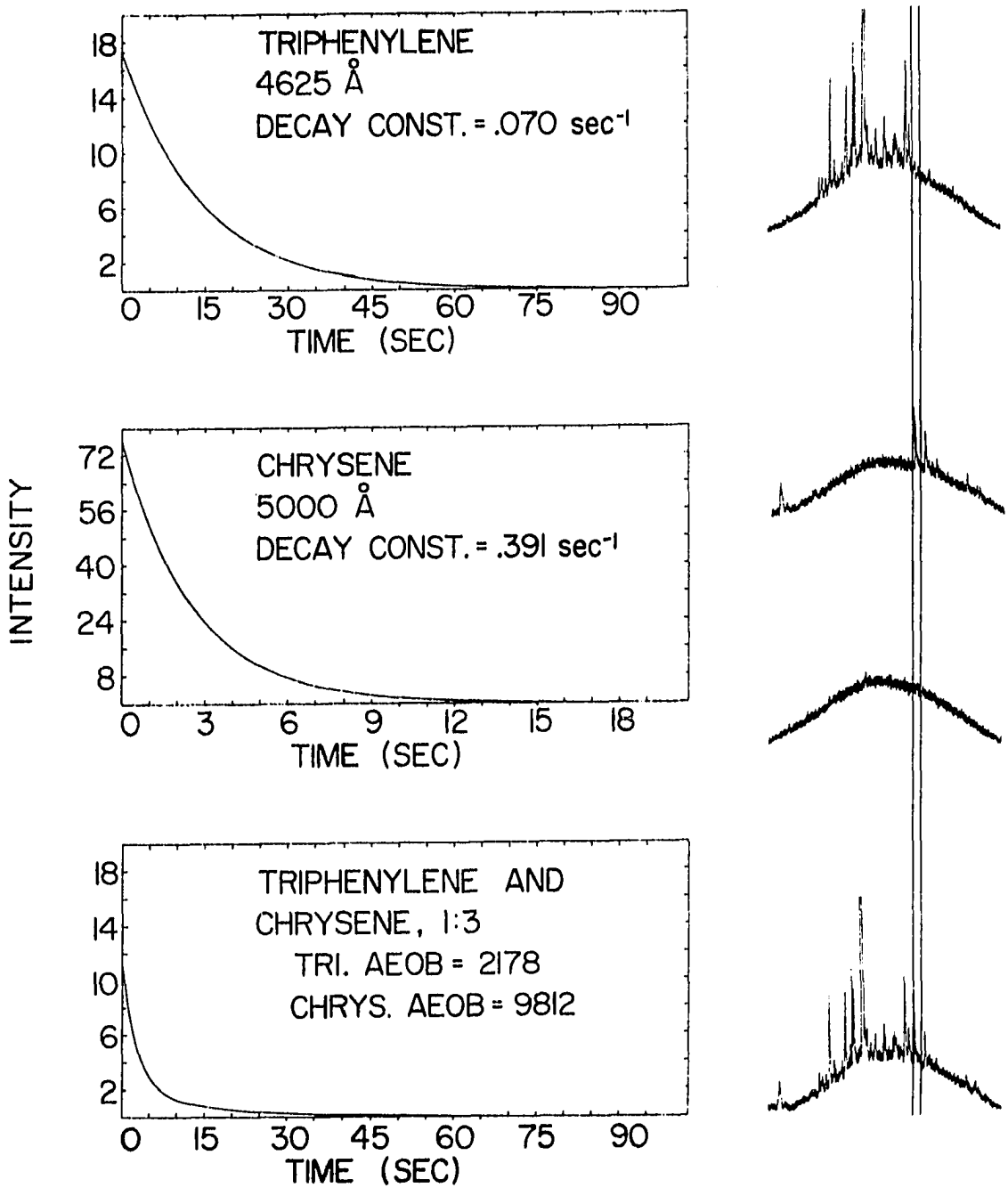

Figure 13. Time resolution of the phosphorescence emission from a mixture of triphenylene and chrysene in n-heptane by use of the pulsed XEOL technique.

To determine the problems encountered in the time resolution of more complex mixtures with the pulsed XEOL system, a five component system which contained triphenylene, coronene, chrysene, phenanthrene and fluoranthene was examined. The five PAHs were selected because their decay constants cover a large range of values with no overlap.

Even though the five components in the mixture share no common emission band and spectral interferences are not severe, a second advantage of time resolved spectroscopy was demonstrated when the five component mixture was time resolved. The individual lines in the emission bands of the PAHs were weak and analytical determinations based on emission of single lines lacked sensitivity. To demonstrate the improved sensitivity of PAH determination by time resolved spectroscopy the monochromator was tuned to zero order and the slits were opened to 1 millimeter. In this way all the light emitted by the sample proceeded through the monochromator unresolved. If the monochromator had not been an integral part of the pulsed XEOL system, only a lens and a mirror would have been used to transmit the optical signal to the photomultiplier tube. With the slits opened to 1 millimeter the optical throughput of the monochromator obviously increased and the sensitivity of the measurement improved. The amount of scattered radiation which reached the detector also increased as the slits were opened, but with

time resolution only radiation which is characterized by a specific decay constant was detected. All other radiation produces a DC background which is removed by a simple subtraction.

Complex decay curves of several dilutions of the mixture were collected with the pulsed XEOL system. Each decay curve was time resolved and the results were normalized. Analytical calibration curves, both linear and logarithmic, for each component in the mixture were plotted and are drawn in Figures 14-18. Several unexpected features were observed for the logarithmic and linear plots of concentration versus intensity.

The first unexpected feature was the nonlinear behavior of the calibration curves. An approximate slope of one half was observed for the log plots, which indicated that the observed intensity was a function of the half power of concentration. Two explanations for the one half slope are possible. First, a half power rate expression could exist as an intermediate step in the kinetic scheme which describes the excitation mechanism. For example, a half power rate expression is observed for some free radical reactions (e.g. the formation of chlorine free radicals from molecular chlorine). Ionized species and free radicals are produced when x-rays interact with matter. The second possibility is based on the scattering of light within the translucent

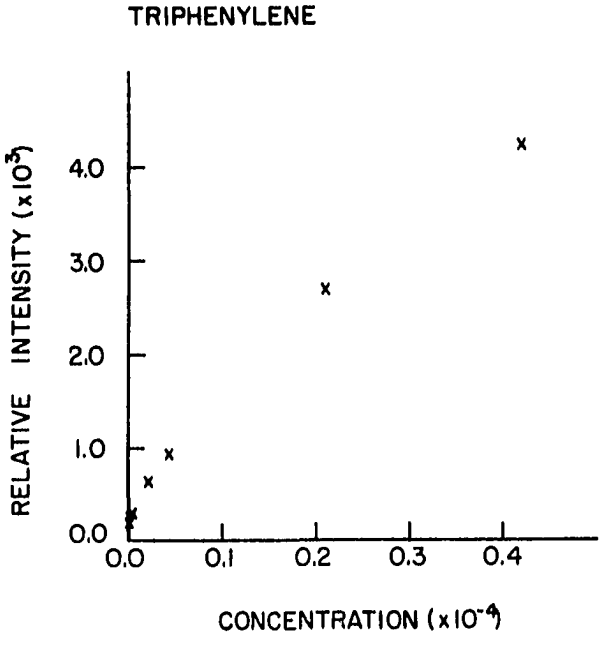

Figure 14a. Linear plot of intensity versus molar concentration for triphenylene.

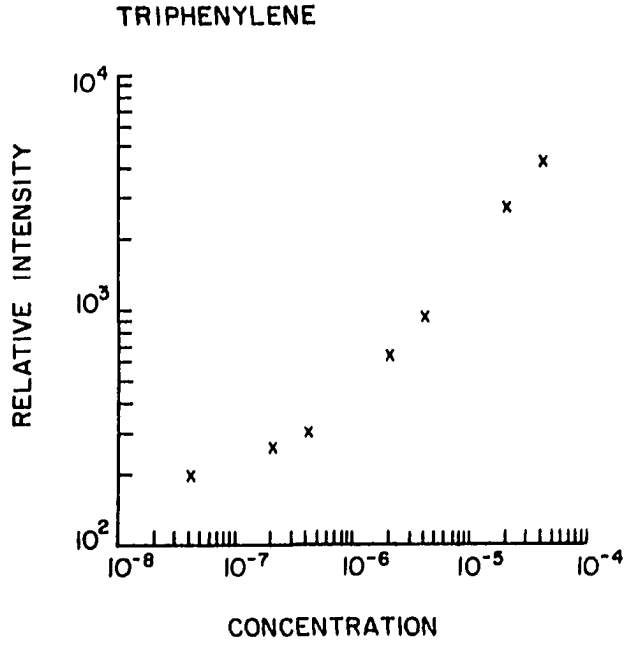

Figure 14b. Logarithmic plot of intensity versus molar concentration for triphenylene.

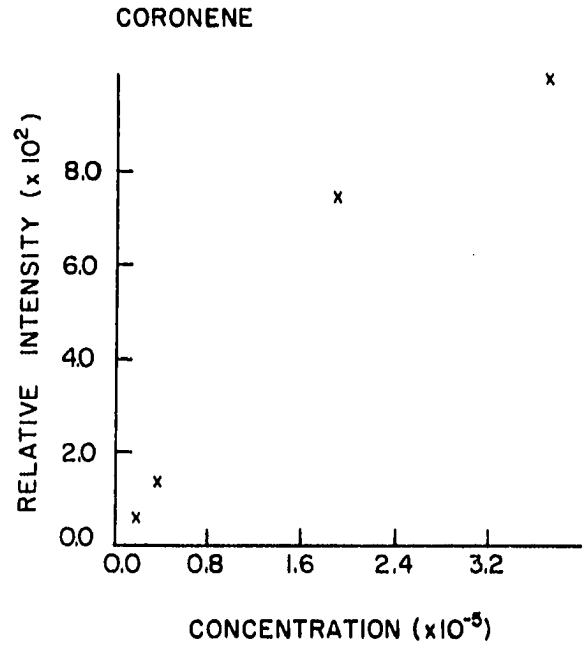

Figure 15a. Linear plot of intensity versus molar concentration for coronene.

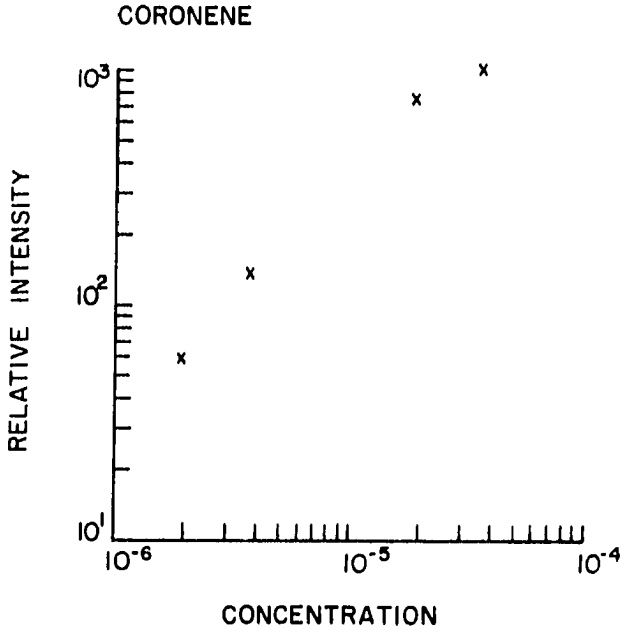

Figure 15b. Logarithmic plot of intensity versus molar concentration for coronene.

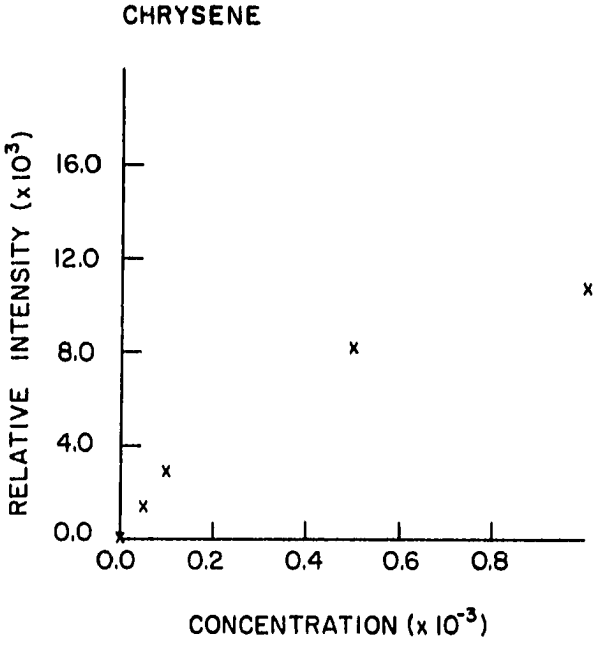

Figure 16a. Linear plot of intensity versus molar concentration for chrysene.

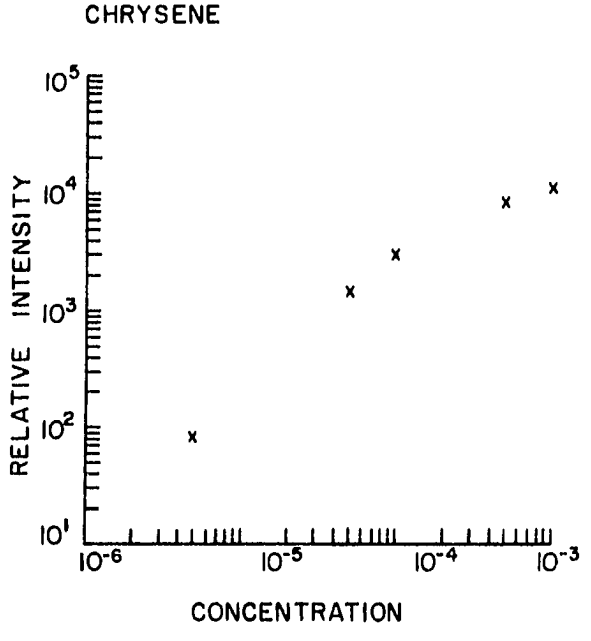

Figure 16b. Logarithmic plot of intensity versus molar concentration for chrysene.

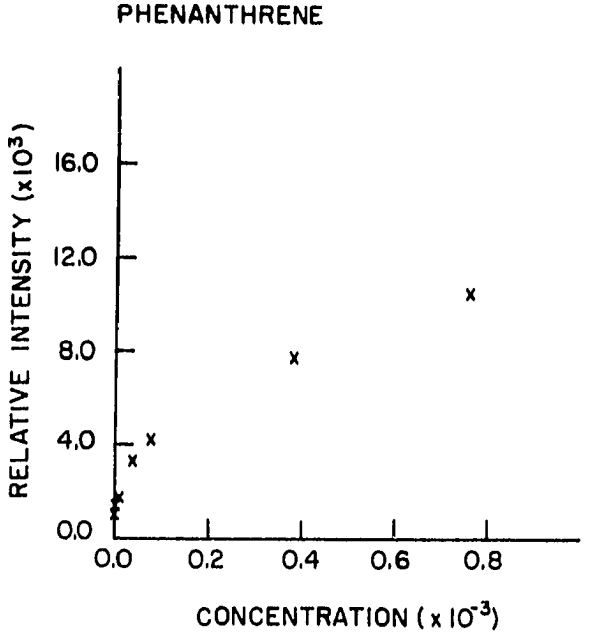

Figure 17a. Linear plot of intensity versus molar concentration for phenanthrene.

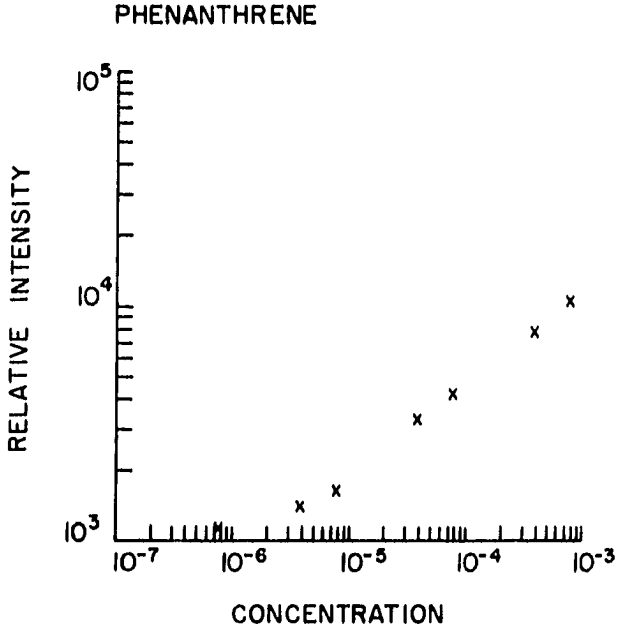

Figure 17b. Logarithmic plot of intensity versus molar concentration for phenanthrene.

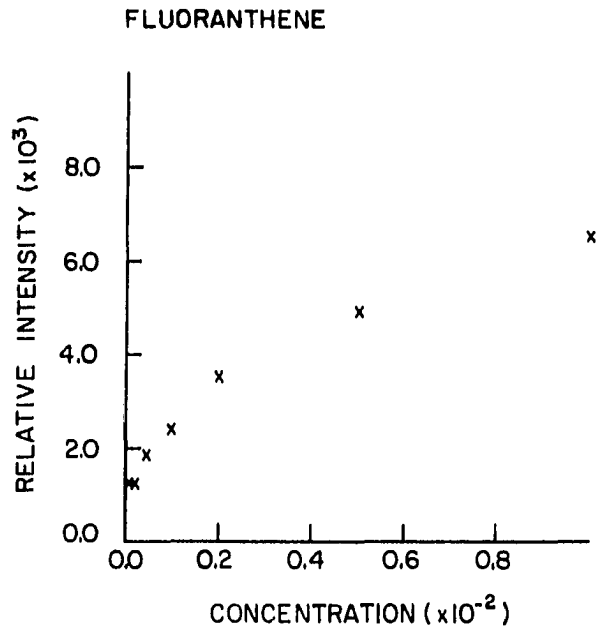

Figure 18a. Linear plot of intensity versus molar concentration for fluoranthene.

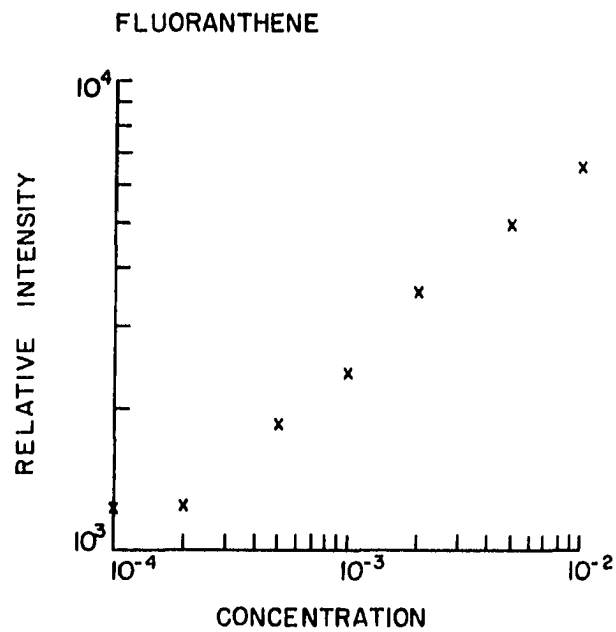

Figure 18b. Logarithmic plot of intensity versus molar concentration for fluoranthene.

sample. The emission of the sample originates from different depths within the sample and not just the sample surface. Formation of a microcrystalline snow when n-alkanes are frozen produced many reflective surfaces within the sample. Internal reflection and optical scattering reduced the probability of detection of a photon which originated in the interior of the sample as compared to a photon which originated on the surface of the sample. The relationship between concentration of luminescent species and the probability of detection of a photon emitted in the n-alkane snow as a function of distance from the surface of the sample must be considered. The functional behavior of the probability of detection as a function of distance from the surface of the sample could be responsible for the observed half power dependence of intensity on concentration. Escape depth considerations are common in many surface techniques and empirical functions have been used to make corrections for probabilities of escape for x-rays, photons and electrons (55). The answer to the question of which interpretation is correct, or if some other factors need to be considered could not be answered in the course of the present investigation.

The second unexpected feature was the flattening of the fluoranthene and triphenylene analytical calibration curves at low concentration. This flattening could be attributed to a background luminescence from the quartz window in the

sample holder characterized by decay constants with values approximately equal to the decay constants for triphenylene and fluoranthene. The background luminescence of the quartz window at 10 K contains two slow components with decay constants 0.068 and 1.160 sec^{-1}. The second component was six times as intense as the first, hence a greater background effect was observed for fluoranthene as compared to triphenylene. The source of the background luminescence is defects and impurities in the quartz which become luminescent centers at low temperatures (56). Above 200 K no background luminescence is observed. Two possible solutions to this problem are considered in the next chapter.

Finally, the analytical calibration curves for coronene and chrysene flattened at high concentration. The observed behavior is not concentration quenching because singlet-triplet absorption is a forbidden process. The exact nature of the effect is not fully understood but energy transfer between luminescent species at high concentration and photochemical decomposition may be contributing to the observed behavior. Elucidation of photochemical processes in n-alkane systems induced by x-ray irradiation will be needed to understand the relationship between the observed intensity and high concentration of PAHs in the n-alkane snow.

To test the applicability of time resolved spectroscopy for analytical problems, three synthetic unknown PAH mixtures

were prepared and analyzed. The analysis was performed in triplicate and the results are tabulated in Table 12. All the values in the table are reported in micrograms. The uncertainties range from a few percent to 20 percent relative. Values for coronene and chrysene are not reported for unknown No. 1 because the amount present was below the detection limit for that particular sample. The phenanthrene value for unknown No. 2 and the chrysene value for unknown No. 3 were low because of peculiarities in SMASH discussed earlier. Although the data in Table 12 are promising, additional development undoubtedly will be required before XEOL-TRS can make a major contribution to the determination of PAHs in complex mixtures.

Table 12. Analytical Data from XEOL-TRS Analysis[1,2]

Compound	Unknown No. 1		Unknown No. 2		Unknown No. 3	
	Actual	Found	Actual	Found	Actual	Found
Triphenylene	0.57	0.64±0.05	2.0	1.9±0.2	5.7	5.7±0.9
Coronene	0.60	-----	3.0	3.0±0.3	6.0	5.4±2
Chrysene	5.7	-----	11	12±2	23	13±1
Phenanthrene	1.6	1.3±0.4	8.9	5.0±0.4	36	34±7
Fluoranthene	100	120±10	200	200±40	400	440±80

[1]All quantities reported in micrograms
[2]Analysis performed in triplicate

Single Component Analysis by Fluorescence

The pseudo-DC mode was used to measure fluorescent emission induced by the greater x-ray flux available from the medical x-ray supply. Wavelength profiles were obtained for 3,4-benzopyrene and perylene in the wavelength region around 427.5 nm. and 453.0 nm., respectively. Analytical calibration curves were plotted from normalized data obtained from the maxima of the wavelength profiles. The analytical calibration curves were used to analyze three synthetic unknowns. The third unknown contained both compounds whereas the other two unknowns contained only a single component. The analysis was performed in triplicate and the results are tabulated in Table 13. All values are reported in micrograms.

Table 13. Fluorescence Data from Pulsed XEOL Analysis[1] [2]

Compound	Unknown No. 1 Actual	Unknown No. 1 Found	Unknown No. 2 Actual	Unknown No. 2 Found	Unknown No. 3 Actual	Unknown No. 3 Found
Perylene	2.5	1.6±0.8	---	-----	12.6	2.9±0.2
3,4-Benzopyrene	---	-----	2.3	2.2±0.6	3.2	2.5±2

[1] All quantities reported in micrograms
[2] Analysis performed in triplicate

The results are disappointing for the mixture and the uncertainties are unacceptable for all three unknowns. The large uncertainties are caused by the inability to

reproducibly peak the monochromator on the maximum intensity wavelength of the emission band and the fluorescent background emitted by the sample holder. Location of the maximun intensity wavelength of the emission band was a long tedious process with the pseudo-DC excitation source as compared to the standard DC excitation source and an alternate approach was sought. Suggestions for the correction of these problems are discussed in the next chapter. The analysis of the mixture is further complicated by the suppression of 3,4-benzopyrene emission by perylene. Interferences of the type observed for unknown No. 3 are expected when fluorescence analysis is performed with PAHs because energy transfer processes play a major role in the excitation and deexcitation mechanisms of many PAH systems. After appropriate system improvements the XEOL technique could be applied to the fluorescent analysis of single component PAH systems. However, single component PAH analysis is not practical because PAHs occur in complex mixtures. Therefore, the use of internal reference compounds, prior isolation of PAHs by ring size and alkyl substitution or other innovative analytical approaches will be required before XEOL can be applied to the fluorescent analysis of PAHs.

Discussions and Conclusions

The results reported in this chapter demonstrate the feasibility of the XEOL-TRS technique for the analysis of simple mixtures of phosphorescent PAHs. The technique could obviously be applied to other organic phosphorescent systems. The present study is the first application of XEOL to organic systems and many basic principles were established. The use of low temperatures and unconventional geometries are two examples. Techniques for the determination of decay constants were developed. As the scope expands to other organic systems, Fourier techniques and phase resolution will be required to measure shorter decay constants. The examination of fluorescence produced with a high power x-ray pulse demonstrated the flexibility of the pulsed XEOL system to study fluorescence and phosphorescence. The combination of XEOL with conventional pulsed fluorescence techniques will expand the scope of the XEOL method. Finally, the temperature flexibility, supplied by the helium refrigerator employed in the pulsed XEOL system, makes possible the study of a wide range of solids, liquids and gases.

XEOL coupled with time resolved spectroscopy does not solve all the problems of PAH analysis. The technique in the present state of development does not compete with gas or liquid chromatography, GC-MS or conventional fluorescence techniques. The improvements discussed in the next chapter if

implemented should improve the capabilities of the pulsed XEOL system. However, the true potential of the method as applied to PAH analysis will not be appreciated fully until a nanosecond width x-ray pulse is used for excitation. A synchrotron produces an intense x-ray pulse of nanosecond width which would eliminate the limitations imposed on the present study by the pulse characteristics. As time and space become available on national synchrotron facilities a proposal, based on the work presented here, should be prepared. The improved sensitivity and more general applicability of time resolved fluorescence as opposed to time resolved phosphorescence should be stressed. Interferences (e.g. the suppression of 3,4-benzopyrene emission by perylene) could be characterized by the pulsed XEOL system in the pseudo-DC mode prior to the synchrotron study. Even with ideal x-ray excitation sources and unlimited computational facilities the XEOL technique would not be the ultimate method for the analysis of PAH mixtures. The PAH problem is complex and many analytical techniques will be required to characterize natural and man made mixtures of PAHs.

CHAPTER 6: MISCELLANEOUS OBSERVATIONS AND FUTURE WORK

The work reported earlier (13,45), combined with the results presented in this dissertation, is the first application of XEOL to an organic system. Furthermore, the use of a pulsed x-ray excitation source is a novel approach to XEOL. These two facts suggest the scope of application for XEOL coupled with conventional luminescent methods is very broad and requires additional investigation.

Before new applications of XEOL are considered, modifications of the pulsed XEOL system are described in the following section. Implementation of the modifications would eliminate many of the problems encountered in the PAH study. In the next section the effects of solvent composition are discussed and suggestions are presented for the enhancement of the sensitivity of the PAH analysis by XEOL. Finally, XEOL results obtained from novel systems are presented in the last section and new applications of XEOL to analytical problems are indicated.

Pulsed XEOL System Modifications

The major problem encountered in the analysis of PAHs with the pulsed XEOL system was the background luminescence emitted by the quartz window in the sample holder. To correct the problem, the quartz window can be replaced by a window composed of a different material or removed completely.

Several window materials were tested to eliminate the background luminescence but no suitable substitute was found. Single crystal quartz was not available when the other materials were tested. A sample of single crystal quartz should be obtained and tested as a substitute window material.

An alternate approach to eliminate the background luminescence from the quartz window in the sample holder involved deposition of the sample on a cold beryllium disk from a flowing gas stream. A doughnut-shaped manifold with twelve directional ports was designed. At the present time deposition techniques are being developed. The major problems that need to be solved are improved vacuum control, measurement and control of sample deposition and efficient vaporization and transport methods for the PAH material. After the problems are solved, many interesting experiments are possible, in particular, x-ray generation of reactive species and photochemical reactions. The deposition of gaseous samples on a cold surface opens the realm of matrix isolation to study by the XEOL technique.

Another problem, encountered in the fluorescence study, was the inability to reproducibly position the monochromator at a specific wavelength. Mechanical play in the wavelength counter and large temperature variations in the laboratory contributed to the problem. To correct the difficulty

software should be developed to calculate a polynomial fit from discrete data points which characterize the profile of the emission band. A numerical differentiation of the polynomial produces the derivative of the emission band shape. The wavelength of maximum intensity is equal to one of the roots of the polynomial expression which represents the derivative set equal to zero. The maximum intensity is calculated by substitution of the wavelength of maximum intensity into the original polynomial. These numerical methods eliminate the need to position the monochromator reproducibly because only the relative positions of the data points with respect to one another are required. The relative positions can be accurately determined by use of a computer-controlled stepper motor to position the monochromator at the discrete wavelengths in the profile of the emission band. The software and interface needed to operate a stepper motor by computer control were developed by D. Kalnicky (57) and are available in the laboratory. A stepper motor should be purchased and mounted on the monochromator and modifications of software for use of the stepper motor should be started.

In addition to the modifications described in the preceding paragraphs, optimization of the x-ray pulse characteristics is imperative. The trade offs between voltage, current, and pulse duration of the x-ray pulse

should be studied. Figures 19-21 are plots of intensity versus current, voltage and pulse duration. A factor of two increase in current or pulse duration doubles the measured intensity but an approximate fifty percent increase in voltage produces an equivalent enhancement. Optimization of PAH analysis with respect to the three pulse parameters, within the limits determined by the energy the x-ray tube must dissipate as heat, should enhance the sensitivity and lower the detection limits of the XEOL technique.

Solvent Composition

The host matrix or solvent composition for an organic system, e.g. PAHs in n-alkane solvents, is an important factor in all XEOL experiments. The host matrix has to interact with the primary x-ray radiation and support energy transfer processes which excite the guest species. Very few host matrices exhibit XEOL emission from guest species. A better understanding of the excitation processes in those matrices which exhibit XEOL emission should be developed in the near future. The results of a study of the excitation mechanism for PAHs in n-alkanes in particular, will assist in the prediction of new organic systems which will exhibit XEOL emission. The importance of solvent composition for the PAH study is demonstrated by two probing experiments.

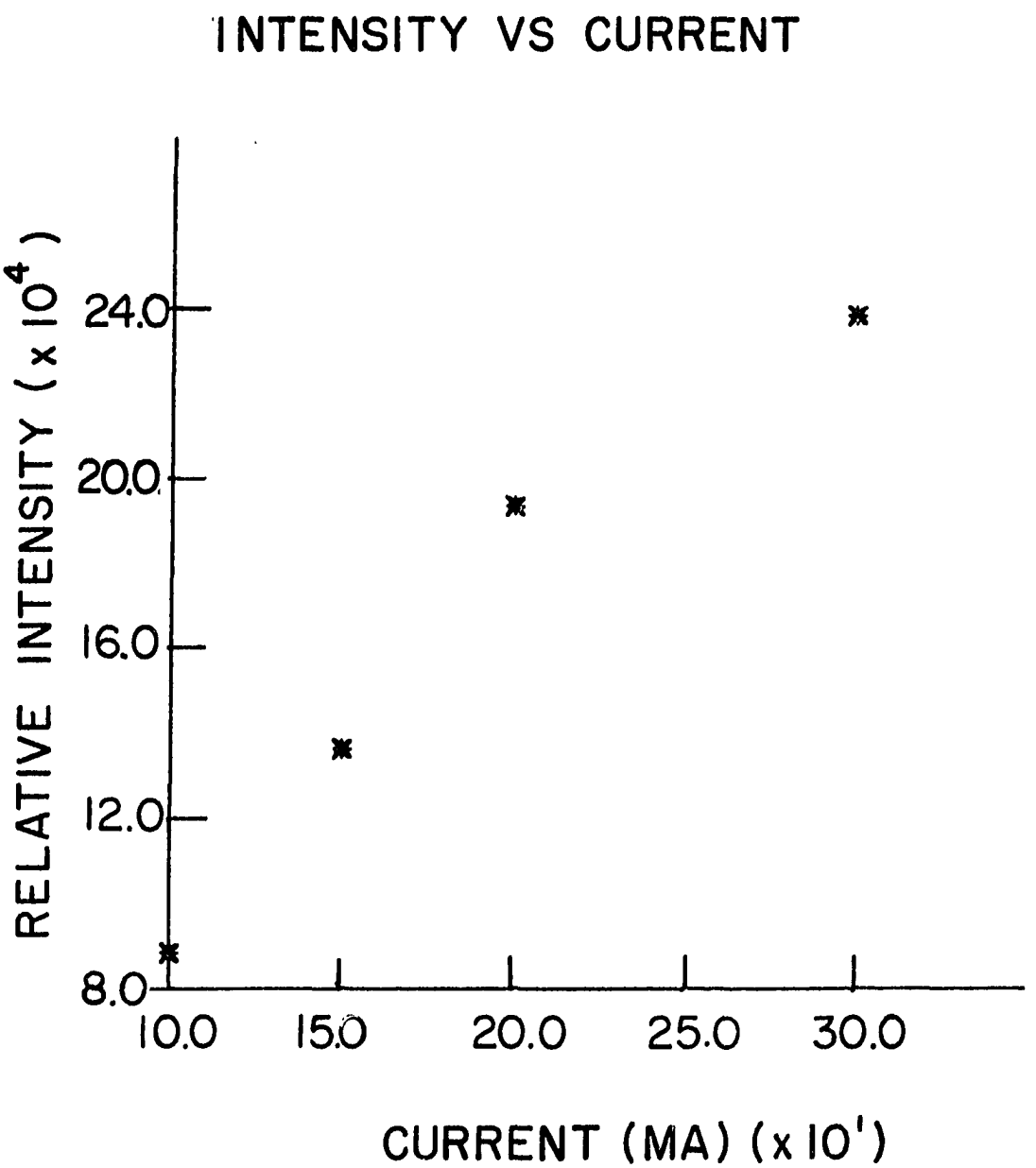

Figure 19. Measured intensity as a function of the current of the electron beam used to produce the x-ray pulse.

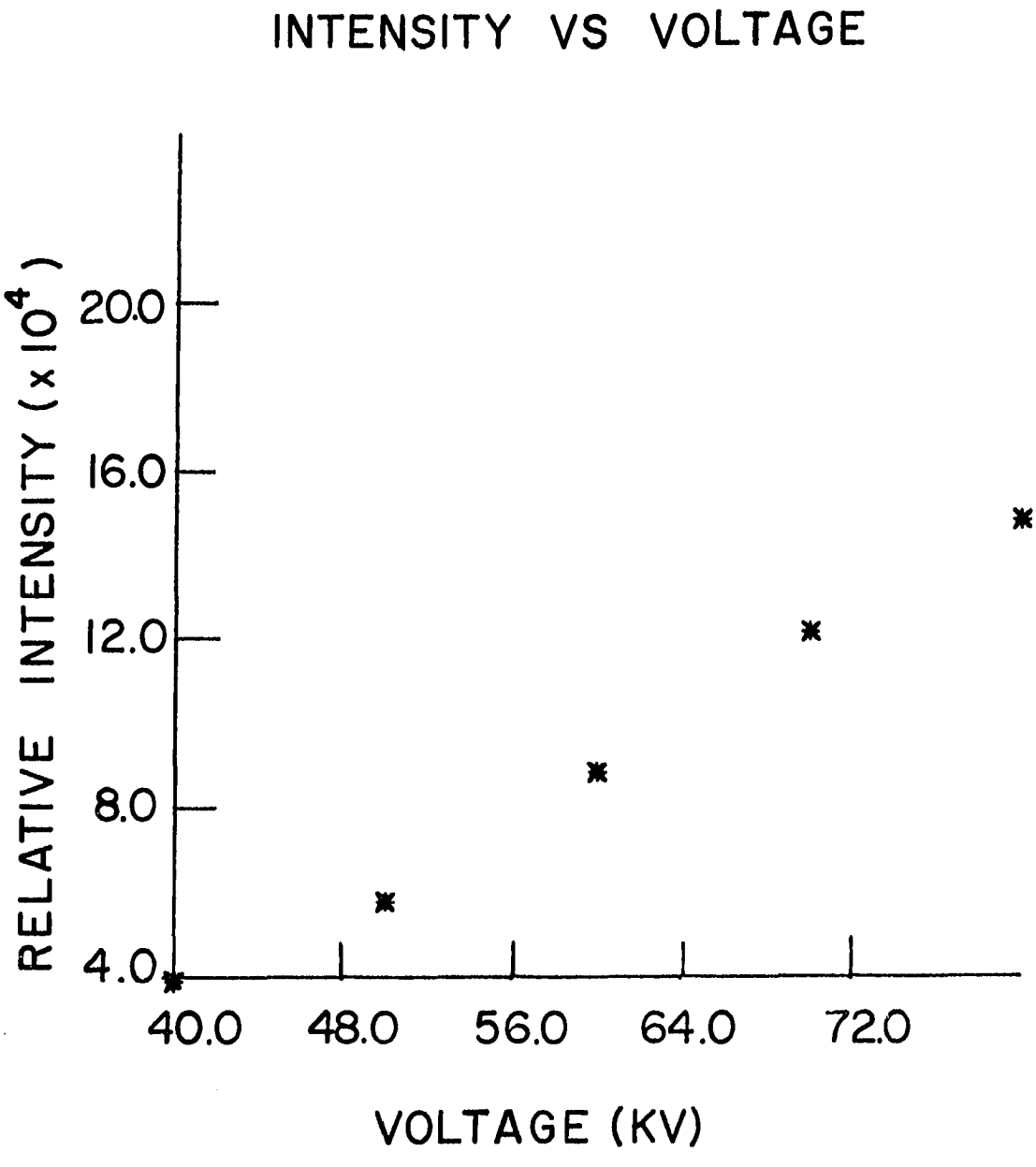

Figure 20. Measured intensity as a function of the acceleration voltage experienced by the electron beam used to produce the x-ray pulse.

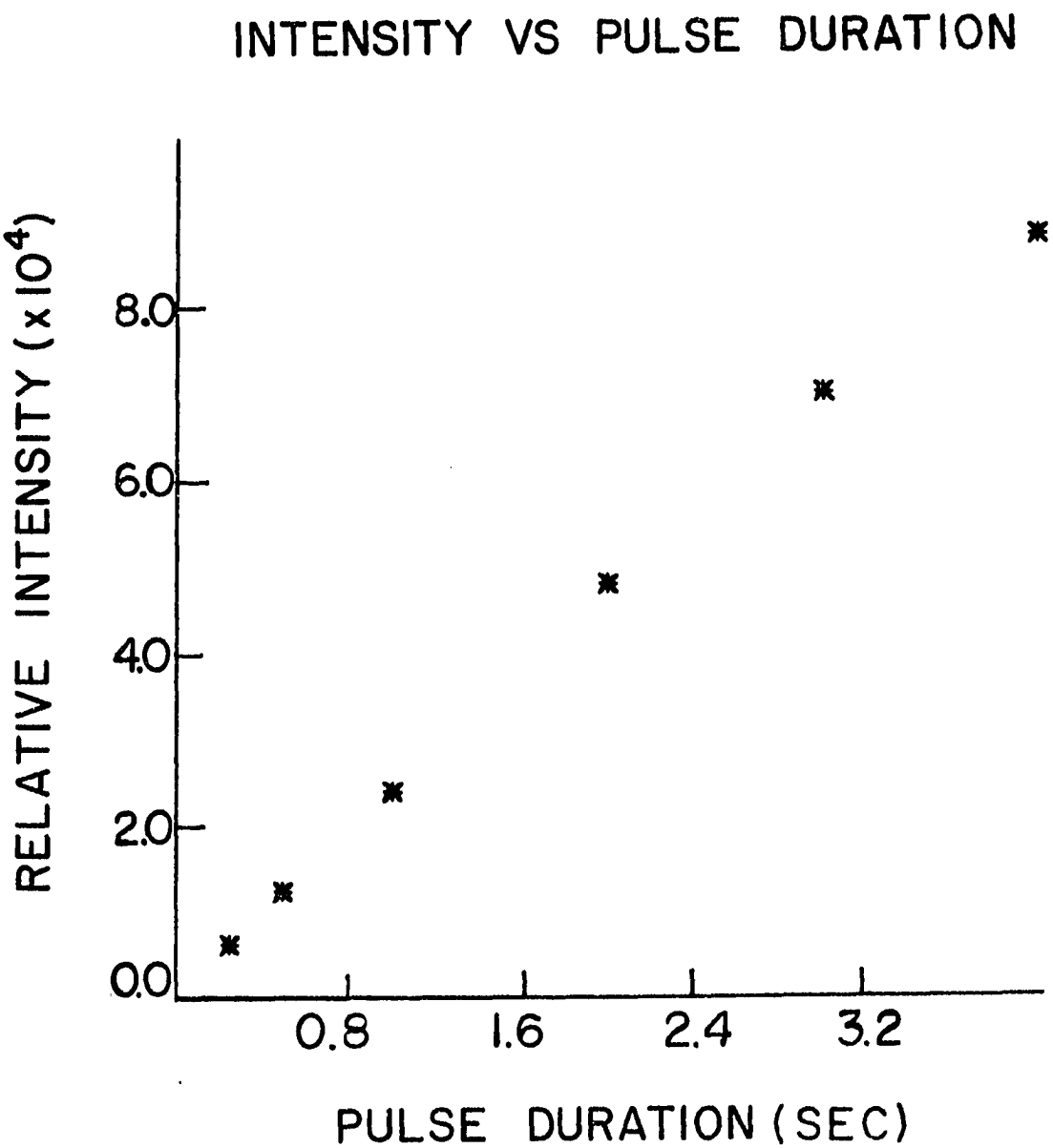

Figure 21. Measured intensity as a function of the duration of the x-ray pulse.

The first experiment examined the effect of n-alkane chain length on the structure of the XEOL spectrum. Anthracene and 3,4-benzopyrene were examined in n-hexane, n-heptane and n-octane. The three anthracene spectra are presented in Figures 22-24. The emission band for anthracene in n-hexane is broad and structureless whereas in n-heptane several sharp lines are observed and in n-octane a weak band is observed. A different effect is observed for 3,4-benzopyrene as shown in Figures 25-27. The structure of the emission sharpens and the intensity increases as the chain length increases. Similar solvent effects are observed for all the PAHs studied. These solvent effects and others previously observed for UV excitation of n-alkane-PAH systems (35,58-61) need to be investigated so that the analysis of PAHs by the XEOL technique can be optimized.

A second probing experiment on solvent composition involved the introduction of a heavy atom to the n-alkane-PAH system by addition of iodobutane or tetra-n-butyllead to the solvent. Addition of a heavy atom to the solvent induces the external heavy atom effect in PAH systems (62-64). The increase of the spin-orbit coupling of excited singlet and triplet states results in an increase in the rate of intersystem crossing between singlet and triplet states and thus enhanced phosphorescence emission. Analytical applications of the external heavy atom effect in UV excited,

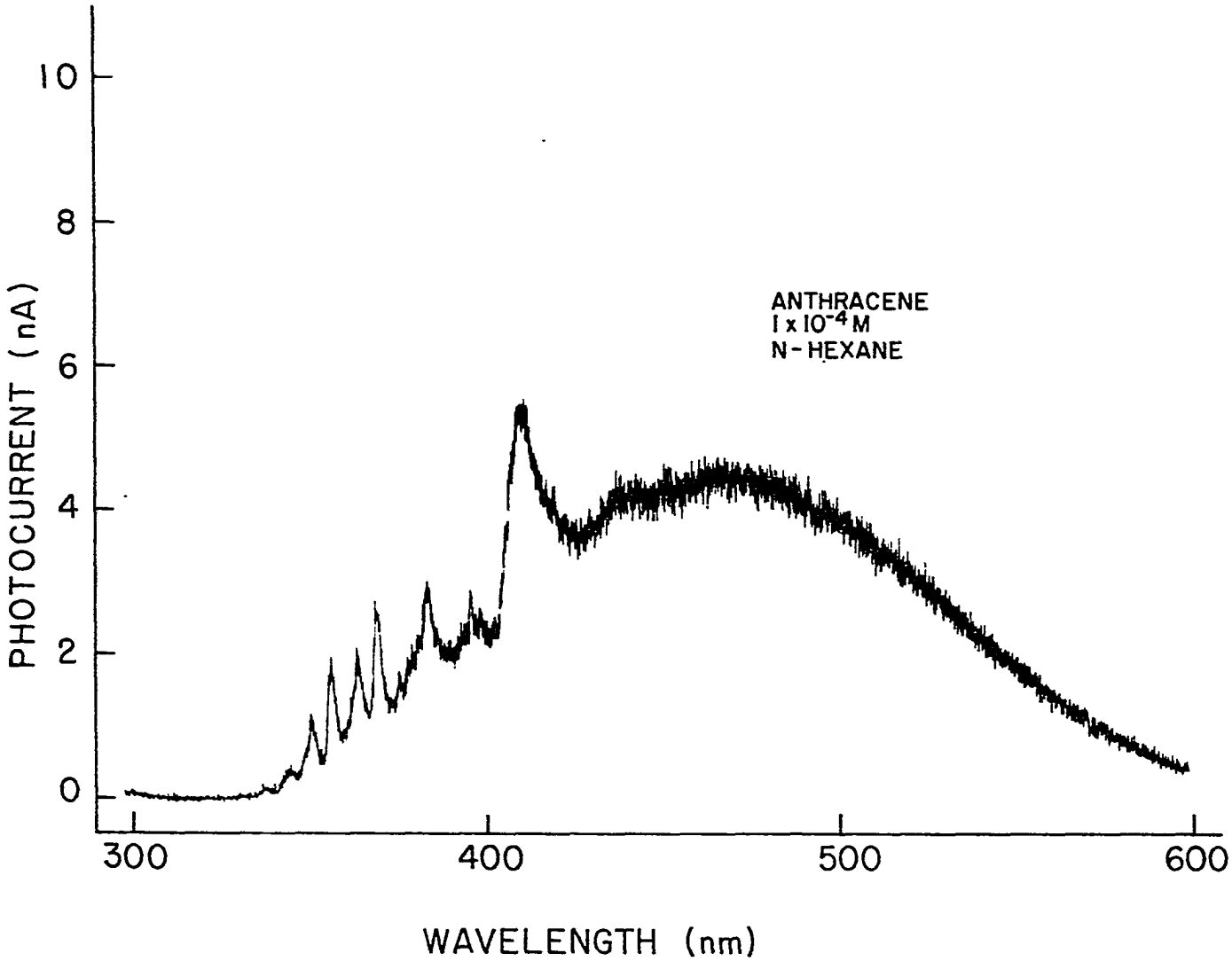

Figure 22. XECL spectrum of anthracene in n-hexane at a concentration of 1 X 10^{-4} M.

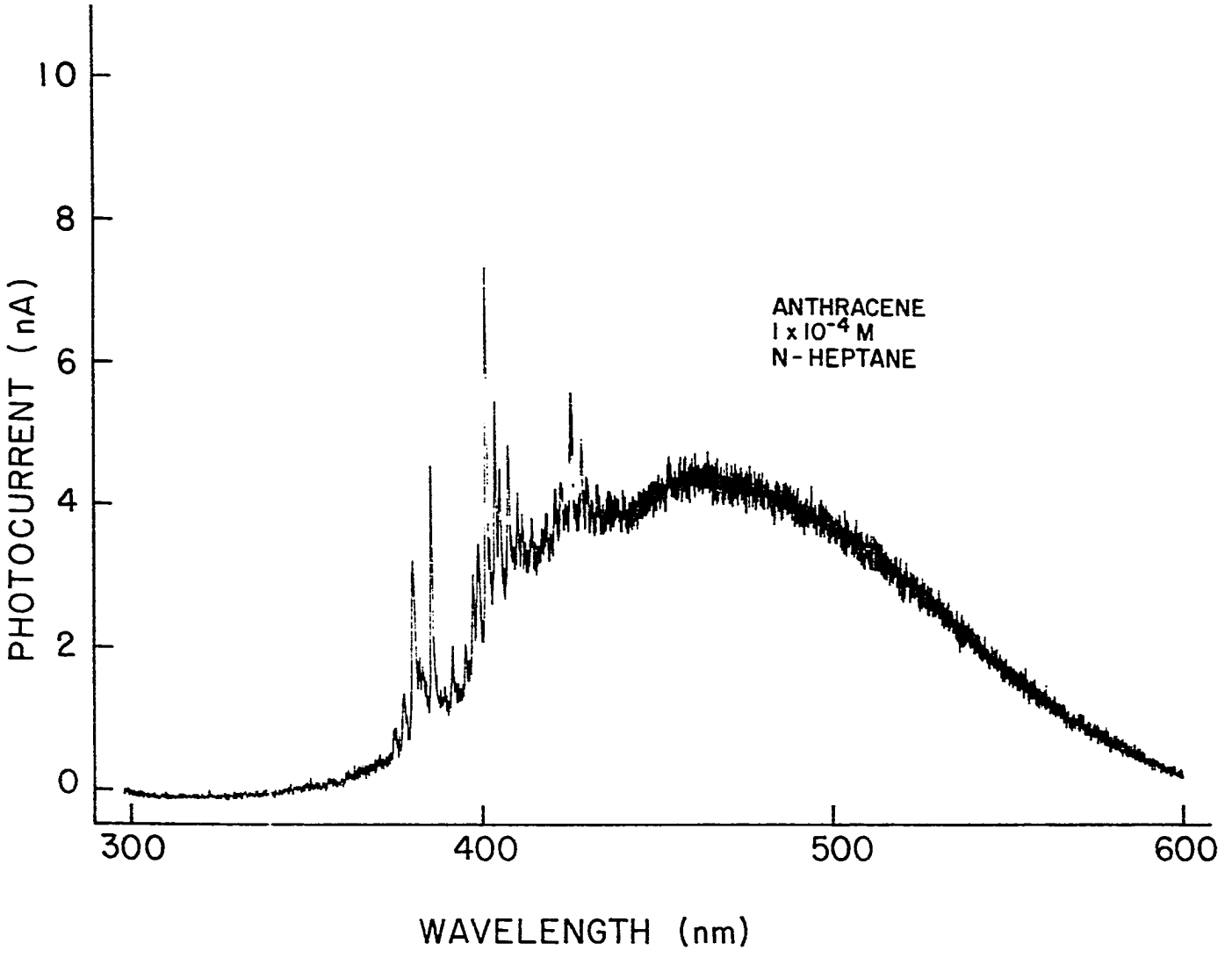

Figure 23. XECL spectrum of anthracene in n-heptane at a concentration of 1 X 10⁻⁴ M.

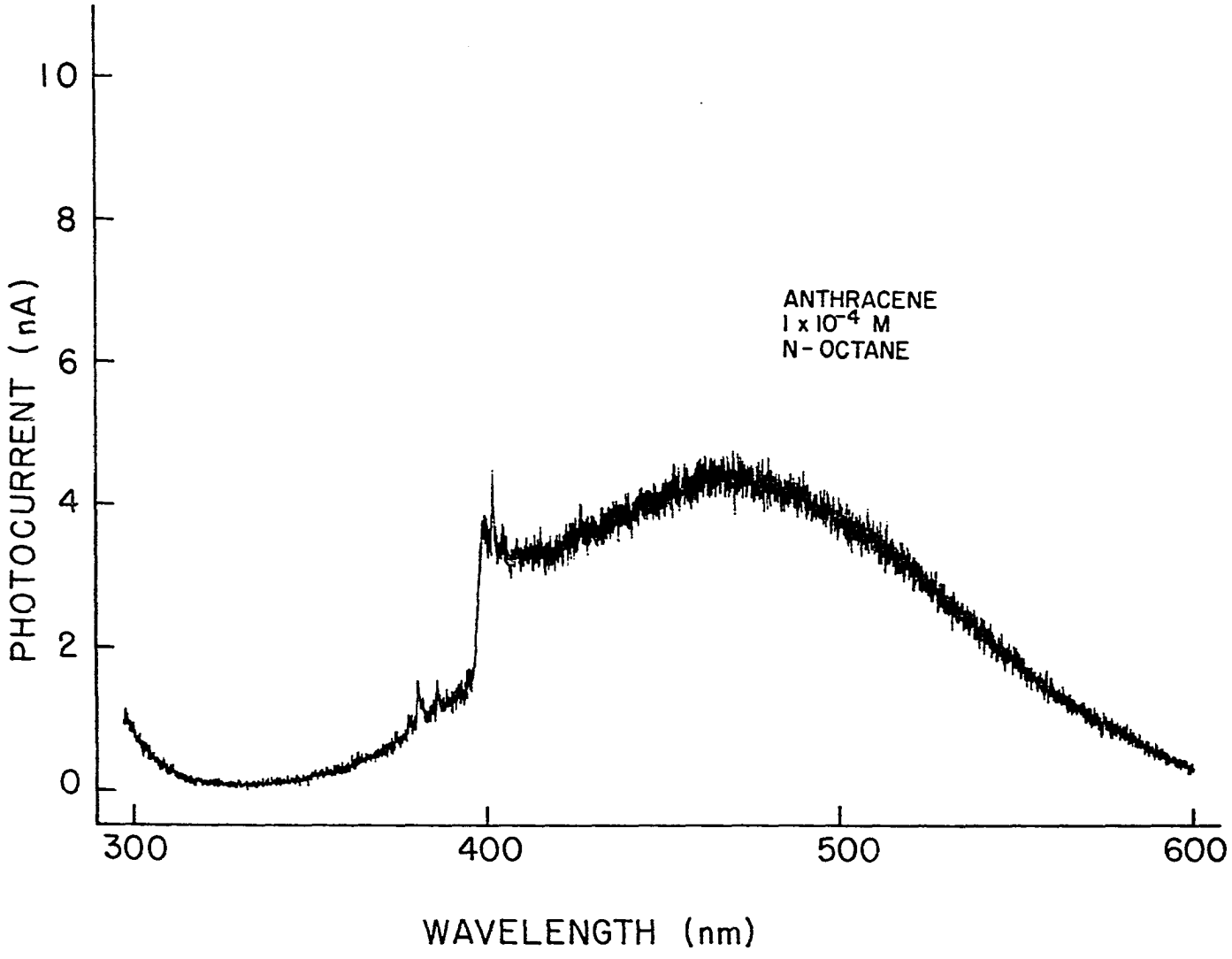

Figure 24. XECL spectrum of anthracene in n-octane at a concentration of 1 X 10^{-4} M.

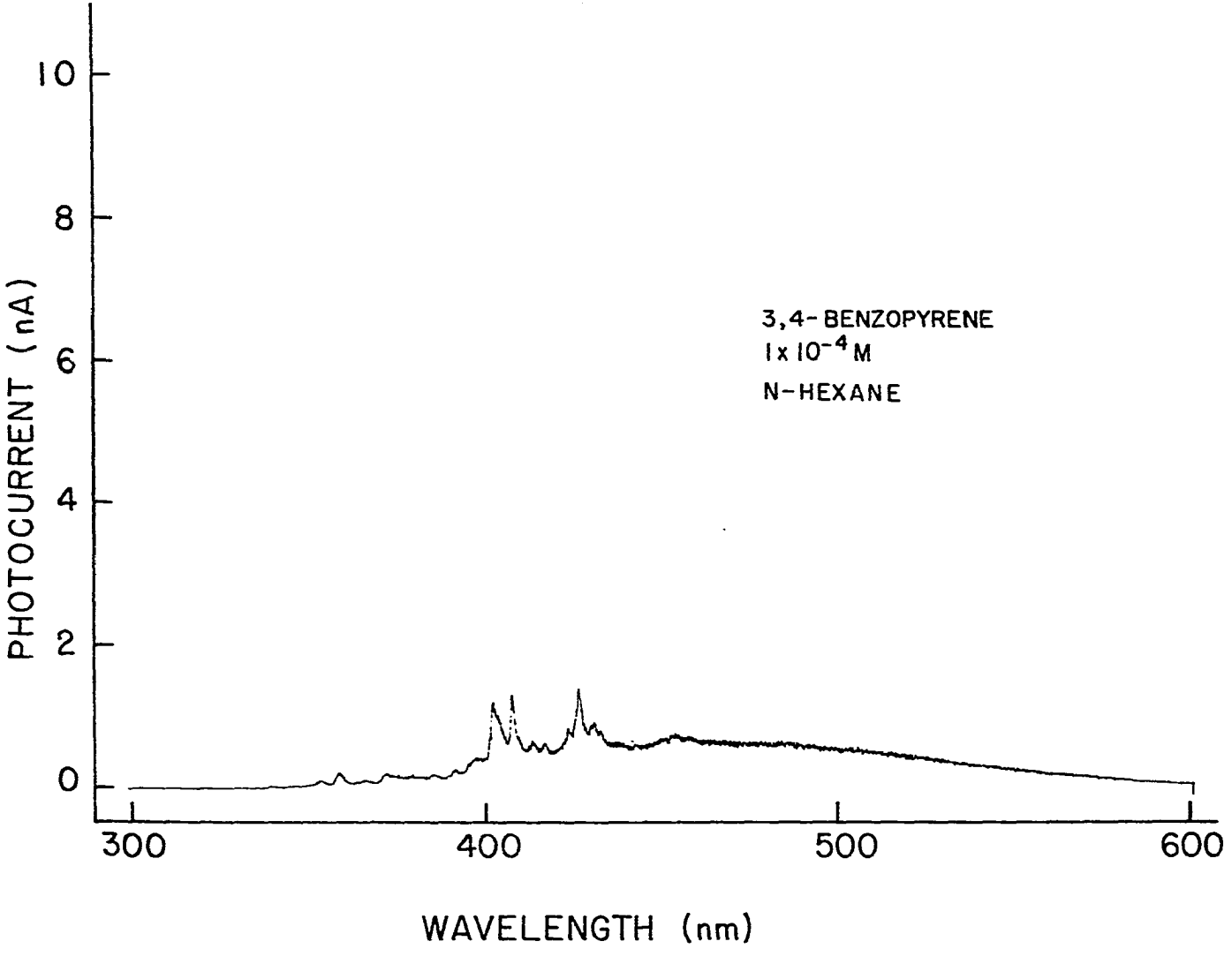

Figure 25. XECL spectrum of 3,4-benzopyrene in n-hexane at a concentration of 1 X 10^{-4} M.

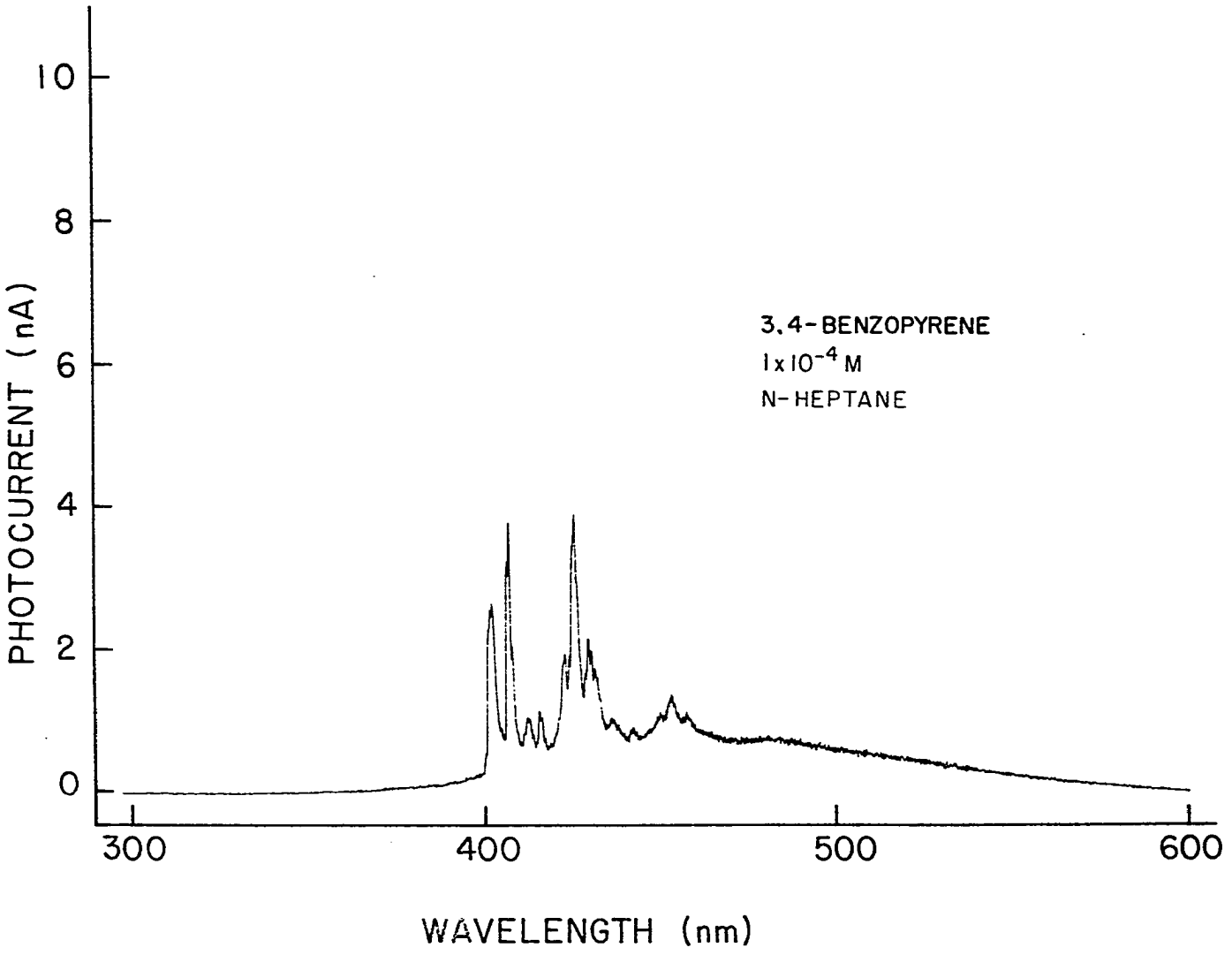

Figure 26. XECL spectrum of 3,4-benzopyrene in n-heptane at a concentration of 1 X 10-4 M.

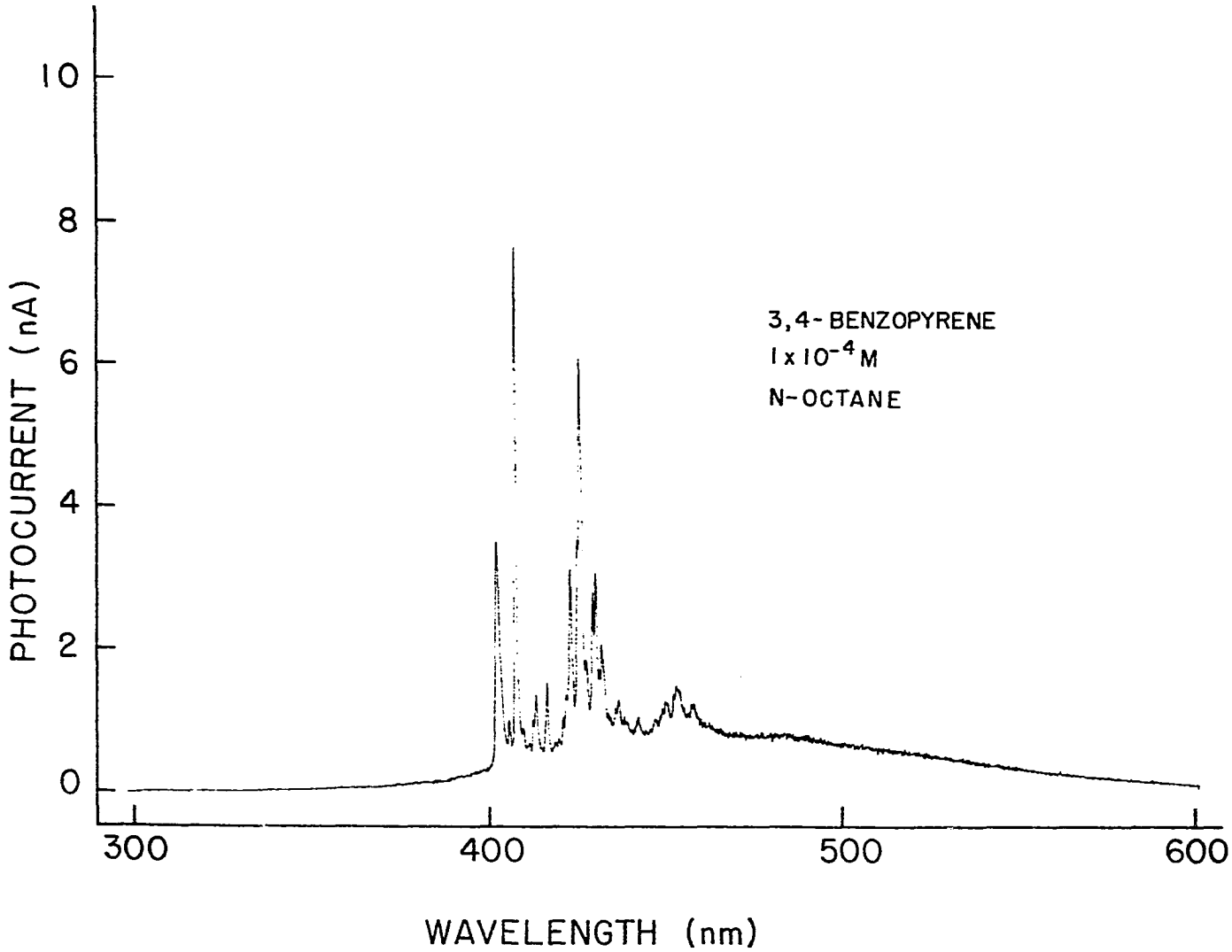

Figure 27. XECL spectrum of 3,4-benzopyrene in n-octane at a concentration of 1 X 10^{-4} M.

PAH systems are numerous (65-67). Furthermore, the x-ray capture cross section of an atom increases with atomic number (47). Therefore, the addition of a heavy atom to the solvent results in a host with a large x-ray capture cross section and a second enhancement of the luminescence emission should result with the XEOL technique. The heavy atom host captures more x-ray photons than a hydrocarbon host and the energy of the x-ray beam is more efficiently converted to electronic excitation energy for the PAH guest molecules.

No effect was observed for iodobutane but an enhancement was observed for tetra-n-butyllead. Table 14 summarizes the effect of tetra-n-butyllead on five PAHs at a concentration of 10 microliters of tetra-n-butyllead per 1 milliliter of n-heptane. The results indicate improved detection limits could be achieved with the addition of a heavy atom to the solvent. Future experiments should be scheduled to study the effect of heavy atom concentration on the signal and decay constant of the analyte. Also, the optimum concentration of heavy atom and the optimum heavy atom need to be determined.

Other Systems Amenable to Study by XEOL

An obvious application of the XEOL study of PAHs is the characterization of fuel oils by the PAH fraction as described by the U. S. Coast Guard (68). Fuel oil samples were collected and XEOL spectra were obtained. The initial

Table 14. External Heavy Atom Effect on PAH Emission

Compound	Conc.	Signal Without Heavy Atom	Signal With Heavy Atom	Percent Increase
Fluoranthene	$1X10^{-2}M$	8642	76050	780%
Chrysene	$1X10^{-3}M$	13019	21060	62%
Phenanthrene	$1X10^{-3}M$	31484	47200	50%
Triphenylene	$1X10^{-3}M$	88157	123700	40%
Coronene	$1X10^{-4}M$	8454	9360	11%

results were not competitive with the U. S. Coast Guard results, hence the fuel oil samples are being stored until the instrumental modifications have been completed. After the modifications are tested, the fuel oil samples will be characterized by XEOL spectra and complex decay curves. Characterization of fuel oils by complex decay curves will be one more method of identification necessary to fingerprint fuel oil spills and stock supplies of fuel oils.

XEOL emission from the final system considered was discovered by accident. The first experiments performed with the gas manifold involved the co-deposition of argon and PAHs on the beryllium disc to take advantage of the large x-ray capture cross section of argon as compared to carbon and hydrogen. A routine examination of a "pure" argon deposit revealed a complex spectrum, as shown in Figure 28. The many lines and bands are characteristic of nitrogen, oxygen and other gaseous impurities in argon. Possible analytical applications for the determination of these gases in argon

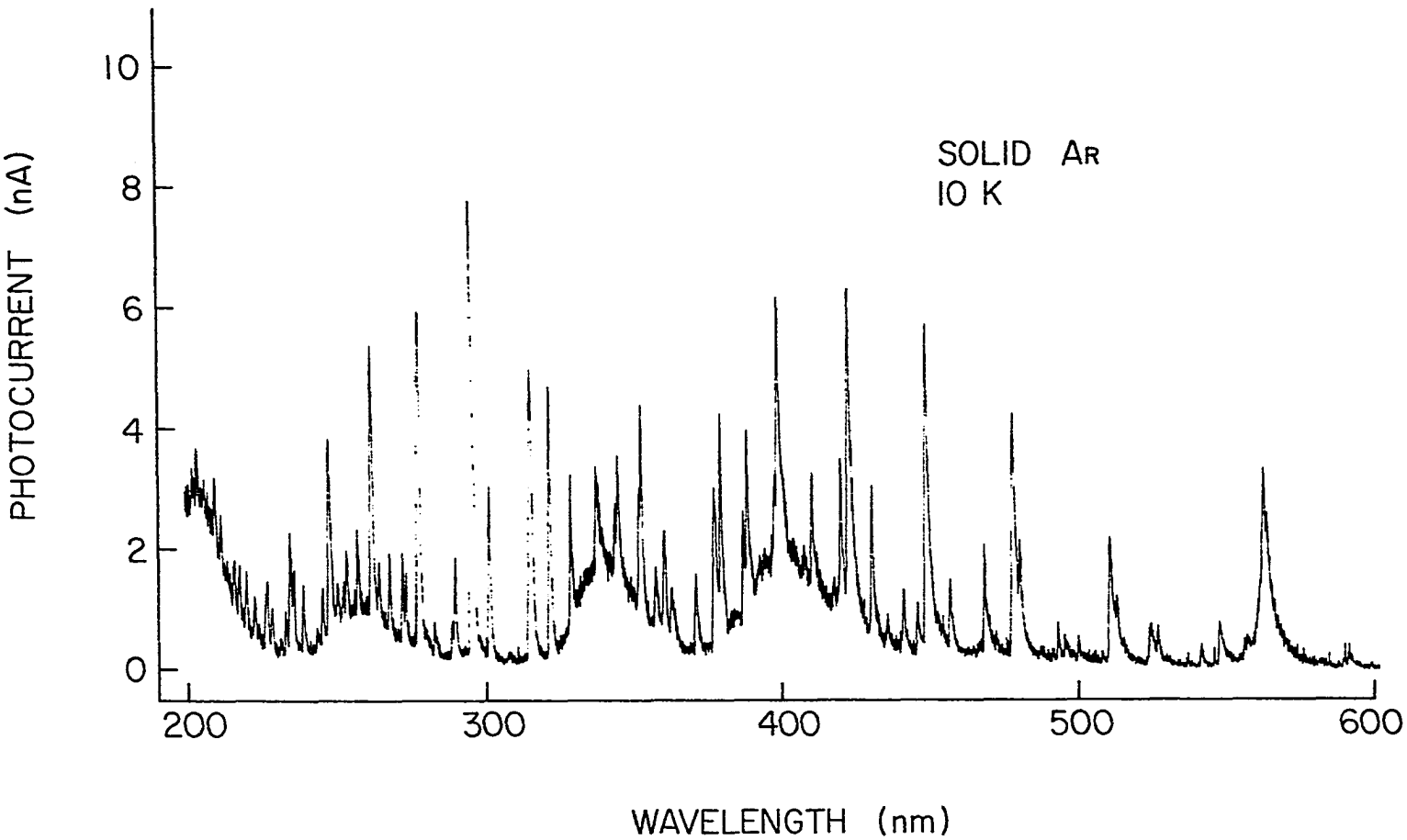

Figure 28. XECL spectrum of solid argon deposited on a beryllium window at 10 K from a flowing gas stream.

should be investigated.

In Figures 29 and 30 the spectra of krypton and xenon are shown. The broad bands in the short wavelength region suggest that these materials may be better suited as hosts for PAHs and other luminescent organic molecules. This possibility is being investigated. The origins of the other lines in the two spectra are unknown but trace gaseous impurities are the most likely sources.

The combination of rare gases and hydrocarbons, both aliphatic and aromatic, opens many avenues of research for the XEOL technique in the pulsed and DC modes. The many matrices with varying degrees of heavy atom concentration, structural peculiarities and x-ray capture cross sections should supply ideal XEOL environments for many different types of organic analytes.

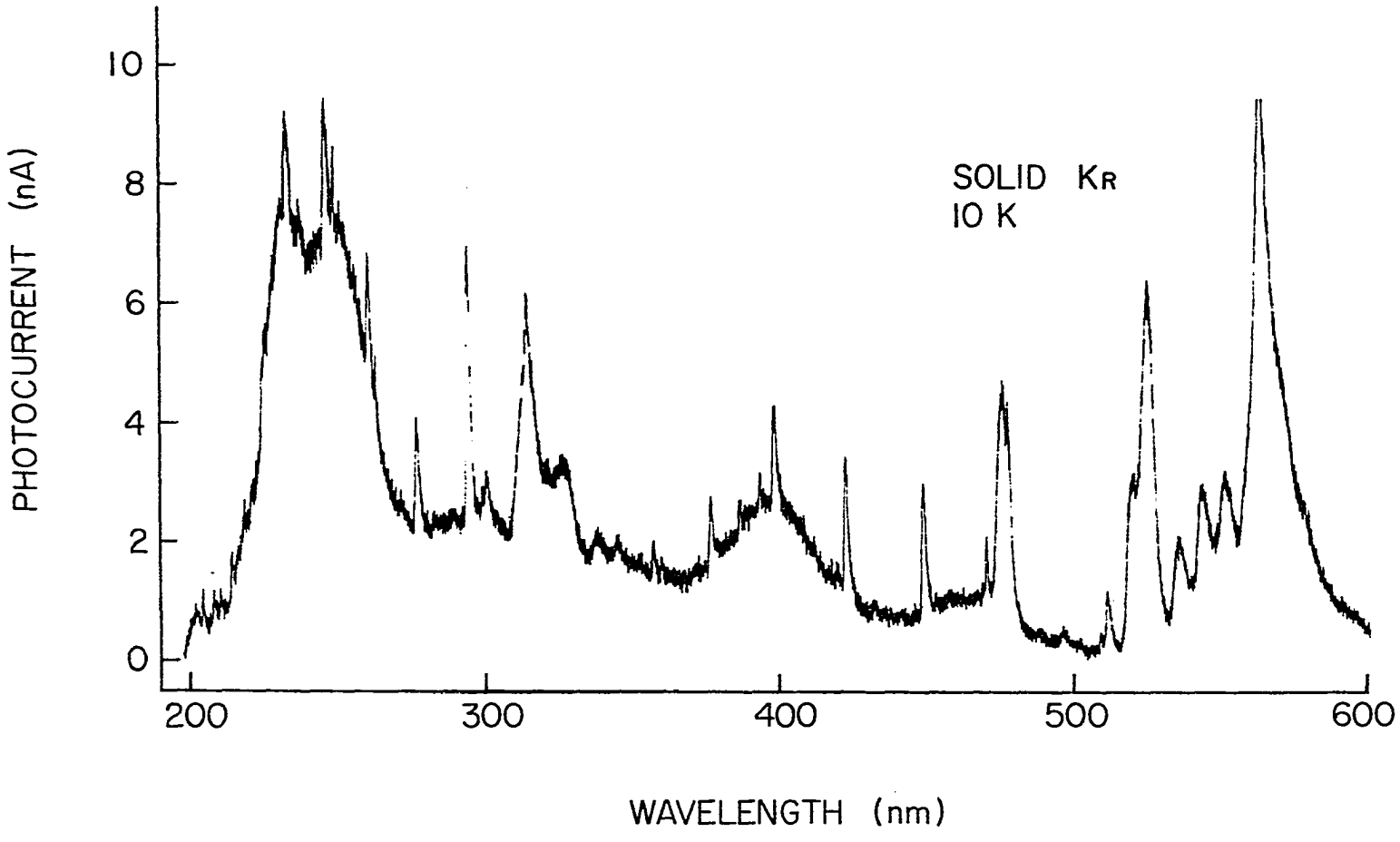

Figure 29. XECL spectrum of solid krypton deposited on a beryllium window at 10 K from a flowing gas stream.

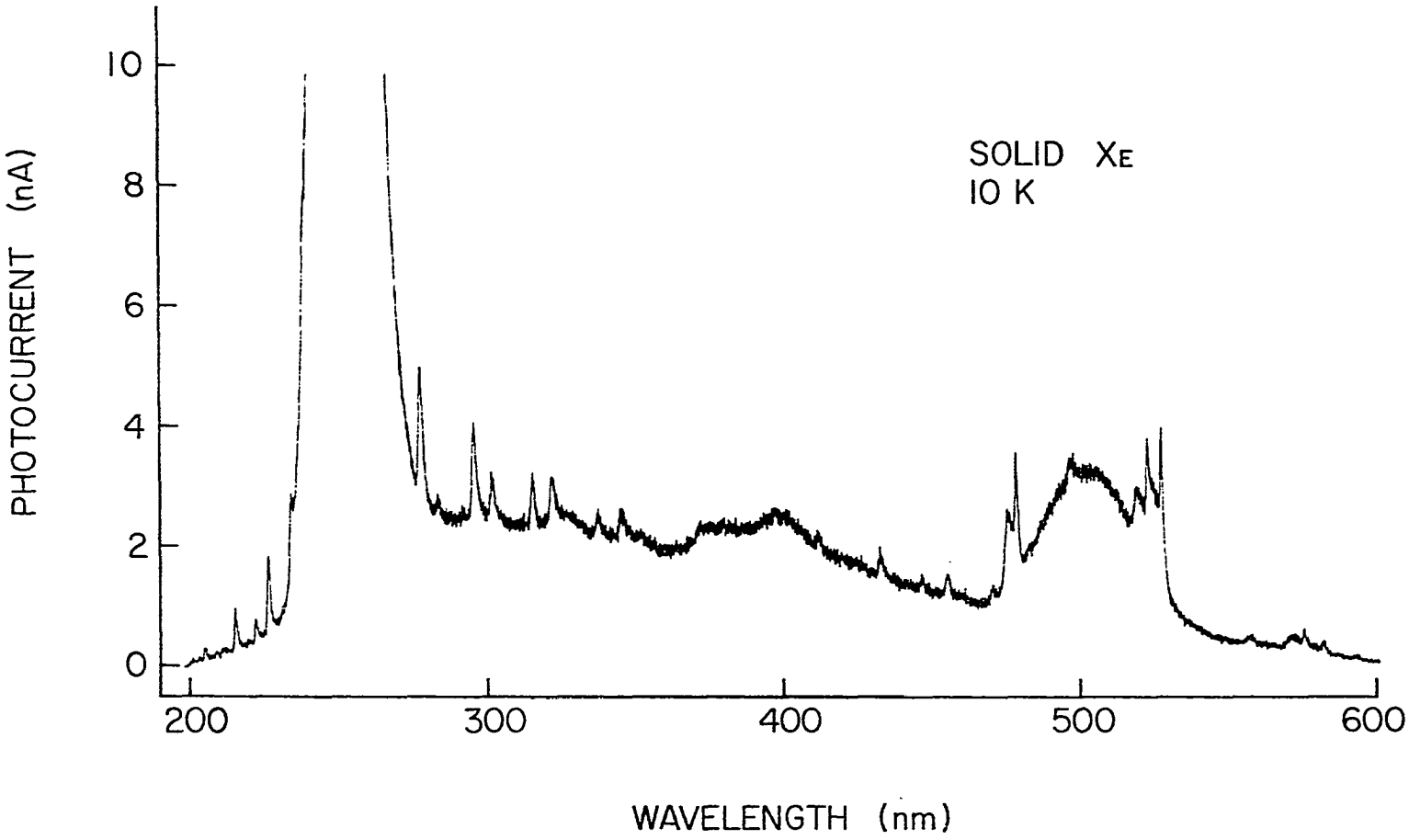

Figure 30. XECL spectrum of solid xenon deposited on a beryllium window at 10 K from a flowing gas stream.

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APPENDIX 1: TRS3

TRS3 is the PL/1 program which reads the experimental data from disc and generates the output data set which is the input data for SMASH. The PL/1 program translates data from a format specified by the assembly language program which runs on the PDP8/E minicomputer to data in the proper format for SMASH. Execution of TRS3 is the first major step in the job which calculates experimental results. TRS3 is run automatically by the WYLBUR execute file which appears in Appendix 6. The operation of TRS3 is controlled by a group of input variables which specify the number of experiments which were performed and the mode of the pulsed XEOL system employed for each experiment. If the slow mode is specified TRS3 plots the decay curve with Simplotter. Simplotter is accessed by the CALL GRAPH and CALL GRAPHS statements which appear in the listing. A CALL ORIGIN statement, one of the Simplotter options, is used to move the position of the graph on the paper on which the graph is plotted. A listing of the source statements of TRS3 is given on the following pages.

```
(STRG,SUBRG):
CORE: PROCEDURE OPTIONS (MAIN);
      DCL GRAPH ENTRY (FIXED BIN, (*) FLOAT, (*) FLOAT,
            FIXED BIN, FIXED BIN, FLOAT, FLOAT, FLOAT,
            FLOAT, FLOAT, FLOAT, CHAR(20), CHAR(20),
            CHAR(20), CHAR(20));
      DCL GRAPHS ENTRY (FIXED BIN, (*) FLOAT, (*) FLOAT,
            FIXED BIN, FIXED BIN, CHAR(20));
      DCL ORIGIN ENTRY (FLOAT,FLOAT,FIXED BIN);
      DCL IN FILE INPUT;
      DCL OUT FILE OUTPUT ENVIRONMENT (CONSECUTIVE);
      DCL OPTION(50) FIXED;
      DCL (REJECT, INPUT) CHAR(80);
      DCL (X1(POINTS), Y1(POINTS), CORRECT(POINTS),
            ADDRESS(POINTS)) FLOAT CONTROLLED;
      DCL (SUMSQR(POINTS),VAR(POINTS)) FLOAT CONTROLLED;
      DCL (LAB1, LAB2) CHAR(20);
      DCL COMP(NCOMP) FLOAT CONTROLLED;
      DCL (DATE, TIME) CHAR(6);
      DCL (RUNS, PASSES, NUMWAV, POINTS) FIXED BIN;
      DCL (HEAD, XLAB, YLAB, GLAB, DATLAB) CHAR(80);
      CALL ORIGIN (0.0,1.0,1);
      GET FILE (IN) LIST (RUN);
      DO I=1 TO RUN;
            GET FILE (IN) LIST (OPTION(I));
      END;
      RUNCNT=RUN;M=1;
GETIN:GET EDIT (REJECT) (COL(1),A(70)) COPY;
      GET EDIT (INPUT) (COL(1),A(63)) COPY;
      GET STRING (INPUT) EDIT (DATE,TIME,RUNS,NUMWAV,
            PASSES,POINTS,LUMIN) (A(6),X(2),A(4),
            X(2),5(F(5),X(2)));
      IF LUMIN=1 THEN
            GET STRING (INPUT) EDIT (DELTIM,RANGE)
            (X(49),2(F(5),X(2)));
      J=1;
      ALLOCATE Y1(POINTS);
INDAT:GET EDIT (INPUT) (COL(1),A(70)) COPY;
      DO I=1 TO 7;
            GET STRING (SUBSTR(INPUT,(10*I-9),8)) EDIT
            (Y1(J)) (F(8));
            IF J=POINTS THEN GO TO ENDIN;
            J=J+1;
      END;
      IF J¬=POINTS+1 THEN GO TO INDAT;
ENDIN:RUNCNT=RUNCNT-1;
      J=1;
      Y1=-Y1;
      ALLOCATE CORRECT(POINTS);
      ALLOCATE ADDRESS(POINTS);
```

```
CORIN:GET EDIT (INPUT) (COL(1),A(70)) COPY;
      DO I=1 TO 5;
               GET STRING (SUBSTR(INPUT,(14*I-13),14)) EDIT
               (CORRECT(J),ADDRESS(J)) (2(F(5),X(2)));
               IF CORRECT(J)=0 THEN GO TO CORR;
               J=J+1;
      END;
      IF CORRECT(J-1)¬=0 THEN GO TO CORIN;
CORR: ALLOCATE SUMSQR(POINTS);
      J=1;
INSQR:GET EDIT (INPUT) (COL(1),A(70)) COPY;
      DO I=1 TO 7;
               GET STRING (SUBSTR(INPUT,(10*I-9),8)) EDIT
               (SUMSQR(J)) (F(8));
               IF J=POINTS THEN GO TO ENDSQR;
               J=J+1;
      END;
      IF J¬=POINTS+1 THEN GO TO INSQR;
ENDSQR:DO I=1 TO POINTS;
      IF CORRECT(I)=0 THEN GO TO ENDIT;
      SUMSQR(ADDRESS(I))=SUMSQR(ADDRESS(I))+
               CORRECT(I)*16777216;
      END;
 ENDIT:FREE CORRECT;
      FREE ADDRESS;
      IF LUMIN=0 THEN GO TO FAST;
      ALLOCATE VAR(POINTS);
      VAR=ABS(SUMSQR-Y1**2/PASSES)/(PASSES-1);
      FREE SUMSQR;
      CHECK=999;
      DO I=1 TO POINTS;
               IF VAR(I)¬=0 THEN CHECK=MIN(CHECK,VAR(I));
      END;
      DO I=1 TO POINTS;
               IF VAR(I)=0 THEN VAR(I)=CHECK;
      END;
      Y1=Y1/PASSES;
      ALLOCATE X1(POINTS);
      X1(1)=0;
      IF RANGE=1 THEN RANVAL=0.01;
               ELSE IF RANGE=2 THEN RANVAL=0.1;
               ELSE RANVAL=1;
      DO I=2 TO POINTS;
               X1(I)=X1(I-1)+RANVAL;
      END;
      GET FILE (IN) EDIT (LAB1,LAB2) (COL(1),2(A(20)));
      CALL ORIGIN (11.0,0.0,1);
      CALL GRAPH (POINTS,X1,Y1,1,7,9,7,0,0,0,0,
               'TIME  (SEC)','INTENSITY',LAB1,LAB2);
      CALL GRAPHS (POINTS,X1,Y1,0,121,DATE||'  '||TIME);
```

```
      IF OPTION(M)=1 THEN GO TO SMASH;
DUMP: PUT PAGE;
      PUT SKIP LIST ('TRS2 DATA DUMP');
      PUT SKIP LIST ('DATE',DATE,'TIME',TIME,'RUN NO.',
            RUNS);
      PUT SKIP LIST ('NUMBER OF PASSES',PASSES,
            'NUMBER OF XRAY WAVES',NUMWAV);
      IF LUMIN=0 THEN GO TO CONT1;
      PUT SKIP LIST ('TRANSIENT DECAY TIME (USEC)',(DELTIM*
            5+10),'INTEGRATION TIME (MSEC)',(10**RANGE));
      PUT SKIP;
      PUT SKIP LIST ('THE TIME VALUES ARE:');
      PUT SKIP LIST (X1);
CONT1:PUT SKIP;
      PUT SKIP LIST ('THE INTENSITY VALUES ARE:');
      PUT SKIP LIST (Y1);
      PUT SKIP;
      PUT SKIP LIST ('THE VARIANCE VALUES ARE:');
      PUT SKIP LIST (VAR);
      PUT PAGE;
      M=M+1;
      IF RUNCNT¬=0 THEN GO TO GETIN;
      PUT FILE (OUT) SKIP;
      GO TO STOP;
SMASH:AVE=0;IFIRST=0;DEADT=0.0;SIGMAB=0.0;
      DO I=1 TO 10;
            AVE=AVE+Y1(POINTS+1-I);
      END;
      BACKGR=AVE/10;
      GET FILE (IN) EDIT (ISMASH) (COL(1),F(2));
      DO I=1 TO ISMASH;
            GET FILE (IN) EDIT (NCOMP,INPU,IPLOT)
            (COL(1),3(F(5)));
            PUT FILE (OUT) EDIT (NCOMP,POINTS,IFIRST,
            INPU,DEADT,BACKGR,SIGMAB,IPLOT)
            (COL(1),4(F(5)),3(F(12,3)),X(19),F(5));
            GET FILE (IN) EDIT (HEAD) (COL(1),A(80));
            PUT FILE (OUT) EDIT (HEAD) (COL(1),A(80));
            IF IPLOT=0 THEN GO TO CONT3;
            GET FILE (IN) EDIT (XLAB,YLAB,GLAB,DATLAB)
            (COL(1),4(A(20)));
            PUT FILE (OUT) EDIT (XLAB,YLAB,GLAB,DATLAB)
            (COL(1),4(A(20)));
CONT3:      ALLOCATE COMP(NCOMP);
            GET FILE (IN) EDIT (COMP) ((NCOMP)(F(10,3)));
            PUT FILE (OUT) EDIT (COMP) (COL(1),(NCOMP)
            (F(10,3)));
            FREE COMP;
            IF INPU<0 THEN GO TO CONT4;
            PUT FILE (OUT) EDIT (Y1) (COL(1),6 E(12,5));
```

```
              PUT FILE (OUT) EDIT (X1) (COL(1),6 E(12,5));
              PUT FILE (OUT) EDIT (VAR) (COL(1),6 E(12,5));
CCNT4:END;
      GO TO DUMP;
FAST: AVE=SUM(Y1)/POINTS;
      VARI=0;
      DO I=1 TO POINTS;
              VARI=VARI+((Y1(I)-AVE)**2);
      END;
      VARI=VARI/(POINTS-1);
      STAND=SQRT(VARI);
      PUT SKIP LIST ('THE AVERAGE VALUE IS:',AVE);
      PUT SKIP LIST ('THE STANDARD DEVIATION IS:',STAND);
      PUT SKIP;
      GO TO DUMP;
STOP: END CORE;
```

APPENDIX 2: SMASH

SMASH is a FORTRAN IV program which determines decay constants for single component decay curves and initial intensities for each component in a multiple component decay curve. The operation of SMASH is described elsewhere (53). Several modifications were made on the input routines and declaration statements to facilitate the execution of the program for the analysis of spectroscopic data. SMASH is the second major step in the job which calculates experimental results. A listing of SMASH with the modifications appears on the following pages.

```
C
C     SMASH, A PROGRAM FOR THE ANALYSIS OF DECAY CURVES,
C     BY P.J.M. KORTHOVEN AND F.S. CARLSEN
C
      CALL SMASH1
      STOP
      END
      SUBROUTINE SMASH1
      DIMENSION IPAR(10),SSIZE(10),X(10),Y(10)
      REAL LAMBDA(10)
      COMMON NSTEPS,NCOMP,FIT2,IFIRST,SSIZE,LAMBDA,ORFIT,
     1NVAR,FIT1
    1 NSTEPS=0
      KOUNT=0
      CALL SMINP1
      IF (NCOMP) 2,63,2
    2 ICONV=NVAR*400
    3 KOUNT=KOUNT+1
      DO 4 I=1,NCOMP
    4 IPAR(I)=0
      IA=0
      IB=0
      CALL SMFIT1
      FIT1=FIT2
      IF (NVAR) 6,5,6
    5 IFIRST=0
    6 IF (IFIRST) 10,7,10
    7 CALL SMOUT1(1)
      IFIRST=1
      IF (NVAR) 8,1,8
    8 IF (KOUNT-1) 10,9,10
    9 ORFIT=FIT2
   10 TEMFIT=FIT2
   11 FIT1=TEMFIT
C
C     INITIAL SEARCH
C
      DO 25 I=1,NCOMP
      X(I)=LAMBDA(I)
      IF (SSIZE(I)) 13,12,13
   12 IPAR(I)=0
      GO TO 25
   13 LAMBDA(I)=LAMBDA(I)+SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 14,14,62
   14 IF (FIT2-FIT1) 15,20,20
   15 IF (IPAR(I)-2) 16,17,16
   16 IPAR(I)=0
   17 IF (ABS(FIT2-FIT1)-0.000001) 19,18,18
   18 IB=1
```

```
      IPAR(I)=1
   19 FIT1=FIT2
      GO TO 25
   20 LAMBDA(I)=X(I)-SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 21,21,62
   21 IF (FIT2-FIT1) 22,23,23
   22 SSIZE(I)=-SSIZE(I)
      GO TO 15
   23 LAMBDA(I)=X(I)
      IF (IPAR(I)-2) 24,25,24
   24 IPAR(I)=0
   25 CONTINUE
C
C     END INITIAL SEARCH
C
   26 DO 27 I=1,NCOMP
      IF (IPAR(I)-1) 27,38,27
   27 CONTINUE
      IF (IB) 28,33,28
   28 DO 32 I=1,NCOMP
      IF (IPAR(I)-2) 30,29,30
   29 SSIZE(I)=SSIZE(I)*0.2
      IPAR(I)=0
   30 IF (ABS(SSIZE(I))-0.00002*LAMBDA(I)) 31,32,32
   31 SSIZE(I)=0.0
   32 CONTINUE
      IB=0
      GO TO 58
   33 DO 34 I=1,NCOMP
      IF (ABS(SSIZE(I))-0.00002*LAMBDA(I)) 34,34,35
   34 CONTINUE
      IF (ABS(FIT1-FIT2)-0.000001) 61,3,3
   35 DO 37 I=1,NCOMP
      SSIZE(I)=SSIZE(I)*0.2
      IF (ABS(SSIZE(I))-0.00002*LAMBDA(I)) 36,37,37
   36 SSIZE(I)=0.0
   37 CONTINUE
      GO TO 58
C
C     ADJUST PARAMETERS FOR THE SELECTED SEARCH
C
   38 TEMFIT=FIT1
      DO 43 I=1,NCOMP
      TEMP=LAMBDA(I)
      IF (IPAR(I)-1) 40,39,40
   39 LAMBDA(I)=LAMBDA(I)*2.0-X(I)
   40 X(I)=TEMP
      IF (IA-1) 41,43,41
   41 IPAR(I)=0
```

```
      IF (SSIZE(I)) 42,43,42
   42 IPAR(I)=1
   43 CONTINUE
      CALL SMFIT1
      IF (NSTEPS-ICONV) 44,44,62
   44 IF (FIT2-FIT1) 45,46,46
   45 FIT1=FIT2
C
C     SELECTED SEARCH
C
   46 DO 54 I=1,NCOMP
      IF (IPAR(I)-1) 54,47,54
   47 Y(I)=LAMBDA(I)
      LAMBDA(I)=LAMBDA(I)+SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 48,48,62
   48 IF (FIT2-FIT1) 53,49,49
   49 LAMBDA(I)=Y(I)-SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 50,50,62
   50 IF (FIT2-FIT1) 51,52,52
   51 SSIZE(I)=-SSIZE(I)
      GO TO 53
   52 LAMBDA(I)=Y(I)
      IPAR(I)=2
      GO TO 54
   53 IA=1
      IB=1
      FIT1=FIT2
   54 CONTINUE
C
C     END SELECTED SEARCH
C
      IF (FIT1-TEMFIT) 38,55,55
   55 DO 57 I=1,NCOMP
      IF (IPAR(I)-1) 57,56,57
   56 IPAR(I)=2
   57 LAMBDA(I)=X(I)
      IA=0
      GO TO 11
   58 IF (FIT2-TEMFIT) 10,59,59
   59 DO 60 I=1,NCOMP
   60 LAMBDA(I)=X(I)
      GO TO 11
   61 CALL SMOUT1 (0)
      GO TO 1
   62 CALL SMOUT1 (-1)
      GO TO 1
   63 STOP
      END
```

```
C
C      SUBROUTINE INPUT
C
       SUBROUTINE SMINP1
       DIMENSION IDENT(20),HALFL(10),SSIZE(10),XLAB(5),
      1YLAB(5),DATLAB(5),GLAB(5),TM(1000),RATE(1000),
      2DIFF(1000),ACALC(1000),A0(10),C(10,10),P(1000,10),
      3BGRND(1000),SIGMBG(1000),RAVAR(1000),DFIT(10),
      4VAR(1000),COUNTS(1000),DELTAT(1000),WDIFF(1000),
      5X(10),HL(10)
       REAL LAMBDA(10)
       INTEGER DF
       COMMON NSTEPS,NCOMP,FIT2,IFIRST,SSIZE,LAMBDA,ORFIT,
      1IDENT,TM,RATE,VAR,XLAB,YLAB,GLAB,DATLAB,IPLOT,COUNTS,
      2ACALC,DIFF,DF,HL,A0,C,P,WDIFF,KS,DEADT,BACKGR,SIGMAB,
      3RAVAR,IWRIT,FIT1,NVAR,DELTAT,NP,HALFL,TO
       NVAR=0
       READ (5,101) NCOMP,NP,IFIRST,INPU,DEADT,BACKGR,SIGMAB,
      1IDUAL,IPLOT
  101  FORMAT (4I5,3F12.3,14X,2I5)
       IF (IPLOT) 116,115,116
  116  CALL ORIGIN (0.0,0.0,0)
       CALL ORIGIN (0.0,1.0,1)
  115  IF (NCOMP) 102,145,102
  102  READ (5,103) (IDENT(I),I=1,20)
  103  FORMAT (20A4)
       IF (IPLOT) 104,105,104
  104  READ (5,103) XLAB,YLAB,GLAB,DATLAB
  105  READ (5,106) (HALFL(I),I=1,NCOMP)
  106  FORMAT (8F10.3)
       IF (INPU) 129,112,111
  111  NCOMP=0
       GO TO 145
  112  READ (5,126) (COUNTS(I),I=1,NP)
       READ (5,126) (TM(I),I=1,NP)
       READ (5,126) (VAR(I),I=1,NP)
  126  FORMAT (6E12.5,8X)
  113  DO 127 I=1,NP
       RATE(I)=COUNTS(I)-BACKGR
       RAVAR(I)=RATE(I)/VAR(I)
       DELTAT(I)=TM(I)
  127  CONTINUE
       DO 128 I=2,NP
  128  TM(I)=TM(I)-TM(1)
       TO=TM(1)
       TM(1)=0.0
  129  DO 130 I=1,NCOMP
       IF (HALFL(I)) 220,230,220
  230  LAMBDA(I)=0.0
       GO TO 130
```

```
  220 LAMBDA(I)=ABS(HALFL(I))
  130 CONTINUE
      IF (NCOMP-1) 107,107,108
  108 XN=0.0
      IWRIT=1
      CALL SMFIT1
      FIT1=FIT2
      DO 131 I=1,NCOMP
      X(I)=LAMBDA(I)
      IF (HALFL(I)) 132,136,136
  132 XX=LAMBDA(I)*0.05
      LAMBDA(I)=LAMBDA(I)+XX
      CALL SMFIT1
      IF (FIT2-FIT1) 133,134,134
  134 LAMBDA(I)=LAMBDA(I)-2.0*XX
      CALL SMFIT1
      IF (FIT2-FIT1) 133,136,136
  133 DFIT(I)=FIT1-FIT2
      GO TO 135
  136 DFIT(I)=XN-1.0
  135 LAMBDA(I)=X(I)
  131 CONTINUE
      DO 140 I=1,NCOMP
      K=NCOMP-1
      DO 140 J=1,K
      IF (DFIT(J)-DFIT(J+1)) 141,140,140
  141 SWAP=DFIT(J)
      DFIT(J)=DFIT(J+1)
      DFIT(J+1)=SWAP
      SWAP=LAMBDA(J)
      LAMBDA(J)=LAMBDA(J+1)
      LAMBDA(J+1)=SWAP
      SWAP=HALFL(J)
      HALFL(J)=HALFL(J+1)
      HALFL(J+1)=SWAP
  140 CONTINUE
  107 IWRIT=0
      NSTEPS=0
      DO 142 I=1,NCOMP
      IF (HALFL(I)) 143,144,144
  143 SSIZE(I)=0.05*LAMBDA(I)
      NVAR=NVAR+1
      GO TO 142
  144 SSIZE(I)=0.0
  142 CONTINUE
  145 RETURN
      END
C
C     SUBROUTINE FIT
C
```

```
      SUBROUTINE SMFIT1
      DIMENSION TM(1000),P(1000,10),V(10),RATE(1000),
     1A0(10),ACALC(1000),DIFF(1000),HL(10),IDENT(20),
     2YLAB(5),GLAB(5),DATLAB(5),COUNTS(1000),DELTAT(1000),
     3HALFL(10),RAVAR(1000),CC(10,10),PAR(10),WDIFF(1000),
     4XLAB(5),SSIZE(10),VAR(1000),C(10,10)
      REAL LAMBDA(10)
      INTEGER DF
      COMMON NSTEPS,NCOMP,FIT2,IFIRST,SSIZE,LAMBDA,ORFIT,
     1IDENT,TM,RATE,VAR,XLAB,YLAB,GLAB,DATLAB,IPLOT,COUNTS,
     2ACALC,DIFF,DF,HL,A0,C,P,WDIFF,KS,DEADT,BACKGR,SIGMAB,
     3RAVAR,IWRIT,FIT1,NVAR,DELTAT,NP,HALFL,TO
      NSTEPS=NSTEPS+1
      IF (NSTEPS-1) 700,701,700
  701 DO 702 I=1,NCOMP
  702 PAR(I)=1.0E60
  700 DO 2031 J=1,NCOMP
      IF (PAR(J)-LAMBDA(J)) 300,2031,300
  300 DO 203 I=1,NP
      DECAYF=-LAMBDA(J)*TM(I)
      IF (ABS(DECAYF)-50.0) 202,201,201
  201 P(I,J)=0.0
      GO TO 203
  202 P(I,J)=EXP(DECAYF)
  203 CONTINUE
 2031 CONTINUE
      DO 204 I=1,NCOMP
      IF (PAR(I)-LAMBDA(I)) 320,204,320
  320 V(I)=0.0
      DO 204 K=1,NP
      V(I)=V(I)+P(K,I)*RAVAR(K)
  204 CONTINUE
      DO 2051 I=1,NCOMP
      DO 2051 J=1,NCOMP
      IF (PAR(I)-LAMBDA(I)) 2205,2206,2205
 2206 IF (PAR(J)-LAMBDA(J)) 2205,2207,2205
 2207 C(I,J)=CC(I,J)
      GO TO 2051
 2205 C(I,J)=0.0
      DO 205 K=1,NP
      C(I,J)=C(I,J)+P(K,I)*P(K,J)/VAR(K)
  205 CC(I,J)=C(I,J)
 2051 CONTINUE
      DO 2500 I=1,NCOMP
 2500 PAR(I)=LAMBDA(I)
      CALL SMATNV (C,NCOMP,DETERM)
      DO 206 I=1,NCOMP
      A0(I)=0.0
      DO 206 J=1,NCOMP
  206 A0(I)=A0(I)+C(I,J)*V(J)
```

```
      RS=0.0
      DO 208 I=1,NP
      ACALC(I)=0.0
      DO 207 J=1,NCOMP
  207 ACALC(I)=ACALC(I)+P(I,J)*A0(J)
      DIFF(I)=RATE(I)-ACALC(I)
      RS=RS+DIFF(I)**2/VAR(I)
  208 CONTINUE
      DF=NP-NCOMP
      XDF=DF
      FIT2=SQRT(RS/XDF)
      IF (IWRIT) 217,751,217
  751 DO 211 I=1,NCOMP
      IF (LAMBDA(I)) 210,209,210
  209 HL(I)=0.0
      GO TO 211
  210 HL(I)=LAMBDA(I)
  211 CONTINUE
      IF (NSTEPS-1) 215,212,215
  212 IF (IFIRST) 213,217,213
  213 WRITE (6,214) (I,I=1,NCOMP)
  214 FORMAT (1H1,5H STEP,6X,3HFIT,9X,9(1H-,I1,1H-,8X),1H-,
     1I2,1H-/1H0)
  215 WRITE (6,216) NSTEPS,FIT2,(HL(I),I=1,NCOMP)
  216 FORMAT (I5,F13.6,9F11.4,F12.4)
  217 RETURN
      END
C
C     SUBROUTINE MATINV
C
      SUBROUTINE SMATNV (A,N,DETERM)
      DIMENSION A(10,10),PIVOT(10),INDEX(10,2),IPIVOT(10)
      EQUIVALENCE (IROW,JROW),(ICOLUM,JCOLUM),(AMAX,T,SWAP)
C
C     INITIALIZATION
C
      DETERM=1.0
      DO 301 J=1,N
  301 IPIVOT(J)=0
      DO 314 I=1,N
C
C     SEARCH FOR PIVOT ELEMENT
C
      AMAX=0.0
      DO 306 J=1,N
      IF (IPIVOT(J)-1) 302,306,302
  302 DO 305 K=1,N
      IF (IPIVOT(K)-1) 303,305,318
  303 IF (ABS(AMAX)-ABS(A(J,K))) 304,305,305
  304 IROW=J
```

```
      ICOLUM=K
      AMAX=A(J,K)
  305 CONTINUE
  306 CONTINUE
      IPIVOT(ICOLUM)=IPIVOT(ICOLUM)+1
C
C     INTERCHANGE ROWS TO PUT PIVOT ELEMENT ON DIAGONAL
C
      IF (IROW-ICOLUM) 307,309,307
  307 DETERM=-DETERM
      DO 308 L=1,N
      SWAP=A(IROW,L)
      A(IROW,L)=A(ICOLUM,L)
  308 A(ICOLUM,L)=SWAP
  309 INDEX(I,1)=IROW
      INDEX(I,2)=ICOLUM
      PIVOT(I)=A(ICOLUM,ICOLUM)
      DETERM=DETERM*PIVOT(I)
C
C     DIVIDE PIVOT ROW BY PIVOT ELEMENT
C
      A(ICOLUM,ICOLUM)=1.0
      DO 310 L=1,N
  310 A(ICOLUM,L)=A(ICOLUM,L)/PIVOT(I)
C
C     REDUCE NON-PIVOT ROWS
C
  311 DO 314 L1=1,N
      IF (L1-ICOLUM) 312,314,312
  312 T=A(L1,ICOLUM)
      A(L1,ICOLUM)=0.0
      DO 313 L=1,N
  313 A(L1,L)=A(L1,L)-A(ICOLUM,L)*T
  314 CONTINUE
C
C     INTERCHANGE COLUMNS
C
      DO 317 I=1,N
      L=N+1-I
      IF (INDEX(L,1)-INDEX(L,2)) 315,317,315
  315 JROW=INDEX(L,1)
      JCOLUM=INDEX(L,2)
      DO 316 K=1,N
      SWAP=A(K,JROW)
      A(K,JROW)=A(K,JCOLUM)
      A(K,JCOLUM)=SWAP
  316 CONTINUE
  317 CONTINUE
  318 RETURN
      END
```

```
C
C     SUBROUTINE OUTPUT
C
      SUBROUTINE SMOUT1(ICASE)
      DIMENSION DATLAB(5),A0(10),P(1000,10),SAZERO(10),
     1IDENT(20),SRELAT(10),WDIFF(1000),HALFL(10),HL(10),
     2DELTAT(1000),COUNTS(1000),RATE(1000),ACALC(1000),
     3XLAB(5),YLAB(5),GLAB(5),THALFL(10),TEMPHL(5),
     4SSIZE(10),TM(1000),CORR(10),DIFF(1000),VAR(1000),
     5AZERO(10),C(10,10)
      REAL LAMBDA(10),LOGACT(1000),LOGFC(1000)
      INTEGER DF
      COMMON NSTEPS,NCOMP,FIT2,IFIRST,SSIZE,LAMBDA,ORFIT,
     1IDENT,TM,RATE,VAR,XLAB,YLAB,GLAB,DATLAB,IPLOT,COUNTS,
     2ACALC,DIFF,DF,HL,A0,C,P,WDIFF,KS,DEADT,BACKGR,SIGMAB,
     3HALFL,TO,DELTAT,NP,FIT1,NVAR
      EQUIVALENCE (LOGACT(1),WDIFF(1)),(LOGFC(1),ACALC(1))
      DO 400 I=1,NP
  400 TM(I)=TM(I)+TO
      DO 401 I=1,NCOMP
      CORR(I)=EXP(TO*LAMBDA(I))
      AZERO(I)=A0(I)*CORR(I)
      SAZERO(I)=SQRT(C(I,I))*CORR(I)*FIT1
  401 SRELAT(I)=SAZERO(I)/AZERO(I)*100.0
      IPERC1=0
      IPERC2=0
      IPERC3=0
      DO 406 I=1,NP
      VAR(I)=SQRT(VAR(I))
      WDIFF(I)=DIFF(I)/VAR(I)
      IWDIFF=IABS(IFIX(WDIFF(I)))+1
      IF (ABS(WDIFF(I))-3.0) 402,403,403
  402 GO TO (406,404,405),IWDIFF
  403 IPERC3=IPERC3+1
      GO TO 406
  404 IPERC1=IPERC1+1
      GO TO 406
  405 IPERC2=IPERC2+1
  406 CONTINUE
      PERC1=FLOAT(IPERC1+IPERC2+IPERC3)/FLOAT(NP)*100.0
      PERC2=FLOAT(IPERC2+IPERC3)/FLOAT(NP)*100.0
      PERC3=FLOAT(IPERC3)/FLOAT(NP)*100.0
      WRITE (6,407) (IDENT(I),I=1,20)
  407 FORMAT (1H1,20A4)
      IF (ICASE) 408,410,414
  408 WRITE (6,409) NSTEPS
  409 FORMAT (86H THE SOLUTION IS NOT YET REACHED, OUTPUT IS
     1CALCULATED WITH THE PARAMETER VALUES AFTER,I5,6H STEPS
     2/1H0)
      GO TO 412
```

```
410 WRITE (6,411)
411 FORMAT (45H RESULTS OBTAINED WITH FINAL PARAMETER
   1VALUES/1H0)
412 WRITE (6,413) NP,NSTEPS,NCOMP,PERC1,NVAR,DF,PERC2,
   2BACKGR,SIGMAB,PERC3,DEADT,ORFIT,FIT1
413 FORMAT (15X,16HINPUT QUANTITIES,50X,17HOUTPUT QUANTITI
   1ES//12X,23HNUMBER OF DATA POINTS =,I5,56X,17HNUMBER OF
   2 STEPS =,I5/13X,22HNUMBER OF COMPONENTS =,I5,23X,50HPE
   3RCENTAGE OF POINTS DEVIATING MORE THAN 1 SIGMA =,F8.2/
   44X,31HNUMBER OF VARIABLE DECAY CONS =,I5,34X,28H(THEOR
   5ETICAL VALUE = 31.74 ) /15X,20HDEGREES OF FREEDOM =,I5
   6,23X,50HPERCENTAGE OF POINTS DEVIATING MORE THAN 2 SIG
   7MA =,F8.2/7X,28HBACKGROUND (COUNTS/MINUTE) =,F9.1,30X,
   828H(THEORETICAL VALUE =  4.56 )/1H ,34HSIGMA BACKGROUN
   9D (COUNTS/MINUTE) =,F7.1,21X,50HPERCENTAGE OF POINTS D
   8EVIATING MORE THAN 3 SIGMA =,F8.2/8X,27HDEAD TIME (MIC
   7RO SECONDS) =,F7.1,32X,29H(THEORETICAL VALUE = 0.26 )
   6//21X,14HORIGINAL FIT =,F14.6,53X,11HFINAL FIT =,F14.6
   5//1H0)
    IF (ICASE) 445,548,417
445 WRITE (6,447)
447 FORMAT (1H0/58X,17H*****WARNING*****/51X,30H*****CHECK
   1 YOUR ESTIMATES*****/1H0/1H0)
    GO TO 448
548 NEG=0
    DO 442 I=1,NCOMP
    IF (AZERO(I)) 443,443,442
443 NEG=1
442 CONTINUE
    IF (NEG-1) 438,460,460
460 WRITE (6,444)
444 FORMAT (1H0/58X,17H*****WARNING*****/38X,56H*****THE N
   1UMBER OF COMPONENTS IS PROBABLY TOO LARGE*****/1H0)
    GO TO 448
438 IF (FIT2-2.0) 448,439,439
439 WRITE (6,440)
440 FORMAT (1H0/58X,17H*****WARNING*****/38X,56H*****THE N
   1UMBER OF COMPONENTS IS PROBABLY TOO SMALL*****/1H0)
    GO TO 448
414 WRITE (6,415)
415 FORMAT (48H RESULTS OBTAINED WITH ORIGINAL PARAMETER
   1VALUES/1H0)
    DO 416 I=1,NCOMP
    TEMPHL(I)=HL(I)
    THALFL(I)=HALFL(I)
    HALFL(I)=ABS(HALFL(I))
416 HL(I)=0.0
    FIT1=FIT2
    NV=NVAR
    NVAR=0
```

```
      ORFIT=0.0
      GO TO 412
  417 IF (NV) 448,449,448
  449 IF (FIT1-2.0) 448,450,450
  450 WRITE (6,447)
  448 IF (ICASE) 420,420,418
  418 NVAR=NV
  420 WRITE (6,421)
  421 FORMAT (1H0,22X,9HCOMPONENT,8X,8HORIGINAL,9X,5HFINAL,9
     1X,8HACTIVITY,9X,5HSIGMA,9X,5HSIGMA/39X,9HDECAY CON,7X,
     29HDECAY CON,8X,6HAT EOB,8X,8HABSOLUTE,7X,8HRELATIVE//)
      WRITE (6,422) (I,HALFL(I),HL(I),AZERO(I),SAZERO(I),
     1SRELAT(I),I=1,NCOMP)
  422 FORMAT (22X,I5,F21.4,F16.4,F16.3,F14.3,F13.3)
      WRITE (6,423)
  423 FORMAT (1H0///1H0)
  424 WRITE (6,425)
  425 FORMAT (8X,7HMIDTIME, 7X,4HTIME,10X,8HORIGINAL,8X,9HCO
     1RRECTED,8X,5HSIGMA,8X,10HCALCULATED,9X,8HABSOLUTE,11X,
     210HDIFFERENCE/9X,5HCOUNT,6X,8HINTERVAL,10X,4HDATA,13X,
     34HRATE,11X,4HRATE,11X,4HRATE,11X,10HDIFFERENCE,8X,13H(
     4SIGMA UNITS)/1H0)
      WRITE (6,426) (I,TM(I),DELTAT(I),COUNTS(I),RATE(I),
     1VAR(I),ACALC(I),DIFF(I),WDIFF(I),I=1,NP)
  426 FORMAT (I4,F10.6,F12.6,F18.1,F17.1,F14.1,F16.1,
     1F18.1,F18.3)
  427 DO 428 I=1,NP
  428 VAR(I)=VAR(I)**2
      IF (IPLOT) 429,432,431
  429 DO 430 I=1,NP
      IF (RATE(I)) 461,461,462
  461 RATE(I)=1.0
  462 LOGACT(I)=ALOG10(RATE(I))
      IF (ACALC(I)) 463,463,464
  463 ACALC(I)=1.0
  464 LOGFC(I)=ALOG10(ACALC(I))
  430 CONTINUE
      CALL ORIGIN (11.0,0.0,1)
      CALL GRAPH (NP,TM,LOGACT,3,7,9.,-7.,0,0,0,0,XLAB,YLAB,
     1GLAB,DATLAB)
      CALL GRAPH (NP,TM,LOGFC,3,2,0,0,0,0,0,0,0,0,0,0)
      GO TO 432
  431 CALL ORIGIN (11.0,0.0,1)
      CALL GRAPH (NP,TM,RATE,3,7,9.,7.,0,0,0,0,XLAB,YLAB,
     1GLAB,DATLAB)
      CALL GRAPH (NP,TM,ACALC,3,2,0,0,0,0,0,0,0,0,0,0)
  432 IF (ICASE) 437,437,433
  433 DO 419 I=1,NCOMP
      HL(I)=TEMPHL(I)
  419 HALFL(I)=THALFL(I)
```

```
      IF (NVAR) 434,437,434
434   WRITE (6,435) (I,I=1,NCOMP)
435   FORMAT (1H1,5H STEP,6X,3HFIT,9X,9(1H-,I1,1H-,8X),1H-,
     1I2,1H-/1H0)
      WRITE (6,436) NSTEPS,FIT2,(HL(I),I=1,NCOMP)
436   FORMAT (I5,F13.6,9F11.4,F12.4)
437   DO 446 I=1,NP
446   TM(I)=TM(I)-TO
      RETURN
      END
```

APPENDIX 3: GENPLOT

GENPLOT, a utility program for the generation of plots of general data, is a combination of a WYLBUR execute file and a PL/1 program. The execute file requests input information and data from the operator. The PL/1 program accesses Simplotter with CALL GRAPH and CALL GRAPHS statements. Logarithmic or linear plots can be generated. Several data sets can be plotted on the same graph and several graphs can be plotted at one time.

GENPLOT was used to plot calibration curves, decay curves, current, voltage and time relationships and other general data. The program was written to plot general data sets with many options of Simplotter available. Increased use of GENPLOT for examination of data trends and shapes of curves should be encouraged. The listing of the program follows on subsequent pages.

```
  10   SET EXEC NOL TERSE
  20   SET ESC :
  25   CLR TEXT
  30   COPY 700/761 EXEC TO 1
  40   REA VAL N0 PRO 'NUMBER OF GRAPHS ?  '
  50   CH '###' TO ':N0' N
  55   SET VAL W0=100
  60   SET VAL N1=0
  70   SET VAL N1=N1+1
  80   IF (N1 GT N0) EXEC 550
  90   REA VAL N2 PRO 'NUMBER OF PLOTS ON GRAPH :N1 ?  '
 100   :W0 :N2
 101   SET VAL W0=W0+1
 110   SET VAL N3=0
 130   REA STR S0 PRO 'X-AXIS LABEL ?  '
 140   :W0 ':S0'
 145   SET VAL W0=W0+1
 150   REA STR S0 PRO 'Y-AXIS LABEL ?  '
 160   :W0 ':S0'
 165   SET VAL W0=W0+1
 170   REA STR S0 PRO 'GRAPH LABEL ?  '
 180   :W0 ':S0'
 181   SET VAL W0=W0+1
 182   REA STR S0 PRO 'LIN=LINEAR OR LOG=LOGARITHMIC PLOT ? '
 183   :W0 ':S0'
 190   SET VAL W0=W0+1
 200   SET VAL N3=N3+1
 210   IF (N3 GT N2) EXEC 70
 220   REA VAL N4 PRO 'HOW MANY POINTS IN PLOT :N3 ?  '
 230   REA VAL N5 PRO 'ENTER A NUMBER BETWEEN 1-13 !  '
 240   SET VAL S0=N4||' '||N5
 250   :W0 :S0
 260   SET VAL W0=W0+1
 270   SET VAL N5=0
 274   COMM ENTER X VALUES ONE AT A TIME
 275   SET VAL S1=''
 280   SET VAL N5=N5+1
 285   IF (N5 GT N4) EXEC 340
 300   REA STR S0 PRO 'X(:N5)= '
 310   SET VAL S1=S1||' '||S0
 320   IF (SIZE(S1) LE 60) EXEC 280
 330   EXEC 500 SAVE
 333   IF (N5 EQ N4) EXEC 360
 335   EXEC 275
 340   :W0 :S1
 350   SET VAL W0=W0+1
 360   SET VAL N5=0
 364   COMM ENTER Y VALUES ONE AT A TIME
 365   SET VAL S1=''
 370   SET VAL N5=N5+1
```

```
375    IF (N5 GT N4) EXEC 430
390    REA STR S0 PRO 'Y(:N5)= '
400    SET VAL S1=S1||' '||S0
410    IF (SIZE(S1) LE 60) EXEC 370
420    EXEC 500 SAVE
423    IF (N5 EQ N4) EXEC 450
425    EXEC 365
430    :W0 :S1
440    SET VAL W0=W0+1
450    REA STR S0 PRO 'DATA LABEL ?  '
460    :W0 ':S0'
470    SET VAL W0=W0+1
480    EXEC 200
500    :W0 :S1
510    SET VAL W0=W0+1
520    EXEC RETURN
550    COMM TO PLOT DATA TYPE EXEC NEXT
560    EXEC PAUSE
570    COPY 800/805 EXEC TO L+1
600    RUN UNN
610    EXEC PAUSE
700    //A411GJO JOB A0099,GJO,TIME=(,29)
701    //S1 EXEC PL1LFCG,PARM.PL1L='A,X,NEST',REGION.GO=128K
702    //PL1L.SYSIN DD *
703     PLOT:PROC OPTIONS (MAIN);
704     DCL GRAPH ENTRY(FIXED BIN,(*) FLOAT,(*) FLOAT,FIXED
705     BIN,FIXED BIN,FLOAT,FLOAT,FLOAT,FLOAT,FLOAT,FLOAT,
706     CHAR(20),CHAR(20),CHAR(20),CHAR(20));
707     DCL GRAPHS ENTRY (FIXED BIN,(*) FLOAT,(*) FLOAT,FIXED
708     BIN,FIXED BIN,CHAR(20));
709     DCL LETTRS ENTRY (FLOAT,FLOAT,FLOAT,CHAR(80),FLOAT,
709.5   FIXED BIN);
710     DCL ORIGIN ENTRY (FLOAT,FLOAT,FIXED BIN);
711     DCL (XLAB,YLAB,GLAB,DATLAB) CHAR(20) VARYING;
712     DCL (STRING) CHAR (3);
713     CALL ORIGIN (0.0,3.0,1);
714     DO I=1 TO ###;
715     CALL ORIGIN (8.5,0.0,1);
716     CALL ORIGIN (1.0,-1.5,6);
717     GET LIST (IPLOT);
718     GET LIST (XLAB,YLAB,GLAB);
719     GET LIST (STRING);
720     GET LIST (NPOINTS,ISYM);
721     PLOT1:BEGIN;
722     DCL (X(NPOINTS),Y(NPOINTS)) FLOAT;
723     GET LIST (X);
724     GET LIST (Y);
725     GET LIST (DATLAB);
726     IF STRING='LOG' THEN DO;
727     X=LOG10(X);
```

```
728     Y=LOG10(Y);
729     END;
730     IF STRING='LOG' THEN DO;
731     I5=-5;
732     XYSF=0.5;
733     END;
734     ELSE DO;
735     I5=5;
736     XYSF=0.0;
737     END;
738     CALL GRAPH (NPOINTS,X,Y,ISYM,7,I5,I5,XYSF,0.0,XYSF,
739     0.0,';',';',';',DATLAB);
740     CALL LETTRS (0.0,5.5,0.2,GLAB,0.0,80);
741     CALL LETTRS ((5-(LENGTH(XLAB)/5))/2,-1.0,0.2,XLAB,
741.5   0.0,20);
742     CALL LETTRS (-1.0,(5-(LENGTH(YLAB)/5))/2,0.2,YLAB,
742.5   90.0,20);
743     END PLOT1;
744     IF IPLOTS=1 THEN GO TO STOP;
745     DO J=2 TO IPLOT;
746     GET LIST (NPOINTS,ISYM);
747     PLOTS:BEGIN;
748     DCL (X(NPOINTS),Y(NPOINTS)) FLOAT;
749     GET LIST (X);
750     GET LIST (Y);
751     GET LIST (DATLAB);
752     IF STRING='LOG' THEN DO;
753     X=LOG10(X);
754     Y=LOG10(Y);
755     END;
756     CALL GRAPHS (NPOINTS,X,Y,ISYM,107,DATLAB);
757     END PLOTS;
758     END;
759     END;
760     STOP:END PLOT;
761    //GO.SYSIN DD *
800    //GO.FT14F001 DD DSN=&SM,UNIT=SCRTCH,DISP=(NEW,PASS),
801    // SPACE=(800,(120,15)),DCB=(RECFM=VS,LRECL=796,
802    // BLKSIZE=800)
803    /*
804    //SMPLTTR EXEC PLOT,PLOTTER=INCRMNTL,FORM=W
805    /*
806    //
```

APPENDIX 4: TRSGJO

TRSGJO is an assembly language program which runs on the PDP8/E minicomputer. TRSGJO controls the x-ray pulse generation, data acquisition and format of the paper tape data set of the pulsed XEOL system. The assembly language program is composed of several subroutines. Many of the subroutines are utilities for accepting input from the keyboard or paper tape reader, generating output on the teletype or paper tape punch or performing simple numerical operations. The subroutines which contain interface instructions control the x-ray supply or gated integrator. The program, in compiled form, appears on the following pages.

```
                / TRSGJO
                / OESTREICH 5-20-77

        0000    FIELD 0

        0000    *0

        0020    *20

00020   7402            HLT
00021   0000    CNTR1,  0
00022   0000    CNTR2,  0
00023   3777    ISTORE, 3777
00024   0000    P,      0
00025   0000    PASSES, 0
00026   0000    SUM2,   0
00027   0000    NUMWAV, 0
00030   0000    DELTIM, 0
00031   0000    PUN1,   0
00032   0000    RUNCNT, 0
00033   0000    LUMIN,  0
00034   0000    DATPOT, 0
00035   0000    RANGE,  0
00036   0000    N,      0
00037   0000    SUM,    0
00040   0000    DELRAN, 0
00041   0000    TEMPST, 0
00042   0000            0
00043   0000    CNT1,   0
00044   0000    CNT2,   0
00045   0000    HIGH,   0
00046   0000    LOW,    0

        0200    *200

00200   7300    START,  CLA CLL         /CLEAR LINK & LINK
00201   6046            TLS             /RAISE TTY PRINT FLAG
00202   4577            JMS I  DATTIM   /INPUT DATE & TIME
00203   4576    RESET,  JMS I  RESET1   /RESET ROUTINE
00204   4231    PASS,   JMS SET1        /SET WORKING VARIABLES
00205   4575            JMS I  PREP     /ROTOR ON & ENABLE
00206   1033            TAD LUMIN
00207   7650            SNA CLA
00210   4304            JMS BOMB2       /XRAYS FAST
00211   4254            JMS BOMB        /X-RAYS SLOW
00212   4574            JMS I  SUMDAT
00213   4573            JMS I  SUMSQR   /SUM SQUARES
00214   2024            ISZ P           /TEST PASS COUNT
00215   5204            JMP PASS
```

```
0C216  4572          JMS I  DATOUT
0C217  7200          CLA
00220  1377          TAD (MSG15-1     /ANOTHER RUN ?
0C221  3017          DCA 17
00222  4571          JMS I  MESAGE
00223  4570          JMS I  NUMGET    /GET ANSWER
00224  7640          SZA CLA
00225  5203          JMP RESET
00226  4567          JMS I  ENDFIL
0C227  4566          JMS I  CRLF
00230  7402          HLT

00231  0000  SET1,    0                /SET WORKING VARIABLES
0C232  7200          CLA
00233  1023          TAD ISTORE       /SET STORAGE POINTER
0C234  3010          DCA 10
00235  1033          TAD LUMIN        /FAST OR SLOW
0C236  7650          SNA CLA
00237  5251          JMP POINTS       /FAST, GO BOMB
00240  7340          CLA CLL CMA      /SLOW, SET OTHERS
00241  1034          TAD DATPOT       /DATA POINT COUNTER
0C242  3037          DCA SUM
0C243  7340          CLA CLL CMA
00244  1010          TAD 10
00245  3010          DCA 10
0C246  1034          TAD DATPOT       /DATA REFERENCE
00247  3026          DCA SUM2
0C250  5631          JMP I SET1
00251  1027  POINTS,  TAD NUMWAV
0C252  3026          DCA SUM2
00253  5631          JMP I SET1

00254  0000  BOMB,    0                /BOMB ROUTINE
0C255  6337          CSTART           /CONTROLLER STARTS
00256  1027          TAD NUMWAV       /# OF WAVES
0C257  3036          DCA N
00260  6331          CREADY           /COMPUTER READY
0C261  6332          NOW              /ZERO CROSSING OF WAVE
00262  5261          JMP .-1
0C263  6333  MULTI,   XON              /TURN XRAY ON
00264  7346          CLA CLL CMA RTL
0C265  4565          JMS I  DEL       /5 USEC * AC DELAY
0C266  6332          NOW              /INDICATES X-RAY OFF
0C267  5266          JMP .-1
00270  6334          XOFF             /HOLDS X-RAYS OFF
CC271  7346          CLA CLL CMA RTL
0C272  4565          JMS I  DEL       /5 USEC * AC DELAY
0C273  2036          ISZ N            /ANOTHER WAVE ?
00274  5263          JMP MULTI        /YES, REPEAT PROCESS
0C275  6336          CWAIT            /NO, RESET NOW PULSE
```

```
0C276  6344           XDABLE          /XRAY DISABLE
00277  6342           ROTROF          /TURN ROTOR OFF
00300  1030           TAD DELTIM      /TRANSIENT DELAY
0C301  4565           JMS I  DEL      /5 USEC * AC DELAY
0C302  4564           JMS I  DATA     /COLLECT DATA
00303  5654           JMP I BOMB

00304  0000  BOMB2,    0               /BCMB ROUTINE FAST
0C305  6337           CSTART          /CONTROLLER START
00306  1027           TAD NUMWAV
00307  3036           DCA N
00310  6331           CREADY          /COMPUTER READY
0C311  6332           NOW
00312  5311           JMP .-1
00313  6333  MULT,     XON             /TURN XRAY ON
00314  1376           TAD (-1440
0C315  4565           JMS I  DEL      /5 USEC * AC DELAY
00316  6345           STBOX           /START INTEGRATOR
0C317  6332           NOW
0C320  5317           JMP .-1
0C321  6334           XOFF            /HOLD XRAY OFF
00322  1376           TAD (-1440
00323  4565           JMS I  DEL      /5 USEC * AC DELAY
00324  6455           STATOD          /START A TO D
0C325  7346           CLA CLL CMA RTL
0C326  4565           JMS I  DEL      /5 USEC * AC DELAY
00327  6354           GETDAT          /GET DATA POINT
0C330  6346           INBOX           /RESET INTEGRATOR
0C331  3410           DCA I 10
00332  6332           NOW
0C333  5332           JMP .-1
00334  7346           CLA CLL CMA RTL
0C335  4565           JMS I  DEL      /5 USEC * AC DELAY
00336  2036           ISZ N           /MORE WAVES ?
00337  5313           JMP MULT        /YES, BOMB
00340  6336           CWAIT           /NO, RESET
0C341  6344           XDABLE          /DISABLE XRAY
00342  6342           ROTROF          /TURN ROTOR OFF
0C343  2304           ISZ BOMB2
00344  5704           JMP I BOMB2

0C376  6340
00377  3206

       0400  * 400

00400  0000  MESAGE,  0               /MESSAGE ROUTINE
0C401  7300  ENT10,   CLA CLL
00402  1241           TAD LIT1
0C403  3240           DCA BYTCNT
```

```
0C404   1417            TAD I 17
00405   3246            DCA STOR1
0C406   1246            TAD STOR1
00407   7002            BSW                 /BYTE SWAP
00410   0242  ENT11,    AND LIT2            /CHECK FOR TERMINATOR
00411   7440            SZA                 /ZERO IN AC ?
00412   5214            JMP .+2             /NO; CONTINUE
00413   5600            JMP I MESAGE        /YES; END MESSAGE
0C414   1243            TAD LIT3
0C415   7500            SMA
0C416   5221            JMP .+3
00417   1244            TAD LIT4
00420   5222            JMP .+2
00421   1245            TAD LIT5
0C422   3247            DCA STOR2
0C423   1247            TAD STOR2           /CHECK FOR CRLF
0C424   1250            TAD MDOLAR
00425   7640            SZA CLA             /IS THE CHARACTER A $
00426   5231            JMP .+3             /NO; PRINT IT
0C427   4566            JMS I  CRLF         /YES; CRLF
00430   5233            JMP .+3
0C431   1247            TAD STOR2
0C432   4563            JMS I  TYPEIT
00433   2240            ISZ BYTCNT          /GET NEXT CHARACTER
00434   5236            JMP .+2
00435   5201            JMP ENT10
00436   1246            TAD STOR1
0C437   5210            JMP ENT11
00440   0000  BYTCNT,   0
0C441   7776  LIT1,     7776
0C442   0077  LIT2,     0077
0C443   7745  LIT3,     7745
00444   0333  LIT4,     0333
00445   0233  LIT5,     0233
00446   0000  STOR1,    0
0C447   0000  STOR2,    0
00450   7534  MDOLAR,   -244

00451   0000  NUMGET,   0                   /NO INTERPRETER ROUTINE
0C452   7300            CLA CLL
0C453   3323            DCA DIGITS
0C454   1324            TAD DIGLOC
0C455   3010            DCA DIGPTR
0C456   3325            DCA TEMP
00457   4562  GETDIG,   JMS I READ          /READ CHARACTER
0C460   3325            DCA TEMP
00461   1325            TAD TEMP            /CHECK FOR ERASE
00462   1326            TAD MSLASH          /KEY (SLASH)
00463   7650            SNA CLA             /IS CHAR A SLASH ?
00464   5311            JMP ERROR           /YES; REPEAT ENTRY
```

```
00465  1325          TAD TEMP          /NO; TEST FOR TERMINAL
00466  1327          TAD RETURN        /RETURN CHARACTER
00467  7650          SNA CLA           /IS IT A RETURN ?
00470  5316          JMP CLEAR         /YES; EXIT THIS ROUTINE
00471  1325          TAD TEMP          /NO; CHECK FOR
00472  1377          TAD (-260         /OCTAL INPUT
00473  7510          SPA               /IS CHAR < 260 ?
00474  5311          JMP ERROR         /YES; GO TO ERROR
00475  1330          TAD MNINE         /NO; SUBTRACT 9 DECIMAL
00476  7740          SMA SZA CLA       /IS CHAR > 271 ?
00477  5311          JMP ERROR         /YES; GO TO ERROR
00500  1325          TAD TEMP          /NO; GET THE CHAR
00501  3410          DCA I DIGPTR
00502  2323          ISZ DIGITS        /INCREMENT DIGIT COUNT
00503  7300          CLA CLL
00504  1323          TAD DIGITS        /CHECK DIGIT COUNT
00505  1376          TAD (-4
00506  7740          SMA SZA CLA       /DIGITS <= 4 ?
00507  5311          JMP ERROR         /NO; GO TO ERROR BRANCH
00510  5257          JMP GETDIG
00511  4566  ERROR,  JMS I  CRLF      /CRLF
00512  1322          TAD MQM           /GET ?
00513  7041          CIA
00514  4563          JMS I  TYPEIT     /PRINT THE ?
00515  5252          JMP NUMGET+1      /DISREGARD BAD ENTRY
00516  7300  CLEAR,  CLA CLL
00517  4331          JMS CONVRT        /CONVERT TO OCTAL
00520  5651          JMP I NUMGET
00521  0000  MDIGIT, 0
00522  7501  MQM,    -277
00523  0000  DIGITS, 0
00524  0567  DIGLOC, 567
00525  0000  TEMP,   0
00526  7521  MSLASH, -257
00527  7555  RETURN, -223
00530  7767  MNINE,  -11
       0010          DIGPTR=10

00531  0000  CONVRT, 0                 /CONVERT ASCII TO OCTAL
00532  7300          CLA CLL
00533  1323          TAD DIGITS        /SET DIGIT COUNTER
00534  7041          CIA
00535  3321          DCA MDIGIT
00536  1324          TAD DIGLOC        /SET POINTER
00537  3010          DCA DIGPTR
00540  3325          DCA TEMP          /ZERO TEMPORARY STORAGE
00541  1325  PACK,   TAD TEMP          /LOAD PARTIAL NUMBER
00542  7106          CLL RTL           /MULTIPLY BY 10
00543  1325          TAD TEMP
00544  7004          RAL
```

```
00545  3325           DCA TEMP
00546  1410           TAD I DIGPTR     /ADD NEXT STORED DIGIT
00547  1377           TAD (-260        /SUBTRACT 260
00550  1325           TAD TEMP         /ADD TO PARTIAL NUMBER
00551  3325           DCA TEMP         /STORE PARTIAL NUMBER
00552  2321           ISZ MDIGIT       /ALL DIGITS DONE ?
00553  5341           JMP PACK         /NO; GET ANOTHER
00554  1325           TAD TEMP         /YES; GET PACKED NUMBER
00555  5731           JMP I CONVRT

       0570   *570

00570  0000           0
00571  0000           0
00572  0000           0
00573  0000           0

00576  7774
00577  7520

       0600   * 600

00600  0000   SDPRNT, 0
00601  7300           CLA CLL
00602  1600           TAD I SDPRNT     /PICK UP ADDRESS OF
00603  3303           DCA SDGET        /HIGH ORDER WORD
00604  6211           CDF 10
00605  1703           TAD I SDGET      /GET HIGH ORDER WORD
00606  7700           SMA CLA          /IS IT NEGATIVE ?
00607  1272           TAD SDPLUS       /NO, GENERATE SPACE
00610  1273           TAD SDMNS        /YES, GENERATE MINUS
00611  1377           TAD (260
00612  4563           JMS I  TYPEIT    /TYPE IT OUT
00613  1703           TAD I SDGET      /GET HIGH ORDER WORD
00614  7510           SPA              /IS IT POSITIVE ?
00615  7060           CMA CML          /NO, COMPLEMENT IT
00616  3275           DCA SDHIGH       /STORE POSITIVE WORD
00617  2303           ISZ SDGET
00620  1703           TAD I SDGET      /PICK UP LOW ORDER WORD
00621  6201           CDF 00
00622  7430           SZL              /IS LINK SET ?
00623  7141           CMA CLL IAC      /YES, TWO'S COMPLEMENT
00624  7430           SZL              /DID AC OVERFLOW
00625  2275           ISZ SDHIGH       /YES, CORRECT HIGH WORD
00626  3276           DCA SDLOW        /STORE LOW ORDER WORD
00627  1270           TAD SDLOOP       /INITIALIZE COUNTER=7
00630  3274           DCA SDCNT
00631  1271           TAD SDADDR       /INITIALIZE POINTER TO
00632  3304           DCA SDPTR        /TABLE OF POWERS OF TEN
00633  2200           ISZ SDPRNT       /INDEX RETURN LINKAGE
```

```
00634  1704  SDARND,  TAD I SDPTR      /PICK UP POWER OF TEN
00635  2304           ISZ SDPTR       /FOR USE IN SUBSTRACT
00636  3277           DCA SDHSUB
00637  1704           TAD I SDPTR
00640  2304           ISZ SDPTR
00641  3300           DCA SDLSUB
00642  7100  SDDO,    CLL             /DOUBLE PRECISION
00643  1300           TAD SDLSUB      /SUBTRACTION
00644  1276           TAD SDLOW
00645  3302           DCA SDTEML
00646  7004           RAL
00647  1277           TAD SDHSUB
00650  1275           TAD SDHIGH
00651  7510           SPA             /DID IT UNDERFLOW ?
00652  5260           JMP SDOUT       /NO, COUNT IS DONE
00653  2301           ISZ SDBOX       /YES, COUNT NOT DONE
00654  3275           DCA SDHIGH      /DEPOSIT HIGH ORDER
00655  1302           TAD SDTEML      /PORTION RESTORE LOW
00656  3276           DCA SDLOW       /ORDER PORTION
00657  5242           JMP SDDO        /GO BACK AND SUBTRACT
00660  7200  SDOUT,   CLA
00661  1301           TAD SDBOX       /PICK UP DIGIT
00662  1377           TAD (260
00663  4563           JMS I  TYPEIT   /TYPE IT OUT
00664  3301           DCA SDBOX       /INITIALIZE DIGIT TO 0
00665  2274           ISZ SDCNT       /HAVE WE TYPED 7 DIGITS
00666  5234           JMP SDARND      /NO, DETERMINE NEXT
00667  5600           JMP I SDPRNT    /YES, END ROUTINE
00670  7771  SDLOOP,  -7              /COUNT OF 7 DIGITS
00671  0705  SDADDR,  SDCONL          /ADDRESS OF POWERS
00672  7763  SDPLUS,  -15             /'SPACE' GENERATOR
00673  7775  SDMNS,   -3              /'MINUS' GENERATOR
00674  0000  SDCNT,   0               /STORAGE LOCATIONS
00675  0000  SDHIGH,  0
00676  0000  SDLOW,   0
00677  0000  SDHSUB,  0
00700  0000  SDLSUB,  0
00701  0000  SDBOX,   0
00702  0000  SDTEML,  0
00703  0000  SDGET,   0
00704  0000  SDPTR,   0
00705  7413  SDCONL,  7413            /TABLE OF POWERS OF TEN
00706  6700           6700            /-1,000,000
00707  7747           7747            /-100,000
00710  4540           4540
00711  7775           7775            /-10,000
00712  4360           4360
00713  7777           7777            /-1,000
00714  6030           6030
00715  7777           7777            /-100
```

```
00716  7634           7634
00717  7777           7777            /-10
00720  7766           7766
00721  7777           7777            /-1
00722  7777           7777

00723  0000  SSPRNT,  0
00724  7100           CLL
00725  7510           SPA             /IS IT POSITIVE ?
00726  7061           CML CMA IAC     /NO, SET LINK
00727  3370           DCA SSVAL       /STORE NUMBER
00730  3366           DCA SSBOX       /SET LOCATION TO ZERO
00731  1365           TAD SSCNTR      /INITIALIZE COUNTER=4
00732  3367           DCA SSCNT
00733  1362           TAD SSADDR      /INITIALIZE INSTRUCTION
00734  3343           DCA SSXYZ+1     /TO GET FIRST 10
00735  1363           TAD SSPLUS      /GET CODE TO TYPE +
00736  7430           SZL             /IS NUMBER NEGATIVE ?
00737  1364           TAD SSMNS       /YES, CHANGE CODE TO -
00740  1377           TAD (260
00741  4563           JMS I  TYPEIT   /TYPE IT OUT
00742  1370  SSXYZ,   TAD SSVAL       /PICK UP NUMBER
00743  1371           TAD SSCON       /SUBSTRACT POWER OF TEN
00744  7510           SPA             /IS RESULT NEGATIVE ?
00745  5351           JMP .+4         /YES, INDEXING FINISHED
00746  2366           ISZ SSBOX       /NO, INDEX DIGIT LOCA.
00747  3370           DCA SSVAL       /STORE REMAINDER SSVAL
00750  5342           JMP SSXYZ       /CONTINUE SUBSTRACTING
00751  7200           CLA
00752  1366           TAD SSBOX       /GET THE DIGIT NUMBER
00753  1377           TAD (260
00754  4563           JMS I  TYPEIT   /TYPE IT OUT
00755  3366           DCA SSBOX       /DIGIT COUNTER=0
00756  2343           ISZ SSXYZ+1     /GET POWER OF TEN
00757  2367           ISZ SSCNT       /TYPED FOUR DIGITS
00760  5342           JMP SSXYZ       /NO, CONTINUE
00761  5723           JMP I SSPRNT    /YES, RETURN
00762  1371  SSADDR,  TAD SSCON       /TO GET FIRST POWER
00763  7760  SSPLUS,  -20             /'SPACE' GENERATOR
00764  0015  SSMNS,   15              /'MINUS' GENERATOR
00765  7774  SSCNTR,  -4              /COUNT OF 4 DIGITS
00766  0000  SSBOX,   0               /STORAGE REGISTERS
00767  0000  SSCNT,   0
00770  0000  SSVAL,   0
00771  6030  SSCON,   6030            /-1000
00772  7634           7634            /-100
00773  7766           7766            /-10
00774  7777           7777            /-1

00777  0260
```

```
        1000   * 1000

01000   0000   ENDFIL, 0                /PUNCH TRAILER
01001   7200           CLA
01002   3031           DCA PUN1
01003   1377           TAD (204
01004   4264           JMS TYPEIT
01005   1376           TAD (-36
01006   3021           DCA CNTR1
01007   1375           TAD (377
01010   4264           JMS TYPEIT
01011   2021           ISZ CNTR1
01012   5207           JMP .-3
01013   1374           TAD (-372
01014   3021           DCA CNTR1
01015   4264           JMS TYPEIT
01016   2021           ISZ CNTR1
01017   5215           JMP .-2
01020   5600           JMP I ENDFIL

01021   0000   DEL,    0                /DEL ROUTINE
01022   3021           DCA CNTR1
01023   7000           NOP
01024   2021           ISZ CNTR1
01025   5223           JMP .-2
01026   5621           JMP I DEL

01027   0000   LEADER, 0                /PUNCH LEADER
01030   1374           TAD (-372
01031   3021           DCA CNTR1
01032   4264           JMS TYPEIT
01033   2021           ISZ CNTR1
01034   5232           JMP .-2
01035   1376           TAD (-36
01036   3021           DCA CNTR1
01037   1375           TAD (377
01040   4264           JMS TYPEIT
01041   2021           ISZ CNTR1
01042   5237           JMP .-3
01043   5627           JMP I LEADER

01044   0000   SPACE,  0                /PUNCH TWO SPACES
01045   7200           CLA
01046   1373           TAD (240
01047   4264           JMS TYPEIT
01050   1373           TAD (240
01051   4264           JMS TYPEIT
01052   5644           JMP I SPACE
```

```
01053  0000  ENDREC, 0              /PUNCH END RECORD CHAR.
01054  7200         CLA
01055  1372         TAD (223
01056  4264         JMS TYPEIT
01057  1375         TAD (377
01060  4264         JMS TYPEIT
01061  1375         TAD (377
01062  4264         JMS TYPEIT
01063  5653         JMP I ENDREC

01064  0000  TYPEIT, 0              /TTY PRINT ROUTINE
01065  6041         TSF
01066  5265         JMP .-1
01067  6046         TLS
01070  7300         CLA CLL
01071  5664         JMP I TYPEIT

01072  0000  CRLF,   0              /CRLF ROUTINE
01073  7300         CLA CLL
01074  1371         TAD (215
01075  4264         JMS TYPEIT
01076  1370         TAD (212
01077  4264         JMS TYPEIT
01100  5672         JMP I CRLF

01101  0000  READ,   0              /KEYBOARD READ ROUTINE
01102  6031         KSF
01103  5302         JMP .-1
01104  7300         CLA CLL
01105  6036         KRB
01106  6046         TLS
01107  5701         JMP I READ

01170  0212
01171  0215
01172  0223
01173  0240
01174  7406
01175  0377
01176  7742
01177  0204

       1200  *1200

01200  0000  DST,    0              /DOUBLE PRECISION STORE
01201  3222         DCA ACC        /SAVE AC
01202  6214         RDF            /SAVE DATA FIELD
01203  1220         TAD KCDF
01204  3211         DCA CHG        /GENERATE CDF INSTRUCT.
01205  6201         CDF 00
```

```
01206  1600          TAD I DST       /GET STORAGE ADDRESS
01207  3221          DCA ARG
01210  2200          ISZ DST         /SET RETURN ADDRESS
01211  0000  CHG,    0               /CHANGE DATA FIELD BACK
01212  1222          TAD ACC         /RECOVER AC
01213  3621          DCA I ARG       /STORE HIGH ORDER WORD
01214  2221          ISZ ARG
01215  7701          ACL             /LOAD AC FROM MQ
01216  3621          DCA I ARG       /STORE LOW ORDER  WORD
01217  5600          JMP I DST
01220  6201  KCDF,   CDF
01221  0000  ARG,    0
01222  0000  ACC,    0

01223  0000  DCM,    0               /DOUBLE PRECISION
01224  7100          CLL             /COMPLEMENT
01225  7040          CMA             /SET AC TO 7777
01226  7521          SWP
01227  7041          CIA             /NEGATE MQ CONTENTS
01230  7521          SWP
01231  7430          SZL             /CHECK FOR OVERFLOW
01232  7001          IAC
01233  5623          JMP I DCM

01234  0000  DAD,    0               /DOUBLE PRECISION ADD
01235  3222          DCA ACC         /SAVE AC
01236  6214          RDF             /SAVE DATA FIELD
01237  1220          TAD KCDF
01240  3245          DCA CHANG
01241  6201          CDF 00
01242  1634          TAD I DAD       /GET ADDRESS OF
01243  3221          DCA ARG         /STORED VALUES
01244  2234          ISZ DAD         /SET RETURN ADDRESS
01245  0000  CHANG,   0               /CHANGE DATA FIELD BACK
01246  1621          TAD I ARG       /GET HIGH ORDER STORED
01247  3262          DCA HIGHT       /VALUE AND SAVE
01250  2221          ISZ ARG
01251  7100          CLL
01252  7521          SWP             /LOAD MQ INTO AC
01253  1621          TAD I ARG       /GET LOW ORDER  STORED
01254  7521          SWP             /LOW ORDER SUM IN MQ
01255  7430          SZL             /WAS THERE A CARRY ?
01256  7101          IAC CLL         /YES, INCREMENT AC
01257  1222          TAD ACC         /NO, ADD HIGH ORDER
01260  1262          TAD HIGHT
01261  5634          JMP I DAD       /RETURN
01262  0000  HIGHT,   0

01263  0000  SUMDAT,  0               /SUM DATA
01264  7200          CLA
```

```
01265  1023           TAD ISTORE      /FIND DATA
01266  3010           DCA 10
01267  3306           DCA MSHPNT      /SET MSH POINTER
01270  3310           DCA MSHPNT+2
01271  1026           TAD SUM2
01272  3021           DCA CNTR1       /DATA COUNTER
01273  7621  SUMLUP,  CAM
01274  1410           TAD I 10        /GET FIRST VALUE
01275  7500           SMA             /IS IT NEGATIVE ?
01276  5303           JMP ADD1        /NO, ADD IT
01277  7041           CIA             /YES, MAKE IT POSITIVE
01300  7521           SWP             /PUT IN MQ
01301  4223           JMS DCM         /MAKE IT NEGATIVE
01302  7410           SKP
01303  7521  ADD1,    SWP             /PUT IN MQ
01304  6211           CDF 10
01305  4234           JMS DAD         /DCUBLE PRECISION ADD
01306  0000  MSHPNT,  0
01307  4200           JMS DST         /DCUBLE PRECISION STORE
01310  0000  DUMMY,   0
01311  6201           CDF 00
01312  2306           ISZ MSHPNT      /SET NEW ADDRESS
01313  2306           ISZ MSHPNT
01314  2310           ISZ MSHPNT+2
01315  2310           ISZ MSHPNT+2
01316  2021           ISZ CNTR1       /ALL DATA SUMMED ?
01317  5273           JMP SUMLUP      /NO, NEXT VALUE
01320  7300           CLA CLL         /YES, DELAY
01321  1033           TAD LUMIN       /DELAY TEST
01322  7650           SNA CLA         /FAST OR SLOW ?
01323  5347           JMP STDEL       /FAST, DELAY
01324  1035           TAD RANGE       /SLOW, TEST
01325  7041           CIA
01326  7001           IAC
01327  7450           SNA             /10 MSEC RANGE ?
01330  5342           JMP TESTA       /YES, TEST TWO
01331  7001           IAC             /NO, 100 MSEC RANGE ?
01332  7640           SZA CLA
01333  5663           JMP I SUMDAT    /NO, FORGET DELAY
01334  1034           TAD DATPOT      /YES, TEST TWO
01335  7041           CIA
01336  0377           AND (7400
01337  7640           SZA CLA
01340  5663           JMP I SUMDAT
01341  5347           JMP STDEL
01342  1034  TESTA,   TAD DATPOT
01343  7041           CIA
01344  0376           AND (4000
01345  7640           SZA CLA
01346  5663           JMP I SUMDAT
```

```
01347   1375   STDEL,  TAD (-3720       /STANDARD DELAY
01350   3022           DCA CNTR2
01351   1375   DELMIN, TAD (-3720
01352   4565           JMS I  DEL       /5 USEC * AC DELAY
01353   2022           ISZ CNTR2
01354   5351           JMP DELMIN
01355   5663           JMP I SUMDAT     /END

01375   4060
01376   4000
01377   7400

        1400   *1400

01400   0000   DATOUT, 0                /PUNCH GENERAL DATA
01401   7200           CLA
01402   1031           TAD PUN1
01403   7650           SNA CLA
01404   4561           JMS I  LEADER    /PUNCH LEADER
01405   2031           ISZ PUN1
01406   4566           JMS I  CRLF
01407   4560           JMS I  ENDREC
01410   1377           TAD (-6
01411   3021           DCA CNTR1
01412   1376           TAD (PNTDAT
01413   3013           DCA 13
01414   1413           TAD I 13
01415   4563           JMS I  TYPEIT
01416   2021           ISZ CNTR1
01417   5214           JMP .-3
01420   4557           JMS I  SPACE
01421   1413           TAD I 13
01422   1413           TAD I 13
01423   7200           CLA
01424   1375           TAD (-4
01425   3021           DCA CNTR1
01426   1413           TAD I 13
01427   4563           JMS I  TYPEIT
01430   2021           ISZ CNTR1
01431   5226           JMP .-3
01432   4557           JMS I  SPACE
01433   1032           TAD RUNCNT
01434   4556           JMS I  SSPRNT
01435   4557           JMS I  SPACE
01436   1027           TAD NUMWAV
01437   7041           CIA
01440   4556           JMS I  SSPRNT
01441   4557           JMS I  SPACE
01442   1025           TAD PASSES
01443   7041           CIA
```

```
01444  4556           JMS I  SSPRNT
01445  4557           JMS I  SPACE
01446  1026           TAD SUM2
01447  7041           CIA
01450  4556           JMS I  SSPRNT
01451  4557           JMS I  SPACE
01452  1033           TAD LUMIN
01453  4556           JMS I  SSPRNT
01454  4557           JMS I  SPACE
01455  1033           TAD LUMIN
01456  7650           SNA CLA
01457  5267           JMP CONTIN
01460  1030           TAD DELTIM
01461  7041           CIA
01462  4556           JMS I  SSPRNT
01463  4557           JMS I  SPACE
01464  1035           TAD RANGE
01465  4556           JMS I  SSPRNT
01466  4557           JMS I  SPACE
01467  4566  CONTIN,  JMS I  CRLF
01470  4560           JMS I  ENDREC
01471  4555           JMS I  PUNCH
01472  4554           JMS I  PUNSQR
01473  5600           JMP I DATOUT     /END

01474  0000  PUNCH,   0                /SUMMED DATA OUTPUT
01475  7200           CLA
01476  3305           DCA ADR
01477  1026           TAD SUM2
01500  3021           DCA CNTR1
01501  1374  LOP,     TAD (-7
01502  3022           DCA CNTR2
01503  7200  INLOP,   CLA
01504  4553           JMS I  SDPRNT
01505  0000  ADR,     0
01506  4557           JMS I  SPACE
01507  2305           ISZ ADR
01510  2305           ISZ ADR
01511  2021           ISZ CNTR1
01512  5314           JMP .+2
01513  5321           JMP ENDTAP
01514  2022           ISZ CNTR2
01515  5303           JMP INLOP
01516  4566           JMS I  CRLF
01517  4560           JMS I  ENDREC
01520  5301           JMP LOP
01521  4566  ENDTAP,  JMS I  CRLF
01522  4560           JMS I  ENDREC
01523  1373           TAD (5777        /OVERLOAD OUTPUT
01524  3010           DCA 10
```

```
01525  3305           DCA ADR
01526  2305           ISZ ADR
01527  1026           TAD SUM2
01530  3021           DCA CNTR1
01531  1372           TAD (-5
01532  3022           DCA CNTR2
01533  7200  LOPIN,    CLA
01534  1410           TAD I 10
01535  7450           SNA
01536  5352           JMP POL
01537  4556           JMS I  SSPRNT
01540  4557           JMS I  SPACE
01541  1305           TAD ADR
01542  4556           JMS I  SSPRNT
01543  4557           JMS I  SPACE
01544  2022           ISZ CNTR2
01545  5352           JMP POL
01546  4566           JMS I  CRLF
01547  4560           JMS I  ENDREC
01550  1372           TAD (-5
01551  3022           DCA CNTR2
01552  2305  POL,     ISZ ADR
01553  2021           ISZ CNTR1
01554  5333           JMP LOPIN
01555  7200           CLA
01556  4556           JMS I  SSPRNT
01557  4557           JMS I  SPACE
01560  4556           JMS I  SSPRNT
01561  4557           JMS I  SPACE
01562  4566           JMS I  CRLF
01563  4560           JMS I  ENDREC
01564  5674           JMP I PUNCH

01572  7773
01573  5777
01574  7771
01575  7774
01576  1711
01577  7772

       1600  *1600

01600  0000  RESET1,  0              /RESET FOR RUN
01601  2032           ISZ RUNCNT     /SET RUN COUNTER
01602  7200           CLA
01603  1377           TAD (MSG03-1   /REPEAT RUN
01604  3017           DCA 17
01605  4571           JMS I  MESAGE
01606  4570           JMS I  NUMGET  /GET ANSWER
01607  7650           SNA CLA        /REPEAT ?
```

```
01610  4552          JMS I  MESSY     /NO, PRINT MESSAGES
01611  1025          TAD PASSES      /YES, RESET VARIABLES
01612  3024          DCA P
01613  3021          DCA CNTR1       /ZERO FIELD 1
01614  6211          CDF 10
01615  3421  ZLOOP,  DCA I CNTR1
01616  2021          ISZ CNTR1
01617  5215          JMP ZLOOP
01620  6201          CDF 00
01621  1376          TAD (3777       /ZERO OVERLOAD
01622  3010          DCA 10
01623  1375          TAD (-3000
01624  3021          DCA CNTR1
01625  3410          DCA I 10
01626  2021          ISZ CNTR1
01627  5225          JMP .-2
01630  5600          JMP I RESET1

01631  0000  PREP,   0               /ROTOR ON & ENABLE
01632  6341          ROTRON          /TURN ROTOR ON
01633  7200          CLA
01634  1374          TAD (-764       /DELAY 5 SEC
01635  3022          DCA CNTR2
01636  1373  RLOOP,  TAD (-3720
01637  4565          JMS I  DEL      /5 USECD * AC DELAY
01640  2022          ISZ CNTR2
01641  5236          JMP RLOOP
01642  6343          XABLE           /ENABLE X-RAYS
01643  1372          TAD (-6         /DELAY 60 MSEC
01644  3022          DCA CNTR2
01645  1373  XLOOP,  TAD (-3720
01646  4565          JMS I  DEL      /5 USEC * AC DELAY
01647  2022          ISZ CNTR2
01650  5245          JMP XLOOP
01651  6455          INATOD          /INITIALIZE A TO D
01652  6346          INBOX           /INITIALIZE INTEGRATOR
01653  5631          JMP I PREP      /END

01654  0000  DATTIM,  0               /DATE & TIME ROUTINE
01655  1371          TAD (MSG01-1
01656  3017          DCA 17
01657  4571          JMS I  MESAGE   /PRINT MESSAGE
01660  7200          CLA
01661  1372          TAD (-6
01662  3021          DCA CNTR1       /SET DIGIT COUNTER
01663  1310          TAD DATPNT      /GET STORAGE LOCATION
01664  3311          DCA PNTDAT
01665  4562  DNEXT,  JMS I  READ     /GET DIGIT
01666  3711          DCA I PNTDAT    /STORE DIGIT
01667  2311          ISZ PNTDAT      /RESET STORAGE LOCATION
```

```
01670  2021           ISZ CNTR1        /MORE DIGITS ?
01671  5265           JMP DNEXT        /YES, GET DIGIT
01672  1370           TAD (MSG02-1     /NO, GET TIME
01673  3017           DCA 17
01674  4571           JMS I  MESAGE    /PRINT MESSAGE
01675  7200           CLA
01676  1367           TAD (-4
01677  3021           DCA CNTR1        /SET DIGIT COUNTER
01700  1320           TAD TIMPNT       /GET STORAGE LOCATION
01701  3321           DCA PNTTIM
01702  4562  TNEXT,   JMS I  READ      /GET DIGIT
01703  3721           DCA I PNTTIM     /STORE DIGIT
01704  2321           ISZ PNTTIM       /RESET
01705  2021           ISZ CNTR1        /MORE DIGITS ?
01706  5302           JMP TNEXT        /YES, GET DIGIT
01707  5654           JMP I DATTIM     /NO, END ROUTINE
01710  1712  DATPNT,  DATPNT+2
01711  0000  PNTDAT,  0
01712  0000           0                /STORAGE OF DATE
01713  0000           0
01714  0000           0
01715  0000           0
01716  0000           0
01717  0000           0
01720  1722  TIMPNT,  TIMPNT+2
01721  0000  PNTTIM,  0
01722  0000           0                /STORAGE OF TIME
01723  0000           0
01724  0000           0
01725  0000           0

01767  7774
01770  3006
01771  2777
01772  7772
01773  4060
01774  7014
01775  5000
01776  3777
01777  3020

       2000  *2000

02000  0000  MESSY,   0                /INFORMATION INPUT
02001  1377           TAD (MSG04-1     /GET # OF WAVES
02002  3017           DCA 17
02003  4571           JMS I  MESAGE
02004  4570           JMS I  NUMGET    /GET ANSWER
02005  7041           CIA
02006  3027           DCA NUMWAV
```

```
02007  1376           TAD (MSG05-1    /# OF PASSES
02010  3017           DCA 17
02011  4571           JMS I  MESAGE
02012  4570           JMS I  NUMGET   /GET ANSWER
02013  7041           CIA
02014  3025           DCA PASSES
02015  1375           TAD (MSG06-1    /FAST OR SLOW ?
02016  3017           DCA 17
02017  4571           JMS I  MESAGE
02020  4570           JMS I  NUMGET   /GET ANSWER
02021  3033           DCA LUMIN
02022  1033           TAD LUMIN
02023  7650           SNA CLA
02024  5600           JMP I MESSY
02025  1374           TAD (MSG07-1    /TRANSIENT DECAY
02026  3017           DCA 17
02027  4571           JMS I  MESAGE
02030  4570           JMS I  NUMGET   /GET ANSWER
02031  7041           CIA
02032  3030           DCA DELTIM
02033  1373           TAD (MSG08-1    /# DATA POINTS
02034  3017           DCA 17
02035  4571           JMS I  MESAGE
02036  4570           JMS I  NUMGET   /GET ANSWER
02037  7041           CIA
02040  3034           DCA DATPOT
02041  1372           TAD (MSG09-1    /RANGE CODE
02042  3017           DCA 17
02043  4571           JMS I  MESAGE
02044  4570           JMS I  NUMGET   /GET ANSWER
02045  3035           DCA RANGE
02046  1035           TAD RANGE
02047  1255           TAD PTR
02050  3254           DCA TEMPER
02051  1654           TAD I TEMPER
02052  3040           DCA DELRAN
02053  5600           JMP I MESSY
02054  0000  TEMPER,  0
02055  2055  PTR,     PTR
02056  2217           DEL1
02057  2223           DEL2
02060  2233           DEL3

02172  3162
02173  3152
02174  3116
02175  3070
02176  3056
02177  3041
```

```
        2200    *2200

02200   0000    DATA,   0               /DATA ROUTINE
02201   6455            STATOD          /START A TO D
02202   7346            CLA CLL CMA RTL
02203   4565            JMS I  DEL      /5 USEC * AC DELAY
02204   6354            GETDAT          /GET DATA POINT
02205   6346            INBOX           /INITIAL INTEGRATOR
02206   3410            DCA I 10        /STORE DATA
02207   2037            ISZ SUM         /MORE DATA ?
02210   5212            JMP .+2         /YES, GET IT
02211   5600            JMP I DATA      /NO, STOP
02212   1377            TAD (-276
02213   4565            JMS I  DEL      /5 USEC * AC DELAY
02214   6345            STBOX           /START INTEGRATOR
02215   4440            JMS I DELRAN    /DELAY RANGE VALUE
02216   5201            JMP DATA+1

02217   0000    DEL1,   0               /10 MSEC DELAY
02220   1376            TAD (-3405
02221   4565            JMS I  DEL
02222   5617            JMP I DEL1

02223   0000    DEL2,   0               /100 MSEC DELAY
02224   1375            TAD (-5
02225   3022            DCA CNTR2
02226   1374            TAD (213
02227   4565            JMS I  DEL
02230   2022            ISZ CNTR2
02231   5226            JMP .-3
02232   5623            JMP I DEL2

02233   0000    DEL3,   0               /1 SEC DELAY
02234   1373            TAD (-62
02235   3022            DCA CNTR2
02236   1372            TAD (147
02237   4565            JMS I  DEL
02240   7000            NOP
02241   2022            ISZ CNTR2
02242   5236            JMP .-4
02243   5633            JMP I DEL3

02244   0000    UDPRNT, 0
02245   7300            CLA CLL
02246   1644            TAD I UDPRNT    /PICK UP ADDRESS OF
02247   3331            DCA UDGET       /HIGH ORDER WORD
02250   6211            CDF 10
02251   1731            TAD I UDGET     /PICK UP BOTH WORDS FOR
02252   3323            DCA UDHIGH      /USE IN SUBROUTINE
02253   2331            ISZ UDGET
```

```
02254  1731           TAD I UDGET
02255  3324           DCA UDLOW
02256  6201           CDF 00
02257  1320           TAD UDLOOP       /INITIALIZE COUNTER
02260  3322           DCA UDCNT
02261  1321           TAD UDADDR       /INITIALIZE TO TABLE OF
02262  3332           DCA UDPTR        /POWERS OF TEN
02263  2244           ISZ UDPRNT       /SET RETURN ADDRESS
02264  1732  UDARND,  TAD I UDPTR      /PICK UP FIRST POWER
02265  2332           ISZ UDPTR        /FOR USE IN SUBTRACTION
02266  3325           DCA UDHSUB
02267  1732           TAD I UDPTR
02270  2332           ISZ UDPTR
02271  3326           DCA UDLSUB
02272  7100  UDDO,    CLL              /DOUBLE PRECISION SUB
02273  1326           TAD UDLSUB
02274  1324           TAD UDLOW
02275  3330           DCA UDTEML
02276  7004           RAL
02277  1325           TAD UDHSUB
02300  1323           TAD UDHIGH
02301  7420           SNL              /DID IT OVERFLOW ?
02302  5310           JMP UDOUT        /NO, COUNT IS DONE
02303  2327           ISZ UDBOX        /YES, CONTINUE
02304  3323           DCA UDHIGH       /SAVE REMAINDER
02305  1330           TAD UDTEML
02306  3324           DCA UDLOW
02307  5272           JMP UDDO
02310  7200  UDOUT,   CLA
02311  1327           TAD UDBOX        /GET DIGIT
02312  1371           TAD (260
02313  4563           JMS I  TYPEIT    /TYPE IT
02314  3327           DCA UDBOX
02315  2322           ISZ UDCNT        /MORE DIGITS ?
02316  5264           JMP UDARND       /YES, GET NEXT
02317  5644           JMP I UDPRNT     /NO, DONE
02320  7770  UDLOOP,  -10
02321  2333  UDADDR,  UDCONL
02322  0000  UDCNT,   0
02323  0000  UDHIGH,  0
02324  0000  UDLOW,   0
02325  0000  UDHSUB,  0
02326  0000  UDLSUB,  0
02327  0000  UDBOX,   0
02330  0000  UDTEML,  0
02331  0000  UDGET,   0
02332  0000  UDPTR,   0
02333  3166  UDCONL,  3166           /POWERS OF TEN
02334  4600           4600           /-10,000,000
02335  7413           7413           /-1,000,000
```

```
02336  6700           6700
02337  7747           7747            /-100,000
02340  4540           4540
02341  7775           7775            /-10,000
02342  4360           4360
02343  7777           7777            /-1000
02344  6030           6030
02345  7777           7777            /-100
02346  7634           7634
02347  7777           7777            /-10
02350  7766           7766
02351  7777           7777            /-1
02352  7777           7777

02371  0260
02372  0147
02373  7716
02374  0213
02375  7773
02376  4373
02377  7502

       2400   *2400

02400  0000   SQR,    0               /SQUARE ROUTINE
02401  1600           TAD I SQR       /GET DATA ADDRESS
02402  3273           DCA ARGU
02403  2200           ISZ SQR         /SET RETURN ADDRESS
02404  1673           TAD I ARGU      /GET DATA POINT
02405  7041           CIA             /MAKE IT POSITIVE
02406  3274           DCA STORE       /STORE TEMPORAILY
02407  1274           TAD STORE
02410  3275           DCA TEST        /SET TEST VALUE
02411  7001           IAC
02412  3276           DCA MASK        /SET MASK TO ONE
02413  1377           TAD (-14        /SET BIT COUNTER
02414  3044           DCA CNT2
02415  3045           DCA HIGH
02416  3046           DCA LOW
02417  1275   TESTBT, TAD TEST
02420  0276           AND MASK        /CHECK FOR BIT TRUE
02421  7740           SZA CLA CLL     /TRUE ?
02422  5235           JMP ADD         /YES, ADD PARTIAL PROD.
02423  1276   RETUR,  TAD MASK        /RESET MASK
02424  7104           RAL CLL
02425  3276           DCA MASK
02426  2044           ISZ CNT2        /MORE BITS ?
02427  5217           JMP TESTBT      /YES, TEST NEXT
02430  1046           TAD LOW         /NO, LOAD RESULT IN
02431  7521           SWP             /MQ AND AC
```

```
02432  7200           CLA
02433  1045           TAD HIGH
02434  5600           JMP I SQR          /END
02435  1044  ADD,     TAD CNT2           /DETERMINE WHICH BIT
02436  1376           TAD (14            /WAS BEING TESTED
02437  7140           CMA CLL
02440  3043           DCA CNT1
02441  1274           TAD STORE
02442  3041           DCA TEMPST
02443  3042           DCA TEMPST+1
02444  2043  REDO,    ISZ CNT1           /SET VALUE OF
02445  5247           JMP .+2            /PARTIAL PRODUCT
02446  5262           JMP DADSTP         /ADD PARTIAL PRODUCT
02447  1042           TAD TEMPST+1
02450  7004           RAL
02451  3042           DCA TEMPST+1
02452  1041           TAD TEMPST
02453  7004           RAL
02454  3041           DCA TEMPST
02455  7420           SNL                /CHECK FOR OVERFLOW
02456  5244           JMP REDO           /NO, CONTINUE
02457  2042           ISZ TEMPST+1       /YES, INCREMENT MSD
02460  7100           CLL
02461  5244           JMP REDO
02462  1041  DADSTP,  TAD TEMPST         /DOUBLE PRECISION ADD
02463  7521           SWP
02464  7200           CLA
02465  1042           TAD TEMPST+1
02466  4551           JMS I  DAD         /ADD ROUTINE
02467  0045           HIGH
02470  4550           JMS I  DST         /STORE ROUTINE
02471  0045           HIGH
02472  5223           JMP RETUR
02473  0000  ARGU,    0
02474  0000  STORE,   0
02475  0000  TEST,    0
02476  0000  MASK,    0

02477  0000  SUMSQR,  0                  /SUM OF SQUARES
02500  7300           CLA CLL
02501  1375           TAD (4000          /STORAGE ADDRESS
02502  3317           DCA MSHSQR
02503  1375           TAD (4000
02504  3321           DCA MSHSQR+2
02505  1375           TAD (4000          /RESET DATA LOCATOR
02506  3314           DCA DATLOC
02507  1026           TAD SUM2           /GET # DATA POINTS
02510  3021           DCA CNTR1
02511  1374           TAD (6000          /OVERFLOW COUNTERS
02512  3022           DCA CNTR2
```

```
02513  4200  SQRSUM, JMS SQR          /SQUARE VALUE
02514  4000  DATLOC, 4000
02515  6211          CDF 10
02516  4551          JMS I  DAD       /DOUBLE PRECISION ADD
02517  0000  MSHSQR, 0
02520  4550          JMS I  DST       /DOUBLE PRECISION STORE
02521  0000  DUMB,   0
02522  6201          CDF 00
02523  7430          SZL              /TEST, OVERFLOW
02524  2422          ISZ I CNTR2      /YES, INCREMENT COUNTER
02525  7100          CLL
02526  2022          ISZ CNTR2        /RESET ADDRESS
02527  2314          ISZ DATLOC
02530  2317          ISZ MSHSQR
02531  2317          ISZ MSHSQR
02532  2321          ISZ MSHSQR+2
02533  2321          ISZ MSHSQR+2
02534  2021          ISZ CNTR1        /MORE DATA ?
02535  5313          JMP SQRSUM       /YES, SQUARE & ADD
02536  5677          JMP I SUMSQR     /NO, RETURN

02537  0000  PUNSQR, 0                /SUMMED SQUARES OUTPUT
02540  7200          CLA
02541  1375          TAD (4000
02542  3351          DCA ADRSQR
02543  1026          TAD SUM2
02544  3021          DCA CNTR1
02545  1373  LOPSQR, TAD (-7
02546  3022          DCA CNTR2
02547  7200  INSQR,  CLA
02550  4547          JMS I  UDPRNT
02551  0000  ADRSQR, 0
02552  4557          JMS I  SPACE
02553  2351          ISZ ADRSQR
02554  2351          ISZ ADRSQR
02555  2021          ISZ CNTR1
02556  5360          JMP .+2
02557  5365          JMP ENDSQR
02560  2022          ISZ CNTR2
02561  5347          JMP INSQR
02562  4566          JMS I  CRLF
02563  4560          JMS I  ENDREC
02564  5345          JMP LOPSQR
02565  4566  ENDSQR, JMS I  CRLF
02566  4560          JMS I  ENDREC
02567  5737          JMP I PUNSQR

02573  7771
02574  6000
02575  4000
```

```
02576  0014
02577  7764

       3000  *3000

03000  4424  MSG01,  TEXT /$TODAYS DATE /
03001  1704
03002  0131
03003  2340
03004  0401
03005  2405
03006  4000
03007  4040  MSG02,  TEXT /  TIME (MILITARY) /
03010  2411
03011  1505
03012  4050
03013  1511
03014  1411
03015  2401
03016  2231
03017  5140
03020  0000
03021  4422  MSG03,  TEXT /$REPEAT PREVIOUS RUN 1-YES,
03022  0520               0-NO /
03023  0501
03024  2440
03025  2022
03026  0526
03027  1117
03030  2523
03031  4022
03032  2516
03033  4061
03034  5531
03035  0523
03036  5440
03037  6055
03040  1617
03041  4000
03042  4416  MSG04,  TEXT /$NUMBER OF WAVES IN BOMB /
03043  2515
03044  0205
03045  2240
03046  1706
03047  4027
03050  0126
03051  0523
03052  4011
03053  1640
03054  0217
```

```
03055   1502
03056   4000
03057   4040   MSG05,  TEXT /  NUMBER OF PASSES /
03060   1625
03061   1502
03062   0522
03063   4017
03064   0640
03065   2001
03066   2323
03067   0523
03070   4000
03071   4406   MSG06,  TEXT /$FAST OR SLOW LUMINESCENCE
03072   0123                0-FAST, 1-SLOW /
03073   2440
03074   1722
03075   4023
03076   1417
03077   2740
03100   1425
03101   1511
03102   1605
03103   2303
03104   0516
03105   0305
03106   4060
03107   5506
03110   0123
03111   2454
03112   4061
03113   5523
03114   1417
03115   2740
03116   0000
03117   4424   MSG07,  TEXT /$TRANSIENT DECAY 5.0 USEC-CNT
03120   2201                INITIAL OFFSET 12.6 USEC /
03121   1623
03122   1105
03123   1624
03124   4004
03125   0503
03126   0131
03127   4065
03130   5660
03131   4025
03132   2305
03133   0355
03134   0316
03135   2440
03136   1116
```

```
03137  1124
03140  1101
03141  1440
03142  1706
03143  0623
03144  0524
03145  4061
03146  6256
03147  6640
03150  2523
03151  0503
03152  4000
03153  4443   MSG08,  TEXT /$# DATA POINTS /
03154  4004
03155  0124
03156  0140
03157  2017
03160  1116
03161  2423
03162  4000
03163  4040   MSG09,  TEXT /  RANGE CODE 1-10, 2-100, 3-1000
03164  2201                MSEC /
03165  1607
03166  0540
03167  0317
03170  0405
03171  4061
03172  5561
03173  6054
03174  4062
03175  5561
03176  6060
03177  5440
03200  6355
03201  6160
03202  6060
03203  4015
03204  2305
03205  0340
03206  0000
03207  4403   MSG15,  TEXT /$CONTINUE RUNS 1-YES, 0-NO /
03210  1716
03211  2411
03212  1625
03213  0540
03214  2225
03215  1623
03216  4061
03217  5531
03220  0523
```

```
03221  5440
03222  6055
03223  1617
03224  4000

       6345          STBOX=6345
       6455          STATOD=6455
       6354          GETDAT=6354
       6346          INBOX=6346
       6455          INATOD=6455
       6344          XDABLE=6344
       6342          ROTROF=6342
       6337          CSTART=6337
       6331          CREADY=6331
       6332          NOW=6332
       6333          XON=6333
       6334          XOFF=6334
       6336          CWAIT=6336
       6343          XABLE=6343
       6341          ROTRON=6341
       7701          ACL=7701
       7621          CAM=7621

             $

00147  2244
00150  1200
00151  1234
00152  2000
00153  0600
00154  2537
00155  1474
00156  0723
00157  1044
00160  1053
00161  1027
00162  1101
00163  1064
00164  2200
00165  1021
00166  1072
00167  1000
00170  0451
00171  0400
00172  1400
00173  2477
00174  1263
00175  1631
00176  1600
00177  1654
```

ACC	1222	GETDAT	6354	PREP	1631	SUM	0037
ACL	7701	GETDIG	0457	PTR	2055	SUMDAT	1263
ALD	2435	HIGH	0045	PUNCH	1474	SUMLUP	1273
ALD1	1303	HIGHT	1262	PUNSQR	2537	SUMSQR	2477
ALR	1505	INATOD	6455	PUN1	0031	SUM2	0026
ALRSQR	2551	INBOX	6346	RANGE	0035	TEMP	0525
ARG	1221	INLOP	1503	READ	1101	TEMPER	2054
ARGU	2473	INSQR	2547	REDO	2444	TEMPST	0041
BCMB	0254	ISTORE	0023	RESET	0203	TEST	2475
BCMB2	0304	KCDF	1220	RESET1	1600	TESTA	1342
BYTCNT	0440	LEADER	1027	RETUR	2423	TESTBT	2417
CAM	7621	LIT1	0441	RETURN	0527	TIMPNT	1720
CHANG	1245	LIT2	0442	RLOOP	1636	TNEXT	1702
CHG	1211	LIT3	0443	ROTROF	6342	TYPEIT	1064
CLEAR	0516	LIT4	0444	ROTRON	6341	UDADDR	2321
CNTR1	0021	LIT5	0445	RUNCNT	0032	UDARND	2264
CNTR2	0022	LOP	1501	SDADDR	0671	UDBOX	2327
CNT1	0043	LOPIN	1533	SDARND	0634	UDCNT	2322
CNT2	0044	LOPSQR	2545	SDBOX	0701	UDCONL	2333
CONTIN	1467	LOW	0046	SDCNT	0674	UDDO	2272
CONVRT	0531	LUMIN	0033	SDCONL	0705	UDGET	2331
CREADY	6331	MASK	2476	SDDO	0642	UDHIGH	2323
CRLF	1072	MDIGIT	0521	SDGET	0703	UDHSUB	2325
CSTART	6337	MDOLAR	0450	SDHIGH	0675	UDLOOP	2320
CWAIT	6336	MESAGE	0400	SDHSUB	0677	UDLOW	2324
DAD	1234	MESSY	2000	SDLOOP	0670	UDLSUB	2326
DADSTP	2462	MNINE	0530	SDLOW	0676	UDOUT	2310
DATA	2200	MQM	0522	SDLSUB	0700	UDPRNT	2244
DATLOC	2514	MSG01	3000	SDMNS	0673	UDPTR	2332
DATOUT	1400	MSG02	3007	SDOUT	0660	UDTEML	2330
DATPNT	1710	MSG03	3021	SDPLUS	0672	XABLE	6343
DATPOT	0034	MSG04	3042	SDPRNT	0600	XDABLE	6344
DATTIM	1654	MSG05	3057	SDPTR	0704	XLOOP	1645
DCM	1223	MSG06	3071	SDTEML	0702	XOFF	6334
DEL	1021	MSG07	3117	SET1	0231	XON	6333
DELMIN	1351	MSG08	3153	SPACE	1044	ZLOOP	1615
DELRAN	0040	MSG09	3163	SQR	2400		
DELTIM	0030	MSG15	3207	SQRSUM	2513		
DEL1	2217	MSHPNT	1306	SSADDR	0762		
DEL2	2223	MSHSQR	2517	SSBOX	0766		
DEL3	2233	MSLASH	0526	SSCNT	0767		
DIGITS	0523	MULT	0313	SSCNTR	0765		
DIGLOC	0524	MULTI	0263	SSCON	0771		
DIGPTR	0010	N	0036	SSMNS	0764		
DNEXT	1665	NOW	6332	SSPLUS	0763		
DST	1200	NUMGET	0451	SSPRNT	0723		
DUMB	2521	NUMWAV	0027	SSVAL	0770		
DUMMY	1310	P	0024	SSXYZ	0742		
ENDFIL	1000	PACK	0541	START	0200		
ENDREC	1053	PASS	0204	STATOD	6455		

```
ENDSQR 2565      PASSES 0025      STBOX  6345
ENDTAP 1521      PNTDAT 1711      STDEL  1347
ENT10  0401      PNTTIM 1721      STORE  2474
ENT11  0410      POINTS 0251      STOR1  0446
ERROR  0511      POL    1552      STOR2  0447

ERRORS DETECTED: 0
LINKS GENERATED: 0
```

APPENDIX 5: JCL

JCL is the acronym for job control language. The listing which follows contains all the JCL statements required to run the job which calculates the experimental results. The sections where data and program source decks belong are indicated in the listing. The WYLBUR execute file, EXECTRS3 (see Appendix 6), moves the the proper data sets to the indicated positions when the job is created. The statements in the listing are applicable only to the Iowa State University Computation Center and are subject to change as system changes are implemented.

```
   1 //A411GJO JOB A0099,GJO,TIME=(1,59)
   2 /*JOBPARM  LINES=10
   3 //S1 EXEC PGM=IEBGENER
   4 //SYSPRINT DD SYSOUT=A
   5 //SYSIN DD DUMMY
   6 //SYSUT2 DD DSN=&CARDS1,UNIT=DISK,DISP=(NEW,PASS),
   7 // SPACE=(3520,(5,5),RLSE),DCB=(RECFM=FB,LRECL=80,
   8 // BLKSIZE=3520)
   9 //SYSUT1 DD *
     Control Variables
 180 /*
 801 //S2 EXEC PL1LFCLG,PARM.PL1L='A,X,NEST',REGION.GO=160K
 802 //PL1L.SYSIN DD *
     TRS3 Source Deck
 803 /*
 804 //GO.SYSIN DD DSN=CPS07.A0986.GJO1,DISP=SHR
 805 //IN       DD DSN=&CARDS1,DISP=(OLD,DELETE)
 807 //OUT      DD DSN=CPS07.A0986.GJO2,UNIT=DISK,
 808 // VOL=SER=RJEPAK,DISP=(NEW,KEEP,DELETE),SPACE=(3520,
 809 // (5,5)),DCB=(RECFM=FB,LRECL=80,BLKSIZE=3520)
 810 //GO.FT14F001 DD DSN=&SM,UNIT=SCRTCH,DISP=(NEW,PASS),
 811 // SPACE=(800,(120,15)),DCB=(RECFM=VS,LRECL=796,
 812 // BLKSIZE=800)
 813 //SIMPLTTR EXEC PLOT,PLOTTER=INCRMNTL,FORM=W
 814 //S3 EXEC FORTG,REGION.GO=160K,TIME.GO=(2,00)
 815 //FORT.SYSLIN DD DISP=(OLD,PASS)
 816 //FORT.SYSIN DD *
     SMASH Source Deck
 817 //LKED.SYSLMOD DD DSN=&GOSET2(GO)
 818 //GO.FT05F001 DD DSN=CPS07.A0986.GJO2,DISP=SHR,
 819 // VOL=SER=RJEPAK,UNIT=2314
 820 //GO.FT06F001 DD SYSOUT=A
 821 //GO.FT14F001 DD DSN=&SM2,UNIT=SCRTCH,DISP=(NEW,PASS),
 822 // SPACE=(800,(120,15)),DCB=(RECFM=VS,LRECL=796,
 823 // BLKSIZE=800)
 824 //SIMPLTTR EXEC PLOT,PLOTTER=INCRMNTL,FORM=W
 825 //PLOT.FT14F001 DD DSN=&SM2
 998 /*
 999 //
1000
```

APPENDIX 6: EXECTRS3

EXECTRS3 is a WYLBUR execute file which creates the job which calculates the experimental results. The execute file starts with the JCL statements (Appendix 5), copies TRS3 (Appendix 1) and SMASH (Appendix 2) to the appropriate lines and interrogates the operator for input information. After the job is created the execute file submits the job to the computer system for execution and erases the original input data set in preparation for the next use of the execute file. The WYLBUR statements which make up the execute file are listed on the following pages.

```
 10 SET EXEC NOL TER
 20 SET ESC :
 40 SET VOL CAT
 50 USE #JCL CLR
 60 COPY ALL FROM #TRS3 TO 802.001
 70 SCR $CPS07.A0986.GJO2 ON RJEPAK
 80 COMM HOW MANY RUNS?
 90 INS 11 UNN
100 REA VAL N0 USING 11
110 COPY 1000 TO 12
120 SET VAL W0=12
130 SET VAL W1=13
140 SET VAL N1=0
150 SET VAL N1=N1+1
160 REA STR S0 PRO 'IS RUN :N1 FAST OR SLOW?  '
170 SET VAL N9=2*:N1
180 IF (S0 EQ 'FAST') EXEC 400
190 REA STR S0 PRO 'WILL SMASH BE RUN?  '
200 IF (S0 EQ 'NO') CH :N9/:N9 TO 0 IN :W0 N
210 COPY 1000 TO :W1
220 REA STR S1 PRO 'GRAPH LABEL RUN :N1?  '
230 CH 1/20 TO ':S1' IN :W1 N
240 REA STR S1 PRO 'DATA LABEL RUN :N1?  '
250 CH 21/40 TO ':S1' IN :W1 N
260 SET VAL W1=W1+1
270 IF (S0 EQ 'YES') EXEC 450 SAVE
280 IF (N1 LT N0) EXEC 150
290 COMM TO RUN JOB TYPE EXEC NEXT
300 EXEC PAUSE
310 IF (N2 NE 1) DEL 813/822
320 IF (N2 EQ 1) COPY ALL FROM #SMASH TO 816.001
350 RUN 1/999 UNN
351 SCR $CPS07.A0986.GJO3
360 EXEC PAUSE
400 CH :N9/:N9 TO 0 IN :W0 N
410 EXEC 280
450 REA VAL N8 PRO '#SMASHES RUN :N1?  '
460 COPY 1000 TO :W1
470 CH 1 TO :N8 IN :W1 N
480 SET VAL W1=W1+1
490 SET VAL N2=1
500 CH :N9/:N9 TO 1 IN :W0 N
510 SET VAL N3=0
520 SET VAL  N3=N3+1
530 IF (N3 GT N8) EXEC RETURN
540 COPY 1000 TO :W1
550 IF (N3 EQ 1) CH 10/10 TO 0 IN :W1 N
560 IF (N3 NE 1) CH 9/10 TO -1 IN :W1 N
570 REA STR S1 PRO 'HOW MANY COMPONENTS SMASH :N3?  '
580 CH 5/5 TO ':S1' IN :W1 N
```

```
590 REA STR S1 PRO 'GRAPHS SMASH :N3?  '
600 IF (S1 EQ 'YES') EXEC 630
610 CH 15/15 TO 0 IN :W1 N
620 EXEC 660
630 REA STR S1 PRO 'LIN=LINEAR, LOG=SEMILOG  '
640 IF (S1 EQ 'LIN') CH 15/15 TO 1 IN :W1 N
650 IF (S1 EQ 'LOG') CH 14/15 TO -1 IN :W1 N
660 SET VAL W2=W1
670 SET VAL W1=W1+1
680 REA STR S1 PRO 'PRINTED OUTPUT HEADING?  '
690 COPY 1000 TO :W1
700 CH 1/80 TO ':S1' IN :W1 N
710 SET VAL W1=W1+1
720 REA VAL W9 USING :W2 COLS 15/15
730 IF (W9 EQ 0) EXEC 840
740 COPY 1000 TO :W1
750 REA STR S1 PRO 'X-AXIS LABEL?  '
760 CH 1/20 TO ':S1' IN :W1 N
770 REA STR S1 PRO 'Y-AXIS LABEL?  '
780 CH 21/40 TO ':S1' IN :W1 N
790 REA STR S1 PRO 'GRAPH LABEL?  '
800 CH 41/60 TO ':S1' IN :W1 N
810 REA STR S1 PRO 'DATA LABEL?  '
820 CH 61/80 TO ':S1' IN :W1 N
830 SET VAL W1=W1+1
840 COPY 1000 TO :W1
850 SET VAL N4=0
860 REA VAL N5 USING :W2 COL 5/5
870 SET VAL N4= N4+1
880 SET VAL N6=N4*10-9
890 SET VAL N7=N4*10
900 REA STR S1 PRO 'DECAY CONSTANT FOR COMPONENT :N4  '
910 CH :N6/:N7 TO ':S1' IN :W1 N
920 IF (N4 LT N5) EXEC 870
930 SET VAL W1=W1+1
940 EXEC 520
```